

LOC	OBJECT CODE	ADDR1	ADDR2	STMT
				2 *****
				3 *
				4 * Zvector E6 instruction tests for VRI-f encoded:
				5 *
				6 * E671 VAP - VECTOR ADD DECIMAL
				7 * E673 VSP - VECTOR SUBTRACT DECIMAL
				8 * E678 VMP - VECTOR MULTIPLY DECIMAL
				9 * E679 VSDP - VECTOR MULTIPLY AND SHIFT DECIMAL
				10 * E67A VDP - VECTOR DIVIDE DECIMAL
				11 * E67B VRP - VECTOR REMAINDER DECIMAL
				12 * E67E VSDP - VECTOR SHIFT AND DIVIDE DECIMAL
				13 *
				14 * James Wekel June 2024
				15 *****
				16
				17 *****
				18 *
				19 * basic instruction tests
				20 *
				21 *****
				22 * This program tests proper functioning of the z/arch E6 VRI-f vector
				23 * packed decimal arithmetic instructions. Exceptions are not tested.
				24 *
				25 * PLEASE NOTE that the tests are very SIMPLE TESTS designed to catch
				26 * obvious coding errors. None of the tests are thorough. They are
				27 * NOT designed to test all aspects of any of the instructions.
				28 *
				29 *****
				30 *
				31 * *Testcase VECTOR E6 VRI-f packed arithmetic instructions
				32 * *
				33 * * Zvector E6 tests for VRI-f encoded packed decimal
				34 * * arithmetic instructions:
				35 * *
				36 * * E671 VAP - VECTOR ADD DECIMAL
				37 * * E673 VSP - VECTOR SUBTRACT DECIMAL
				38 * * E678 VMP - VECTOR MULTIPLY DECIMAL
				39 * * E679 VMSP - VECTOR MULTIPLY AND SHIFT DECIMAL
				40 * * E67A VDP - VECTOR DIVIDE DECIMAL
				41 * * E67B VRP - VECTOR REMAINDER DECIMAL
				42 * * E67E VSDP - VECTOR SHIFT AND DIVIDE DECIMAL
				43 * *
				44 * * # -----
				45 * * # This tests only the basic function of the instruction.
				46 * * # Exceptions are NOT tested.
				47 * * # -----
				48 * *
				49 * main size 2
				50 * numcpu 1
				51 * sysclear
				52 * archlvl z/Arch
				53 * *
				54 * loadcore "\$(testpath)/zvector-e6-05-packarith.core" 0x0
				55 * *
				56 * diag8cmd enable # (needed for messages to Hercules console)
				57 * runtest 2

[illegible]

LOC	OBJECT CODE			ADDR1	ADDR2	STMT	
						155	*****
						156	* cc was not as expected
						157	*****
00000276	E310	0001	0082	00000276	00000001	158	CCMSG EQU *
0000027C	E310	5008	0076		00000001	159	XG R1, R1
00000282	5410	82B8			00000008	160	LB R1, M5 M5 has CS bit
00000286	4780	805A			000004B8	161	N R1, =F' 1' get CS (CC set) bit
					0000025A	162	BZ TESTREST ignore if not set
						163	*
						164	* extract CC extracted PSW
						165	*
0000028A	5810	8EE8			000010E8	166	L R1, CCPSW
0000028E	8810	000C			0000000C	167	SRL R1, 12
00000292	5410	82BC			000004BC	168	N R1, =XL4' 3'
00000296	4210	8EF0			000010F0	169	STC R1, CCFOUND save cc
						170	*
						171	* FILL IN MESSAGE
						172	*
0000029A	4820	5004			00000004	173	LH R2, TNUM get test number and convert
0000029E	4E20	8ED5			000010D5	174	CVD R2, DECNUM
000002A2	D211	8EBF	8EA9	000010BF	000010A9	175	MVC PRT3, EDIT
000002A8	DE11	8EBF	8ED5	000010BF	000010D5	176	ED PRT3, DECNUM
000002AE	D202	8E64	8ECC	00001064	000010CC	177	MVC CCPRTNUM(3), PRT3+13 fill in message with test #
						178	
000002B4	D207	8E81	5020	00001081	00000020	179	MVC CCPRTNAME, OPNAME fill in message with instruction
						180	
000002BA	B982	0022				181	XGR R2, R2 get CC as U8
000002BE	4320	5009			00000009	182	IC R2, CC
000002C2	4E20	8ED5			000010D5	183	CVD R2, DECNUM and convert
000002C6	D211	8EBF	8EA9	000010BF	000010A9	184	MVC PRT3, EDIT
000002CC	DE11	8EBF	8ED5	000010BF	000010D5	185	ED PRT3, DECNUM
000002D2	D200	8E97	8ECE	00001097	000010CE	186	MVC CCPRTEXP(1), PRT3+15 fill in message with CC field
						187	
000002D8	B982	0022				188	XGR R2, R2 get CCFOUND as U8
000002DC	4320	8EF0			000010F0	189	IC R2, CCFOUND
000002E0	4E20	8ED5			000010D5	190	CVD R2, DECNUM and convert
000002E4	D211	8EBF	8EA9	000010BF	000010A9	191	MVC PRT3, EDIT
000002EA	DE11	8EBF	8ED5	000010BF	000010D5	192	ED PRT3, DECNUM
000002F0	D200	8EA7	8ECE	000010A7	000010CE	193	MVC CCPRTGOT(1), PRT3+15 fill in message with ccfound
						194	
000002F6	4100	0055			00000055	195	LA R0, CCPRTLNG message length
000002FA	4110	8E54			00001054	196	LA R1, CCPRTLNE messagfe address
000002FE	45F0	818C			0000038C	197	BAL R15, RPTERROR
						198	
00000302	47F0	816E			0000036E	199	B FAILCONT

LOC	OBJECT CODE			ADDR1	ADDR2	STMT	
						201	*****
						202	* result not as expected:
						203	* issue message with test number, instruction under test
						204	* and instruction m3
						205	*****
				00000306	00000001	206	FAILMSG EQU *
00000306	4820	5004			00000004	207	LH R2, TNUM get test number and convert
0000030A	4E20	8ED5			000010D5	208	CVD R2, DECNUM
0000030E	D211	8EBF 8EA9		000010BF	000010A9	209	MVC PRT3, EDIT
00000314	DE11	8EBF 8ED5		000010BF	000010D5	210	ED PRT3, DECNUM
0000031A	D202	8E18 8ECC		00001018	000010CC	211	MVC PRTNUM(3), PRT3+13 fill in message with test #
						212	
00000320	D207	8E33 5020		00001033	00000020	213	MVC PRTNAME, OPNAME fill in message with instruction
						214	
00000326	B982	0022				215	XGR R2, R2 get i4 as U8
0000032A	4320	5007			00000007	216	IC R2, I4
0000032E	4E20	8ED5			000010D5	217	CVD R2, DECNUM and convert
00000332	D211	8EBF 8EA9		000010BF	000010A9	218	MVC PRT3, EDIT
00000338	DE11	8EBF 8ED5		000010BF	000010D5	219	ED PRT3, DECNUM
0000033E	D202	8E44 8ECC		00001044	000010CC	220	MVC PRTI4(3), PRT3+13 fill in message with i4 field
						221	
00000344	B982	0022				222	XGR R2, R2 get m5 as U8
00000348	4320	5008			00000008	223	IC R2, M5 and convert
0000034C	4E20	8ED5			000010D5	224	CVD R2, DECNUM
00000350	D211	8EBF 8EA9		000010BF	000010A9	225	MVC PRT3, EDIT
00000356	DE11	8EBF 8ED5		000010BF	000010D5	226	ED PRT3, DECNUM
0000035C	D201	8E51 8ECD		00001051	000010CD	227	MVC PRTM5(2), PRT3+14 fill in message with m5 field
						228	
00000362	4100	004C			0000004C	229	LA R0, PRTLNG message length
00000366	4110	8E08			00001008	230	LA R1, PRTLNE messagfe address
0000036A	45F0	818C			0000038C	231	BAL R15, RPTERROR
						233	*****
						234	* continue after a failed test
						235	*****
				0000036E	00000001	236	FAILCONT EQU *
0000036E	5800	82B8			000004B8	237	L R0, =F' 1' set GLOBAL failed test indicator
00000372	5000	8E00			00001000	238	ST R0, FAILED
						239	
00000376	41C0	C004			00000004	240	LA R12, 4(0, R12) next test address
0000037A	47F0	802A			0000022A	241	B NEXTE6
						243	*****
						244	* end of testing; set ending psw
						245	*****
				0000037E	00000001	246	ENDTEST EQU *
0000037E	5810	8E00			00001000	247	L R1, FAILED did a test fail?
00000382	1211					248	LTR R1, R1
00000384	4780	8290			00000490	249	BZ EOJ No, exit
00000388	47F0	82A8			000004A8	250	B FAILTEST Yes, exit with BAD PSW
						251	

[illegible]

LOC	OBJECT CODE	ADDR1	ADDR2	STMT
				316 *****
				317 * Normal completion or Abnormal termination PSWs
				318 *****
00000480	00020001 80000000			320 E0JPSW DC 0D' 0' , X' 0002000180000000' , AD(0)
00000490	B2B2 8280		00000480	322 E0J LPSWE E0JPSW Normal completion
00000498	00020001 80000000			324 FAILPSW DC 0D' 0' , X' 0002000180000000' , AD(X' BAD')
000004A8	B2B2 8298		00000498	326 FAILTEST LPSWE FAILPSW Abnormal termination
				328 *****
				329 * Working Storage
				330 *****
000004AC	00000000			332 CTLR0 DS F CRO
000004B0	00000000			333 DS F
				334
000004B4	00004D0C			335 E6TADR DC A(E6TESTS) address of E6 test table
000004B8				337 LTORG , Literals pool
000004B8	00000001			338 =F' 1'
000004BC	00000003			339 =XL4' 3'
000004C0	0000			340 =H' 0'
000004C2	005F			341 =AL2(L' MSGMSG)
				342
				343 * some constants
				344
	00000400	00000001		345 K EQU 1024 One KB
	00001000	00000001		346 PAGE EQU (4*K) Size of one page
	00010000	00000001		347 K64 EQU (64*K) 64 KB
	00100000	00000001		348 MB EQU (K*K) 1 MB
				349
	AABBCCDD	00000001		350 REG2PATT EQU X' AABBCCDD' Polluted Register pattern
	000000DD	00000001		351 REG2LOW EQU X' DD' (last byte above)

LOC	OBJECT CODE	ADDR1	ADDR2	STMT
				353 *=====
				354 *
				355 * NOTE: start data on an address that is easy to display
				356 * within Hercules
				357 *
				358 *=====
				359
000004C4		000004C4	00001000	360
00001000	00000000			361 FAILED DC F' 0'
00001004	00000000			362 TESTING DC F' 0'
				364 *****
				365 * TEST failed : result messgae
				366 *****
				367 *
				368 * failed message and associated editting
				369 *
00001008	40404040	40404040		370 PRTLIN DC C' Test # '
00001018	A7A7A7			371 PRTNUM DC C' xxx'
0000101B	40868189	93858440		372 DC C' failed for instruction '
00001033	A7A7A7A7	A7A7A7A7		373 PRTNAME DC CL8' xxxxxxxx'
0000103B	40A689A3	884089F4		374 DC C' with i4=
00001044	A7A7A7			375 PRTI4 DC C' xxx'
00001047	6B			376 DC C' ,'
00001048	40A689A3	884094F5		377 DC C' with m5=
00001051	A7A7			378 PRTM5 DC C' xx'
00001053	4B			379 DC C' .'
		0000004C	00000001	380 PRTLNG EQU *- PRTLIN
				382 *****
				383 * TEST failed : CC message
				384 *****
				385 *
				386 * failed message and associated editting
				387 *
00001054	40404040	40404040		388 CCPRTLIN DC C' Test # '
00001064	A7A7A7			389 CCPRTNUM DC C' xxx'
00001067	40A69996	95874083		390 DC c' wrong cc for instruction '
00001081	A7A7A7A7	A7A7A7A7		391 CCPRTNAME DC CL8' xxxxxxxx'
00001089	4085A797	8583A385		392 DC C' expected: cc=
00001097	A7			393 CCPRTEXP DC C' x'
00001098	6B			394 DC C' ,'
00001099	40998583	8589A585		395 DC C' received: cc=
000010A7	A7			396 CCPRTGOT DC C' x'
000010A8	4B			397 DC C' .'
		00000055	00000001	398 CCPRTLNG EQU *- CCPRTLIN

[illegible]

LOC	OBJECT CODE	ADDR1	ADDR2	STMT
				455 *****
				456 * Macros to help build test tables
				457 *-----
				458 * VRI_F Macro to help build test tables
				459 *****
				460 MACRO
				461 VRI_F &INST, &V2, &V3, &I4, &M5, &CC
				462 . * &INST - VRI-f instruction under test
				463 . * &v2 - binary DW value for V2
				464 . * &v3 - binary DW value for V3
				465 . * &i4 - i4 field
				466 . * &m5 - m5 field
				467 . * &CC - expected CC
				468 . *
				469 LCLA &XCC(4) &CC has mask values for FAILED condition codes
				470 &XCC(1) SETA 7 CC != 0
				471 &XCC(2) SETA 11 CC != 1
				472 &XCC(3) SETA 13 CC != 2
				473 &XCC(4) SETA 14 CC != 3
				474
				475 GBLA &TNUM
				476 &TNUM SETA &TNUM+1
				477
				478 DS 0FD
				479 USING *, R5 base for test data and test routine
				480
				481 T&TNUM DC A(X&TNUM) address of test routine
				482 DC H' &TNUM test number
				483 DC X' 00'
				484 DC HL1' &I4' i4
				485 DC HL1' &M5' m5
				486 DC HL1' &CC' cc
				487 DC HL1' &XCC(&CC+1)' cc failed mask
				488 V2_&TNUM DC FD' &V2' binary value for v2 packed decimal
				489 V3_&TNUM DC FD' &V3' binary value for v3 packed decimal
				490 DC CL8' &INST' instruction name
				491 DC A(16) result length
				492 REA&TNUM DC A(RE&TNUM) result address
				493 . *
				494 * INSTRUCTION UNDER TEST ROUTINE
				495 X&TNUM DS 0F
				496 LG R2, V2_&TNUM convert v2
				497 CVDG R2, V2PACKED
				498 VL V2, V2PACKED
				499
				500 LG R2, V3_&TNUM convert v3
				501 CVDG R2, V3PACKED
				502 VL V3, V3PACKED
				503
				504 &INST V1, V2, V3, &I4, &M5 test instruction
				505
				506 VST V1, V10OUTPUT save result
				507 EPSW R2, R0 exptract psw
				508 ST R2, CCPSW to save CC
				509 BR R11 return
				510

516	*****		
517	* PTTABLE Macro to generate table of pointers to individual tests		
518	*****		
519			
520		MACRO	
521		PTTABLE	
522		GBLA	&TNUM
523		LCLA	&CUR
524	&CUR	SETA	1
525	. *		
526	TTABLE	DS	OF
527	. LOOP	ANOP	
528	. *		
529		DC	A(T&CUR) address of test
530	. *		
531	&CUR	SETA	&CUR+1
532		AIF	(&CUR LE &TNUM) . LOOP
533	*		
534		DC	A(0) END OF TABLE
535		DC	A(0)
536	. *		
537		MEND	

LOC	OBJECT CODE	ADDR1	ADDR2	STMT	
				539 *****	
				540 * E6 VRI_F tests	
				541 *****	
00001188		00000000	00004EF7	542 ZVE6TST CSECT ,	
				543 DS OF	
				545 PRINT DATA	
				546 *	
				547 * E671 VAP - VECTOR ADD DECIMAL	
				548 * E673 VSP - VECTOR SUBTRACT DECIMAL	
				549 * E678 VMP - VECTOR MULTIPLY DECIMAL	
				550 * E679 VMSP - VECTOR MULTIPLY AND SHIFT DECIMAL	
				551 * E67A VDP - VECTOR DIVIDE DECIMAL	
				552 * E67B VRP - VECTOR REMAINDER DECIMAL	
				553 * E67E VSDP - VECTOR SHIFT AND DIVIDE DECIMAL	
				554	
				555 * VRI_F instr, v2, v3, i4, m5, cc	
				556 * followed by 16 byte expected result	
				557	
				558 * -----	
				559 * VAP - VECTOR ADD DECIMAL	
				560 * -----	
				561 * VAP simple + CC checks	
				562 VRI_F VAP, +10, +12, 7, 1, 2	
00001188				563+ DS OFD	
00001188		00001188		564+ USING *, R5	base for test data and test routine
00001188	000011B8			565+T1 DC A(X1)	address of test routine
0000118C	0001			566+ DC H' 1'	test number
0000118E	00			567+ DC X' 00'	
0000118F	07			568+ DC HL1' 7'	i4
00001190	01			569+ DC HL1' 1'	m5
00001191	02			570+ DC HL1' 2'	cc
00001192	0D			571+ DC HL1' 13'	cc failed mask
00001198	00000000 0000000A			572+V2_1 DC FD' +10'	binary value for v2 packed decimal
000011A0	00000000 0000000C			573+V3_1 DC FD' +12'	binary value for v3 packed decimal
000011A8	E5C1D740 40404040			574+ DC CL8' VAP'	instruction name
000011B0	00000010			575+ DC A(16)	result length
000011B4	000011F4			576+REA1 DC A(RE1)	result address
				577+*	INSTRUCTION UNDER TEST ROUTINE
000011B8				578+X1 DS OF	
000011B8	E320 5010 0004		00001198	579+ LG R2, V2_1	convert v2
000011BE	E320 8F57 002E		00001157	580+ CVDG R2, V2PACKED	
000011C4	E720 8F57 0006		00001157	581+ VL V2, V2PACKED	
000011CA	E320 5018 0004		000011A0	582+ LG R2, V3_1	convert v3
000011D0	E320 8F67 002E		00001167	583+ CVDG R2, V3PACKED	
000011D6	E730 8F67 0006		00001167	584+ VL V3, V3PACKED	
000011DC	E612 3010 7071			585+ VAP V1, V2, V3, 7, 1	test instruction
000011E2	E710 8F08 000E		00001108	586+ VST V1, V10UTPUT	save result
000011E8	B98D 0020			587+ EPSW R2, R0	exptract psw
000011EC	5020 8EE8		000010E8	588+ ST R2, CCPSW	to save CC
000011F0	07FB			589+ BR R11	return
000011F4				590+RE1 DC OF	
000011F4				591+ DROP R5	
000011F4	00000000 00000000			592 DC XL16' 000000000000000000000000000022C'	
000011FC	00000000 0000022C				

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
				593		
				594	VRI_F VAP, - 10, +12, 7, 1, 2	
00001208				595+	DS OFD	
00001208		00001208		596+	USING *, R5	base for test data and test routine
00001208	00001238			597+T2	DC A(X2)	address of test routine
0000120C	0002			598+	DC H' 2'	test number
0000120E	00			599+	DC X' 00'	
0000120F	07			600+	DC HL1' 7'	i4
00001210	01			601+	DC HL1' 1'	m5
00001211	02			602+	DC HL1' 2'	cc
00001212	0D			603+	DC HL1' 13'	cc failed mask
00001218	FFFFFFFF FFFFFFFF6			604+V2_2	DC FD' - 10'	binary value for v2 packed decimal
00001220	00000000 0000000C			605+V3_2	DC FD' +12'	binary value for v3 packed decimal
00001228	E5C1D740 40404040			606+	DC CL8' VAP'	instruction name
00001230	00000010			607+	DC A(16)	result length
00001234	00001274			608+REA2	DC A(RE2)	result address
				609+*		INSTRUCTION UNDER TEST ROUTINE
00001238				610+X2	DS OF	
00001238	E320 5010 0004		00001218	611+	LG R2, V2_2	convert v2
0000123E	E320 8F57 002E		00001157	612+	CVDG R2, V2PACKED	
00001244	E720 8F57 0006		00001157	613+	VL V2, V2PACKED	
0000124A	E320 5018 0004		00001220	614+	LG R2, V3_2	convert v3
00001250	E320 8F67 002E		00001167	615+	CVDG R2, V3PACKED	
00001256	E730 8F67 0006		00001167	616+	VL V3, V3PACKED	
0000125C	E612 3010 7071			617+	VAP V1, V2, V3, 7, 1	test instruction
00001262	E710 8F08 000E		00001108	618+	VST V1, V10UTPUT	save result
00001268	B98D 0020			619+	EPSW R2, R0	exptract psw
0000126C	5020 8EE8		000010E8	620+	ST R2, CCPSW	to save CC
00001270	07FB			621+	BR R11	return
00001274				622+RE2	DC OF	
00001274				623+	DROP R5	
00001274	00000000 00000000			624	DC XL16' 000000000000000000000000000000002C'	
0000127C	00000000 0000002C					
				625		
				626	VRI_F VAP, +10, - 12, 7, 1, 1	
00001288				627+	DS OFD	
00001288		00001288		628+	USING *, R5	base for test data and test routine
00001288	000012B8			629+T3	DC A(X3)	address of test routine
0000128C	0003			630+	DC H' 3'	test number
0000128E	00			631+	DC X' 00'	
0000128F	07			632+	DC HL1' 7'	i4
00001290	01			633+	DC HL1' 1'	m5
00001291	01			634+	DC HL1' 1'	cc
00001292	0B			635+	DC HL1' 11'	cc failed mask
00001298	00000000 0000000A			636+V2_3	DC FD' +10'	binary value for v2 packed decimal
000012A0	FFFFFFFF FFFFFFFF4			637+V3_3	DC FD' - 12'	binary value for v3 packed decimal
000012A8	E5C1D740 40404040			638+	DC CL8' VAP'	instruction name
000012B0	00000010			639+	DC A(16)	result length
000012B4	000012F4			640+REA3	DC A(RE3)	result address
				641+*		INSTRUCTION UNDER TEST ROUTINE
000012B8				642+X3	DS OF	
000012B8	E320 5010 0004		00001298	643+	LG R2, V2_3	convert v2
000012BE	E320 8F57 002E		00001157	644+	CVDG R2, V2PACKED	
000012C4	E720 8F57 0006		00001157	645+	VL V2, V2PACKED	
000012CA	E320 5018 0004		000012A0	646+	LG R2, V3_3	convert v3
000012D0	E320 8F67 002E		00001167	647+	CVDG R2, V3PACKED	

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
000012D6	E730 8F67 0006		00001167	648+	VL	V3, V3PACKED	
000012DC	E612 3010 7071			649+	VAP	V1, V2, V3, 7, 1	test instruction
000012E2	E710 8F08 000E		00001108	650+	VST	V1, V10UTPUT	save result
000012E8	B98D 0020			651+	EPSW	R2, R0	exptract psw
000012EC	5020 8EE8		000010E8	652+	ST	R2, CCPSW	to save CC
000012F0	07FB			653+	BR	R11	return
000012F4				654+RE3	DC	0F	
000012F4				655+	DROP	R5	
000012F4	00000000 00000000			656	DC	XL16' 000000000000000000000000000000002D'	
000012FC	00000000 0000002D						
				657			
00001308				658	VRI_F	VAP, - 10, - 12, 7, 1, 1	
00001308		00001308		659+	DS	0FD	
00001308	00001338			660+	USING	*, R5	base for test data and test routine
0000130C	0004			661+T4	DC	A(X4)	address of test routine
0000130E	00			662+	DC	H' 4'	test number
0000130F	07			663+	DC	X' 00'	
00001310	01			664+	DC	HL1' 7'	i4
00001311	01			665+	DC	HL1' 1'	m5
00001312	0B			666+	DC	HL1' 1'	cc
00001318	FFFFFFFF FFFFFFFF6			667+	DC	HL1' 11'	cc failed mask
00001320	FFFFFFFF FFFFFFFF4			668+V2_4	DC	FD' - 10'	binary value for v2 packed decimal
00001328	E5C1D740 40404040			669+V3_4	DC	FD' - 12'	binary value for v3 packed decimal
00001330	00000010			670+	DC	CL8' VAP'	instruction name
00001334	00001374			671+	DC	A(16)	result length
				672+REA4	DC	A(RE4)	result address
				673+*			INSTRUCTION UNDER TEST ROUTINE
00001338				674+X4	DS	0F	
00001338	E320 5010 0004		00001318	675+	LG	R2, V2_4	convert v2
0000133E	E320 8F57 002E		00001157	676+	CVDG	R2, V2PACKED	
00001344	E720 8F57 0006		00001157	677+	VL	V2, V2PACKED	
0000134A	E320 5018 0004		00001320	678+	LG	R2, V3_4	convert v3
00001350	E320 8F67 002E		00001167	679+	CVDG	R2, V3PACKED	
00001356	E730 8F67 0006		00001167	680+	VL	V3, V3PACKED	
0000135C	E612 3010 7071			681+	VAP	V1, V2, V3, 7, 1	test instruction
00001362	E710 8F08 000E		00001108	682+	VST	V1, V10UTPUT	save result
00001368	B98D 0020			683+	EPSW	R2, R0	exptract psw
0000136C	5020 8EE8		000010E8	684+	ST	R2, CCPSW	to save CC
00001370	07FB			685+	BR	R11	return
00001374				686+RE4	DC	0F	
00001374				687+	DROP	R5	
00001374	00000000 00000000			688	DC	XL16' 000000000000000000000000000000002D'	
0000137C	00000000 0000022D						
				689			
00001388				690	VRI_F	VAP, - 10, +10, 7, 1, 0	
00001388		00001388		691+	DS	0FD	
00001388	000013B8			692+	USING	*, R5	base for test data and test routine
0000138C	0005			693+T5	DC	A(X5)	address of test routine
0000138E	00			694+	DC	H' 5'	test number
0000138F	07			695+	DC	X' 00'	
00001390	01			696+	DC	HL1' 7'	i4
00001391	00			697+	DC	HL1' 1'	m5
00001392	07			698+	DC	HL1' 0'	cc
00001398	FFFFFFFF FFFFFFFF6			699+	DC	HL1' 7'	cc failed mask
000013A0	00000000 0000000A			700+V2_5	DC	FD' - 10'	binary value for v2 packed decimal
				701+V3_5	DC	FD' +10'	binary value for v3 packed decimal

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
000013A8	E5C1D740 40404040			702+	DC	CL8' VAP'	instruction name
000013B0	00000010			703+	DC	A(16)	result length
000013B4	000013F4			704+REA5	DC	A(RE5)	result address
				705+*			INSTRUCTION UNDER TEST ROUTINE
000013B8				706+X5	DS	0F	
000013B8	E320 5010 0004		00001398	707+	LG	R2, V2_5	convert v2
000013BE	E320 8F57 002E		00001157	708+	CVDG	R2, V2PACKED	
000013C4	E720 8F57 0006		00001157	709+	VL	V2, V2PACKED	
000013CA	E320 5018 0004		000013A0	710+	LG	R2, V3_5	convert v3
000013D0	E320 8F67 002E		00001167	711+	CVDG	R2, V3PACKED	
000013D6	E730 8F67 0006		00001167	712+	VL	V3, V3PACKED	
000013DC	E612 3010 7071			713+	VAP	V1, V2, V3, 7, 1	test instruction
000013E2	E710 8F08 000E		00001108	714+	VST	V1, V10UTPUT	save result
000013E8	B98D 0020			715+	EPSW	R2, R0	exptract psw
000013EC	5020 8EE8		000010E8	716+	ST	R2, CCPSW	to save CC
000013F0	07FB			717+	BR	R11	return
000013F4				718+RE5	DC	0F	
000013F4				719+	DROP	R5	
000013F4	00000000 00000000			720	DC	XL16' 00000000000000000000000000000000C'	
000013FC	00000000 0000000C						
				721			
				722	VRI_F	VAP, +100000000000, +10, 135, 1, 3	i4=135(iom=1 & rdc=7)
00001408				723+	DS	0FD	
00001408		00001408		724+	USING	*, R5	base for test data and test routine
00001408	00001438			725+T6	DC	A(X6)	address of test routine
0000140C	0006			726+	DC	H' 6'	test number
0000140E	00			727+	DC	X' 00'	
0000140F	87			728+	DC	HL1' 135'	i4
00001410	01			729+	DC	HL1' 1'	m5
00001411	03			730+	DC	HL1' 3'	cc
00001412	0E			731+	DC	HL1' 14'	cc failed mask
00001418	00000002 540BE400			732+V2_6	DC	FD' +100000000000'	binary value for v2 packed decimal
00001420	00000000 0000000A			733+V3_6	DC	FD' +10'	binary value for v3 packed decimal
00001428	E5C1D740 40404040			734+	DC	CL8' VAP'	instruction name
00001430	00000010			735+	DC	A(16)	result length
00001434	00001474			736+REA6	DC	A(RE6)	result address
				737+*			INSTRUCTION UNDER TEST ROUTINE
00001438				738+X6	DS	0F	
00001438	E320 5010 0004		00001418	739+	LG	R2, V2_6	convert v2
0000143E	E320 8F57 002E		00001157	740+	CVDG	R2, V2PACKED	
00001444	E720 8F57 0006		00001157	741+	VL	V2, V2PACKED	
0000144A	E320 5018 0004		00001420	742+	LG	R2, V3_6	convert v3
00001450	E320 8F67 002E		00001167	743+	CVDG	R2, V3PACKED	
00001456	E730 8F67 0006		00001167	744+	VL	V3, V3PACKED	
0000145C	E612 3018 7071			745+	VAP	V1, V2, V3, 135, 1	test instruction
00001462	E710 8F08 000E		00001108	746+	VST	V1, V10UTPUT	save result
00001468	B98D 0020			747+	EPSW	R2, R0	exptract psw
0000146C	5020 8EE8		000010E8	748+	ST	R2, CCPSW	to save CC
00001470	07FB			749+	BR	R11	return
00001474				750+RE6	DC	0F	
00001474				751+	DROP	R5	
00001474	00000000 00000000			752	DC	XL16' 000000000000000000000000000010C'	
0000147C	00000000 0000010C						
				753			
				754	*	VAP larger #'s , i4=159(iom=1 & rdc=31)	
				755	VRI_F	VAP, +9999999999999999, +1, 159, 1, 2	

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
00001488				756+	DS	OFD	
00001488		00001488		757+	USING	*, R5	base for test data and test routine
00001488	000014B8			758+T7	DC	A(X7)	address of test routine
0000148C	0007			759+	DC	H' 7'	test number
0000148E	00			760+	DC	X' 00'	
0000148F	9F			761+	DC	HL1' 159'	i4
00001490	01			762+	DC	HL1' 1'	m5
00001491	02			763+	DC	HL1' 2'	cc
00001492	0D			764+	DC	HL1' 13'	cc failed mask
				765+V2_7	DC	FD' +9999999999999999' \	
00001498	01634578 5D89FFFF			+			binary value for v2 packed decimal
000014A0	00000000 00000001			766+V3_7	DC	FD' +1'	binary value for v3 packed decimal
000014A8	E5C1D740 40404040			767+	DC	CL8' VAP'	instruction name
000014B0	00000010			768+	DC	A(16)	result length
000014B4	000014F4			769+REA7	DC	A(RE7)	result address
				770+*			INSTRUCTION UNDER TEST ROUTINE
000014B8				771+X7	DS	OF	
000014B8	E320 5010 0004		00001498	772+	LG	R2, V2_7	convert v2
000014BE	E320 8F57 002E		00001157	773+	CVDG	R2, V2PACKED	
000014C4	E720 8F57 0006		00001157	774+	VL	V2, V2PACKED	
000014CA	E320 5018 0004		000014A0	775+	LG	R2, V3_7	convert v3
000014D0	E320 8F67 002E		00001167	776+	CVDG	R2, V3PACKED	
000014D6	E730 8F67 0006		00001167	777+	VL	V3, V3PACKED	
000014DC	E612 3019 F071			778+	VAP	V1, V2, V3, 159, 1	test instruction
000014E2	E710 8F08 000E		00001108	779+	VST	V1, V10OUTPUT	save result
000014E8	B98D 0020			780+	EPSW	R2, R0	exptract psw
000014EC	5020 8EE8		000010E8	781+	ST	R2, CCPSW	to save CC
000014F0	07FB			782+	BR	R11	return
000014F4				783+RE7	DC	OF	
000014F4				784+	DROP	R5	
000014F4	00000000 00000100			785	DC	XL16' 000000000000010000000000000000C'	
000014FC	00000000 0000000C						
				786			
				787	VRI_F	VAP, +9999999999999999, +1000000000000000, 159, 1, 2	
00001508				788+	DS	OFD	
00001508		00001508		789+	USING	*, R5	base for test data and test routine
00001508	00001538			790+T8	DC	A(X8)	address of test routine
0000150C	0008			791+	DC	H' 8'	test number
0000150E	00			792+	DC	X' 00'	
0000150F	9F			793+	DC	HL1' 159'	i4
00001510	01			794+	DC	HL1' 1'	m5
00001511	02			795+	DC	HL1' 2'	cc
00001512	0D			796+	DC	HL1' 13'	cc failed mask
				797+V2_8	DC	FD' +9999999999999999' \	
00001518	01634578 5D89FFFF			+			binary value for v2 packed decimal
				798+V3_8	DC	FD' +1000000000000000' \	
00001520	002386F2 6FC10000			+			binary value for v3 packed decimal
00001528	E5C1D740 40404040			799+	DC	CL8' VAP'	instruction name
00001530	00000010			800+	DC	A(16)	result length
00001534	00001574			801+REA8	DC	A(RE8)	result address
				802+*			INSTRUCTION UNDER TEST ROUTINE
00001538				803+X8	DS	OF	
00001538	E320 5010 0004		00001518	804+	LG	R2, V2_8	convert v2
0000153E	E320 8F57 002E		00001157	805+	CVDG	R2, V2PACKED	
00001544	E720 8F57 0006		00001157	806+	VL	V2, V2PACKED	
0000154A	E320 5018 0004		00001520	807+	LG	R2, V3_8	convert v3

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
00001550	E320 8F67 002E		00001167	808+	CVDG	R2, V3PACKED	
00001556	E730 8F67 0006		00001167	809+	VL	V3, V3PACKED	
0000155C	E612 3019 F071			810+	VAP	V1, V2, V3, 159, 1	test instruction
00001562	E710 8F08 000E		00001108	811+	VST	V1, V10UTPUT	save result
00001568	B98D 0020			812+	EPSW	R2, R0	exptract psw
0000156C	5020 8EE8		000010E8	813+	ST	R2, CCPSW	to save CC
00001570	07FB			814+	BR	R11	return
00001574				815+RE8	DC	0F	
00001574				816+	DROP	R5	
00001574	00000000 00000109			817	DC	XL16' 0000000000000010999999999999999C'	
0000157C	99999999 9999999C						
				818			
				819	VRI_F	VAP, - 9999999999999999, - 1, 159, 1, 1	
00001588				820+	DS	0FD	
00001588		00001588		821+	USING	*, R5	base for test data and test routine
00001588	000015B8			822+T9	DC	A(X9)	address of test routine
0000158C	0009			823+	DC	H' 9'	test number
0000158E	00			824+	DC	X' 00'	
0000158F	9F			825+	DC	HL1' 159'	i4
00001590	01			826+	DC	HL1' 1'	m5
00001591	01			827+	DC	HL1' 1'	cc
00001592	0B			828+	DC	HL1' 11'	cc failed mask
				829+V2_9	DC	FD' - 9999999999999999' \	
00001598	FFDC790D 903F0001			+			binary value for v2 packed decimal
000015A0	FFFFFFFF FFFFFFFF			830+V3_9	DC	FD' - 1'	binary value for v3 packed decimal
000015A8	E5C1D740 40404040			831+	DC	CL8' VAP'	instruction name
000015B0	00000010			832+	DC	A(16)	result length
000015B4	000015F4			833+REA9	DC	A(RE9)	result address
				834+*			INSTRUCTION UNDER TEST ROUTINE
000015B8				835+X9	DS	0F	
000015B8	E320 5010 0004		00001598	836+	LG	R2, V2_9	convert v2
000015BE	E320 8F57 002E		00001157	837+	CVDG	R2, V2PACKED	
000015C4	E720 8F57 0006		00001157	838+	VL	V2, V2PACKED	
000015CA	E320 5018 0004		000015A0	839+	LG	R2, V3_9	convert v3
000015D0	E320 8F67 002E		00001167	840+	CVDG	R2, V3PACKED	
000015D6	E730 8F67 0006		00001167	841+	VL	V3, V3PACKED	
000015DC	E612 3019 F071			842+	VAP	V1, V2, V3, 159, 1	test instruction
000015E2	E710 8F08 000E		00001108	843+	VST	V1, V10UTPUT	save result
000015E8	B98D 0020			844+	EPSW	R2, R0	exptract psw
000015EC	5020 8EE8		000010E8	845+	ST	R2, CCPSW	to save CC
000015F0	07FB			846+	BR	R11	return
000015F4				847+RE9	DC	0F	
000015F4				848+	DROP	R5	
000015F4	00000000 00000010			849	DC	XL16' 000000000000001000000000000000D'	
000015FC	00000000 0000000D						
				850			
				851	* VAP larger #'s , i4=159(iom=1 & rdc=31)		CS=1 for all m5
				852	* check forced positive		
				853	VRI_F	VAP, - 9999999999999999, +1, 159, 9, 2	m5=9(P2=1)
00001608				854+	DS	0FD	
00001608		00001608		855+	USING	*, R5	base for test data and test routine
00001608	00001638			856+T10	DC	A(X10)	address of test routine
0000160C	000A			857+	DC	H' 10'	test number
0000160E	00			858+	DC	X' 00'	
0000160F	9F			859+	DC	HL1' 159'	i4
00001610	09			860+	DC	HL1' 9'	m5

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
00001611	02			861+	DC	HL1' 2'	cc
00001612	0D			862+	DC	HL1' 13'	cc failed mask
				863+V2_10	DC	FD' - 9999999999999999'	\
00001618	FE9CBA87 A2760001			+			binary value for v2 packed decimal
00001620	00000000 00000001			864+V3_10	DC	FD' +1'	binary value for v3 packed decimal
00001628	E5C1D740 40404040			865+	DC	CL8' VAP'	instruction name
00001630	00000010			866+	DC	A(16)	result length
00001634	00001674			867+REA10	DC	A(RE10)	result address
				868+*			INSTRUCTION UNDER TEST ROUTINE
00001638				869+X10	DS	0F	
00001638	E320 5010 0004		00001618	870+	LG	R2, V2_10	convert v2
0000163E	E320 8F57 002E		00001157	871+	CVDG	R2, V2PACKED	
00001644	E720 8F57 0006		00001157	872+	VL	V2, V2PACKED	
0000164A	E320 5018 0004		00001620	873+	LG	R2, V3_10	convert v3
00001650	E320 8F67 002E		00001167	874+	CVDG	R2, V3PACKED	
00001656	E730 8F67 0006		00001167	875+	VL	V3, V3PACKED	
0000165C	E612 3099 F071			876+	VAP	V1, V2, V3, 159, 9	test instruction
00001662	E710 8F08 000E		00001108	877+	VST	V1, V10OUTPUT	save result
00001668	B98D 0020			878+	EPSW	R2, R0	exptract psw
0000166C	5020 8EE8		000010E8	879+	ST	R2, CCPSW	to save CC
00001670	07FB			880+	BR	R11	return
00001674				881+RE10	DC	0F	
00001674				882+	DROP	R5	
00001674	00000000 00000100			883	DC	XL16' 000000000000010000000000000000C'	
0000167C	00000000 0000000C						
				884			
				885	VRI_F	VAP, - 9999999999999999, - 1000000000000000, 159, 13, 2	
00001688				886+	DS	0FD	
00001688		00001688		887+	USING	*, R5	base for test data and test routine
00001688	000016B8			888+T11	DC	A(X11)	address of test routine
0000168C	000B			889+	DC	H' 11'	test number
0000168E	00			890+	DC	X' 00'	
0000168F	9F			891+	DC	HL1' 159'	i4
00001690	0D			892+	DC	HL1' 13'	m5
00001691	02			893+	DC	HL1' 2'	cc
00001692	0D			894+	DC	HL1' 13'	cc failed mask
				895+V2_11	DC	FD' - 9999999999999999'	\
00001698	FE9CBA87 A2760001			+			binary value for v2 packed decimal
				896+V3_11	DC	FD' - 1000000000000000'	\
				+			binary value for v3 packed decimal
000016A0	FFDC790D 903F0000						instruction name
000016A8	E5C1D740 40404040			897+	DC	CL8' VAP'	instruction name
000016B0	00000010			898+	DC	A(16)	result length
000016B4	000016F4			899+REA11	DC	A(RE11)	result address
				900+*			INSTRUCTION UNDER TEST ROUTINE
000016B8				901+X11	DS	0F	
000016B8	E320 5010 0004		00001698	902+	LG	R2, V2_11	convert v2
000016BE	E320 8F57 002E		00001157	903+	CVDG	R2, V2PACKED	
000016C4	E720 8F57 0006		00001157	904+	VL	V2, V2PACKED	
000016CA	E320 5018 0004		000016A0	905+	LG	R2, V3_11	convert v3
000016D0	E320 8F67 002E		00001167	906+	CVDG	R2, V3PACKED	
000016D6	E730 8F67 0006		00001167	907+	VL	V3, V3PACKED	
000016DC	E612 30D9 F071			908+	VAP	V1, V2, V3, 159, 13	test instruction
000016E2	E710 8F08 000E		00001108	909+	VST	V1, V10OUTPUT	save result
000016E8	B98D 0020			910+	EPSW	R2, R0	exptract psw
000016EC	5020 8EE8		000010E8	911+	ST	R2, CCPSW	to save CC
000016F0	07FB			912+	BR	R11	return

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
000016F4				913+RE11	DC	0F	
000016F4				914+	DROP	R5	
000016F4	00000000 00000109			915	DC	XL16' 00000000000000010999999999999999C'	m5=13(P2=1, P3=1)
000016FC	99999999 9999999C						
				916			
				917	VRI_F	VAP, - 9999999999999999, - 1, 159, 3, 2	m5=3(P1=1)
00001708				918+	DS	0FD	
00001708		00001708		919+	USING	*, R5	base for test data and test routine
00001708	00001738			920+T12	DC	A(X12)	address of test routine
0000170C	000C			921+	DC	H' 12'	test number
0000170E	00			922+	DC	X' 00'	
0000170F	9F			923+	DC	HL1' 159'	i4
00001710	03			924+	DC	HL1' 3'	m5
00001711	02			925+	DC	HL1' 2'	cc
00001712	0D			926+	DC	HL1' 13'	cc failed mask
				927+V2_12	DC	FD' - 9999999999999999' \	
00001718	FFDC790D 903F0001			+			binary value for v2 packed decimal
00001720	FFFFFFFF FFFFFFFF			928+V3_12	DC	FD' - 1'	binary value for v3 packed decimal
00001728	E5C1D740 40404040			929+	DC	CL8' VAP'	instruction name
00001730	00000010			930+	DC	A(16)	result length
00001734	00001774			931+REA12	DC	A(RE12)	result address
				932+*			INSTRUCTION UNDER TEST ROUTINE
00001738				933+X12	DS	0F	
00001738	E320 5010 0004		00001718	934+	LG	R2, V2_12	convert v2
0000173E	E320 8F57 002E		00001157	935+	CVDG	R2, V2PACKED	
00001744	E720 8F57 0006		00001157	936+	VL	V2, V2PACKED	
0000174A	E320 5018 0004		00001720	937+	LG	R2, V3_12	convert v3
00001750	E320 8F67 002E		00001167	938+	CVDG	R2, V3PACKED	
00001756	E730 8F67 0006		00001167	939+	VL	V3, V3PACKED	
0000175C	E612 3039 F071			940+	VAP	V1, V2, V3, 159, 3	test instruction
00001762	E710 8F08 000E		00001108	941+	VST	V1, V10UTPUT	save result
00001768	B98D 0020			942+	EPSW	R2, R0	exptract psw
0000176C	5020 8EE8		000010E8	943+	ST	R2, CCPSW	to save CC
00001770	07FB			944+	BR	R11	return
00001774				945+RE12	DC	0F	
00001774				946+	DROP	R5	
00001774	00000000 00000010			947	DC	XL16' 0000000000000001000000000000000F'	
0000177C	00000000 0000000F						
				948			
				949 *			
				950 * VSP		- VECTOR SUBTRACT DECIMAL	
				951 *			
				952 * VSP simple		+ CC checks	
				953	VRI_F	VSP, +10, +12, 7, 1, 1	
00001788				954+	DS	0FD	
00001788		00001788		955+	USING	*, R5	base for test data and test routine
00001788	000017B8			956+T13	DC	A(X13)	address of test routine
0000178C	000D			957+	DC	H' 13'	test number
0000178E	00			958+	DC	X' 00'	
0000178F	07			959+	DC	HL1' 7'	i4
00001790	01			960+	DC	HL1' 1'	m5
00001791	01			961+	DC	HL1' 1'	cc
00001792	0B			962+	DC	HL1' 11'	cc failed mask
00001798	00000000 0000000A			963+V2_13	DC	FD' +10'	binary value for v2 packed decimal
000017A0	00000000 0000000C			964+V3_13	DC	FD' +12'	binary value for v3 packed decimal
000017A8	E5E2D740 40404040			965+	DC	CL8' VSP'	instruction name

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
00001888	000018B8			1020+T15	DC	A(X15)
0000188C	000F			1021+	DC	H' 15'
0000188E	00			1022+	DC	X' 00'
0000188F	01			1023+	DC	HL1' 1'
00001890	01			1024+	DC	HL1' 1'
00001891	03			1025+	DC	HL1' 3'
00001892	0E			1026+	DC	HL1' 14'
00001898	00000000 0000000A			1027+V2_15	DC	FD' +10'
000018A0	FFFFFFFF FFFFFFFF4			1028+V3_15	DC	FD' - 12'
000018A8	E5E2D740 40404040			1029+	DC	CL8' VSP'
000018B0	00000010			1030+	DC	A(16)
000018B4	000018F4			1031+REA15	DC	A(RE15)
				1032+*		
000018B8				1033+X15	DS	0F
000018B8	E320 5010 0004		00001898	1034+	LG	R2, V2_15
000018BE	E320 8F57 002E		00001157	1035+	CVDG	R2, V2PACKED
000018C4	E720 8F57 0006		00001157	1036+	VL	V2, V2PACKED
000018CA	E320 5018 0004		000018A0	1037+	LG	R2, V3_15
000018D0	E320 8F67 002E		00001167	1038+	CVDG	R2, V3PACKED
000018D6	E730 8F67 0006		00001167	1039+	VL	V3, V3PACKED
000018DC	E612 3010 1073			1040+	VSP	V1, V2, V3, 1, 1
000018E2	E710 8F08 000E		00001108	1041+	VST	V1, V10OUTPUT
000018E8	B98D 0020			1042+	EPSW	R2, R0
000018EC	5020 8EE8		000010E8	1043+	ST	R2, CCPSW
000018F0	07FB			1044+	BR	R11
000018F4				1045+RE15	DC	0F
000018F4				1046+	DROP	R5
000018F4	00000000 00000000			1047	DC	XL16' 000000000000000000000000000000002C'
000018FC	00000000 0000002C					
				1048		
				1049	VRI_F	VSP, +10, - 12, 7, 1, 2
00001908				1050+	DS	0FD
00001908		00001908		1051+	USING	*, R5
00001908	00001938			1052+T16	DC	A(X16)
0000190C	0010			1053+	DC	H' 16'
0000190E	00			1054+	DC	X' 00'
0000190F	07			1055+	DC	HL1' 7'
00001910	01			1056+	DC	HL1' 1'
00001911	02			1057+	DC	HL1' 2'
00001912	0D			1058+	DC	HL1' 13'
00001918	00000000 0000000A			1059+V2_16	DC	FD' +10'
00001920	FFFFFFFF FFFFFFFF4			1060+V3_16	DC	FD' - 12'
00001928	E5E2D740 40404040			1061+	DC	CL8' VSP'
00001930	00000010			1062+	DC	A(16)
00001934	00001974			1063+REA16	DC	A(RE16)
				1064+*		
00001938				1065+X16	DS	0F
00001938	E320 5010 0004		00001918	1066+	LG	R2, V2_16
0000193E	E320 8F57 002E		00001157	1067+	CVDG	R2, V2PACKED
00001944	E720 8F57 0006		00001157	1068+	VL	V2, V2PACKED
0000194A	E320 5018 0004		00001920	1069+	LG	R2, V3_16
00001950	E320 8F67 002E		00001167	1070+	CVDG	R2, V3PACKED
00001956	E730 8F67 0006		00001167	1071+	VL	V3, V3PACKED
0000195C	E612 3010 7073			1072+	VSP	V1, V2, V3, 7, 1
00001962	E710 8F08 000E		00001108	1073+	VST	V1, V10OUTPUT
00001968	B98D 0020			1074+	EPSW	R2, R0

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
0000196C	5020 8EE8		000010E8	1075+	ST	R2, CCPSW	to save CC
00001970	07FB			1076+	BR	R11	return
00001974				1077+RE16	DC	0F	
00001974				1078+	DROP	R5	
00001974	00000000 00000000			1079	DC	XL16' 0000000000000000000000000000000022C'	
0000197C	00000000 0000022C						
				1080			
				1081	VRI_F	VSP, - 10, - 12, 7, 1, 2	
00001988				1082+	DS	0FD	
00001988		00001988		1083+	USING	*, R5	base for test data and test routine
00001988	000019B8			1084+T17	DC	A(X17)	address of test routine
0000198C	0011			1085+	DC	H' 17'	test number
0000198E	00			1086+	DC	X' 00'	
0000198F	07			1087+	DC	HL1' 7'	i4
00001990	01			1088+	DC	HL1' 1'	m5
00001991	02			1089+	DC	HL1' 2'	cc
00001992	0D			1090+	DC	HL1' 13'	cc failed mask
00001998	FFFFFFFF FFFFFFFF6			1091+V2_17	DC	FD' - 10'	binary value for v2 packed decimal
000019A0	FFFFFFFF FFFFFFFF4			1092+V3_17	DC	FD' - 12'	binary value for v3 packed decimal
000019A8	E5E2D740 40404040			1093+	DC	CL8' VSP'	instruction name
000019B0	00000010			1094+	DC	A(16)	result length
000019B4	000019F4			1095+REA17	DC	A(RE17)	result address
				1096+*			INSTRUCTION UNDER TEST ROUTINE
000019B8				1097+X17	DS	0F	
000019B8	E320 5010 0004		00001998	1098+	LG	R2, V2_17	convert v2
000019BE	E320 8F57 002E		00001157	1099+	CVDG	R2, V2PACKED	
000019C4	E720 8F57 0006		00001157	1100+	VL	V2, V2PACKED	
000019CA	E320 5018 0004		000019A0	1101+	LG	R2, V3_17	convert v3
000019D0	E320 8F67 002E		00001167	1102+	CVDG	R2, V3PACKED	
000019D6	E730 8F67 0006		00001167	1103+	VL	V3, V3PACKED	
000019DC	E612 3010 7073			1104+	VSP	V1, V2, V3, 7, 1	test instruction
000019E2	E710 8F08 000E		00001108	1105+	VST	V1, V10UTPUT	save result
000019E8	B98D 0020			1106+	EPSW	R2, R0	exptract psw
000019EC	5020 8EE8		000010E8	1107+	ST	R2, CCPSW	to save CC
000019F0	07FB			1108+	BR	R11	return
000019F4				1109+RE17	DC	0F	
000019F4				1110+	DROP	R5	
000019F4	00000000 00000000			1111	DC	XL16' 000000000000000000000000000000002C'	
000019FC	00000000 0000002C						
				1112			
				1113	VRI_F	VSP, - 10, - 10, 7, 1, 0	
00001A08				1114+	DS	0FD	
00001A08		00001A08		1115+	USING	*, R5	base for test data and test routine
00001A08	00001A38			1116+T18	DC	A(X18)	address of test routine
00001A0C	0012			1117+	DC	H' 18'	test number
00001A0E	00			1118+	DC	X' 00'	
00001A0F	07			1119+	DC	HL1' 7'	i4
00001A10	01			1120+	DC	HL1' 1'	m5
00001A11	00			1121+	DC	HL1' 0'	cc
00001A12	07			1122+	DC	HL1' 7'	cc failed mask
00001A18	FFFFFFFF FFFFFFFF6			1123+V2_18	DC	FD' - 10'	binary value for v2 packed decimal
00001A20	FFFFFFFF FFFFFFFF6			1124+V3_18	DC	FD' - 10'	binary value for v3 packed decimal
00001A28	E5E2D740 40404040			1125+	DC	CL8' VSP'	instruction name
00001A30	00000010			1126+	DC	A(16)	result length
00001A34	00001A74			1127+REA18	DC	A(RE18)	result address
				1128+*			INSTRUCTION UNDER TEST ROUTINE

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
00001A38				1129+X18	DS	0F	
00001A38	E320 5010 0004		00001A18	1130+	LG	R2, V2_18	convert v2
00001A3E	E320 8F57 002E		00001157	1131+	CVDG	R2, V2PACKED	
00001A44	E720 8F57 0006		00001157	1132+	VL	V2, V2PACKED	
00001A4A	E320 5018 0004		00001A20	1133+	LG	R2, V3_18	convert v3
00001A50	E320 8F67 002E		00001167	1134+	CVDG	R2, V3PACKED	
00001A56	E730 8F67 0006		00001167	1135+	VL	V3, V3PACKED	
00001A5C	E612 3010 7073			1136+	VSP	V1, V2, V3, 7, 1	test instruction
00001A62	E710 8F08 000E		00001108	1137+	VST	V1, V10UTPUT	save result
00001A68	B98D 0020			1138+	EPSW	R2, R0	exptract psw
00001A6C	5020 8EE8		000010E8	1139+	ST	R2, CCPSW	to save CC
00001A70	07FB			1140+	BR	R11	return
00001A74				1141+RE18	DC	0F	
00001A74				1142+	DROP	R5	
00001A74	00000000 00000000			1143	DC	XL16' 00000000000000000000000000000000C'	
00001A7C	00000000 0000000C						
				1144			
				1145	VRI_F	VSP, +10000000000, +10, 135, 1, 3	i4=135(iom=1 & rdc=7)
00001A88				1146+	DS	0FD	
00001A88		00001A88		1147+	USING	*, R5	base for test data and test routine
00001A88	00001AB8			1148+T19	DC	A(X19)	address of test routine
00001A8C	0013			1149+	DC	H' 19'	test number
00001A8E	00			1150+	DC	X' 00'	
00001A8F	87			1151+	DC	HL1' 135'	i4
00001A90	01			1152+	DC	HL1' 1'	m5
00001A91	03			1153+	DC	HL1' 3'	cc
00001A92	0E			1154+	DC	HL1' 14'	cc failed mask
00001A98	00000002 540BE400			1155+V2_19	DC	FD' +10000000000'	binary value for v2 packed decimal
00001AA0	00000000 0000000A			1156+V3_19	DC	FD' +10'	binary value for v3 packed decimal
00001AA8	E5E2D740 40404040			1157+	DC	CL8' VSP'	instruction name
00001AB0	00000010			1158+	DC	A(16)	result length
00001AB4	00001AF4			1159+REA19	DC	A(RE19)	result address
				1160+*			INSTRUCTION UNDER TEST ROUTINE
00001AB8				1161+X19	DS	0F	
00001AB8	E320 5010 0004		00001A98	1162+	LG	R2, V2_19	convert v2
00001ABE	E320 8F57 002E		00001157	1163+	CVDG	R2, V2PACKED	
00001AC4	E720 8F57 0006		00001157	1164+	VL	V2, V2PACKED	
00001ACA	E320 5018 0004		00001AA0	1165+	LG	R2, V3_19	convert v3
00001AD0	E320 8F67 002E		00001167	1166+	CVDG	R2, V3PACKED	
00001AD6	E730 8F67 0006		00001167	1167+	VL	V3, V3PACKED	
00001ADC	E612 3018 7073			1168+	VSP	V1, V2, V3, 135, 1	test instruction
00001AE2	E710 8F08 000E		00001108	1169+	VST	V1, V10UTPUT	save result
00001AE8	B98D 0020			1170+	EPSW	R2, R0	exptract psw
00001AEC	5020 8EE8		000010E8	1171+	ST	R2, CCPSW	to save CC
00001AF0	07FB			1172+	BR	R11	return
00001AF4				1173+RE19	DC	0F	
00001AF4				1174+	DROP	R5	
00001AF4	00000000 00000000			1175	DC	XL16' 00000000000000000000000009999990C'	note RDC
00001AFC	00000000 9999990C						
				1176			
				1177	* VSP larger #'s , i4=159(iom=1 & rdc=31)		
				1178	VRI_F	VSP, +9999999999999999, +1, 159, 1, 2	
00001B08				1179+	DS	0FD	
00001B08		00001B08		1180+	USING	*, R5	base for test data and test routine
00001B08	00001B38			1181+T20	DC	A(X20)	address of test routine
00001B0C	0014			1182+	DC	H' 20'	test number

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
00001B0E	00			1183+	DC	X' 00'	
00001B0F	9F			1184+	DC	HL1' 159'	i4
00001B10	01			1185+	DC	HL1' 1'	m5
00001B11	02			1186+	DC	HL1' 2'	cc
00001B12	0D			1187+	DC	HL1' 13'	cc failed mask
				1188+V2_20	DC	FD' +9999999999999999' \	
00001B18	01634578 5D89FFFF			+			binary value for v2 packed decimal
00001B20	00000000 00000001			1189+V3_20	DC	FD' +1'	binary value for v3 packed decimal
00001B28	E5E2D740 40404040			1190+	DC	CL8' VSP'	instruction name
00001B30	00000010			1191+	DC	A(16)	result length
00001B34	00001B74			1192+REA20	DC	A(RE20)	result address
				1193+*			INSTRUCTION UNDER TEST ROUTINE
00001B38				1194+X20	DS	0F	
00001B38	E320 5010 0004		00001B18	1195+	LG	R2, V2_20	convert v2
00001B3E	E320 8F57 002E		00001157	1196+	CVDG	R2, V2PACKED	
00001B44	E720 8F57 0006		00001157	1197+	VL	V2, V2PACKED	
00001B4A	E320 5018 0004		00001B20	1198+	LG	R2, V3_20	convert v3
00001B50	E320 8F67 002E		00001167	1199+	CVDG	R2, V3PACKED	
00001B56	E730 8F67 0006		00001167	1200+	VL	V3, V3PACKED	
00001B5C	E612 3019 F073			1201+	VSP	V1, V2, V3, 159, 1	test instruction
00001B62	E710 8F08 000E		00001108	1202+	VST	V1, V10OUTPUT	save result
00001B68	B98D 0020			1203+	EPSW	R2, R0	exptract psw
00001B6C	5020 8EE8		000010E8	1204+	ST	R2, CCPSW	to save CC
00001B70	07FB			1205+	BR	R11	return
00001B74				1206+RE20	DC	0F	
00001B74				1207+	DROP	R5	
00001B74	00000000 00000099			1208	DC	XL16' 00000000000000009999999999999998C'	
00001B7C	99999999 9999998C						
				1209			
00001B88				1210	VRI_F	VSP, +9999999999999999, +1000000000000000, 159, 1, 2	
00001B88		00001B88		1211+	DS	0FD	
00001B88	00001BB8			1212+	USING	*, R5	base for test data and test routine
00001B8C	0015			1213+T21	DC	A(X21)	address of test routine
00001B8E	00			1214+	DC	H' 21'	test number
00001B8E	00			1215+	DC	X' 00'	
00001B8F	9F			1216+	DC	HL1' 159'	i4
00001B90	01			1217+	DC	HL1' 1'	m5
00001B91	02			1218+	DC	HL1' 2'	cc
00001B92	0D			1219+	DC	HL1' 13'	cc failed mask
				1220+V2_21	DC	FD' +9999999999999999' \	
00001B98	01634578 5D89FFFF			+			binary value for v2 packed decimal
				1221+V3_21	DC	FD' +1000000000000000' \	
00001BA0	002386F2 6FC10000			+			binary value for v3 packed decimal
00001BA8	E5E2D740 40404040			1222+	DC	CL8' VSP'	instruction name
00001BB0	00000010			1223+	DC	A(16)	result length
00001BB4	00001BF4			1224+REA21	DC	A(RE21)	result address
				1225+*			INSTRUCTION UNDER TEST ROUTINE
00001BB8				1226+X21	DS	0F	
00001BB8	E320 5010 0004		00001B98	1227+	LG	R2, V2_21	convert v2
00001BBE	E320 8F57 002E		00001157	1228+	CVDG	R2, V2PACKED	
00001BC4	E720 8F57 0006		00001157	1229+	VL	V2, V2PACKED	
00001BCA	E320 5018 0004		00001BA0	1230+	LG	R2, V3_21	convert v3
00001BD0	E320 8F67 002E		00001167	1231+	CVDG	R2, V3PACKED	
00001BD6	E730 8F67 0006		00001167	1232+	VL	V3, V3PACKED	
00001BDC	E612 3019 F073			1233+	VSP	V1, V2, V3, 159, 1	test instruction
00001BE2	E710 8F08 000E		00001108	1234+	VST	V1, V10OUTPUT	save result

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
00001BE8	B98D 0020			1235+	EPSW	R2, R0	exptract psw
00001BEC	5020 8EE8		000010E8	1236+	ST	R2, CCPSW	to save CC
00001BF0	07FB			1237+	BR	R11	return
00001BF4				1238+RE21	DC	0F	
00001BF4				1239+	DROP	R5	
00001BF4	00000000 00000089			1240	DC	XL16' 0000000000000000899999999999999C'	
00001BFC	99999999 9999999C						
				1241			
				1242	VRI_F	VSP, - 9999999999999999, - 1, 159, 1, 1	
00001C08				1243+	DS	0FD	
00001C08		00001C08		1244+	USING	*, R5	base for test data and test routine
00001C08	00001C38			1245+T22	DC	A(X22)	address of test routine
00001C0C	0016			1246+	DC	H' 22'	test number
00001C0E	00			1247+	DC	X' 00'	
00001C0F	9F			1248+	DC	HL1' 159'	i4
00001C10	01			1249+	DC	HL1' 1'	m5
00001C11	01			1250+	DC	HL1' 1'	cc
00001C12	0B			1251+	DC	HL1' 11'	cc failed mask
				1252+V2_22	DC	FD' - 9999999999999999' \	
00001C18	FFDC790D 903F0001			+			binary value for v2 packed decimal
00001C20	FFFFFFFF FFFFFFFF			1253+V3_22	DC	FD' - 1'	binary value for v3 packed decimal
00001C28	E5E2D740 40404040			1254+	DC	CL8' VSP'	instruction name
00001C30	00000010			1255+	DC	A(16)	result length
00001C34	00001C74			1256+REA22	DC	A(RE22)	result address
				1257+*			INSTRUCTION UNDER TEST ROUTINE
00001C38				1258+X22	DS	0F	
00001C38	E320 5010 0004		00001C18	1259+	LG	R2, V2_22	convert v2
00001C3E	E320 8F57 002E		00001157	1260+	CVDG	R2, V2PACKED	
00001C44	E720 8F57 0006		00001157	1261+	VL	V2, V2PACKED	
00001C4A	E320 5018 0004		00001C20	1262+	LG	R2, V3_22	convert v3
00001C50	E320 8F67 002E		00001167	1263+	CVDG	R2, V3PACKED	
00001C56	E730 8F67 0006		00001167	1264+	VL	V3, V3PACKED	
00001C5C	E612 3019 F073			1265+	VSP	V1, V2, V3, 159, 1	test instruction
00001C62	E710 8F08 000E		00001108	1266+	VST	V1, V10UTPUT	save result
00001C68	B98D 0020			1267+	EPSW	R2, R0	exptract psw
00001C6C	5020 8EE8		000010E8	1268+	ST	R2, CCPSW	to save CC
00001C70	07FB			1269+	BR	R11	return
00001C74				1270+RE22	DC	0F	
00001C74				1271+	DROP	R5	
00001C74	00000000 00000009			1272	DC	XL16' 0000000000000000999999999999998D'	
00001C7C	99999999 9999998D						
				1273			
				1274	VRI_F	VSP, - 9999999999999999, - 1, 135, 1, 3 i4=135(iom=1 & rdc=7)	
00001C88				1275+	DS	0FD	
00001C88		00001C88		1276+	USING	*, R5	base for test data and test routine
00001C88	00001CB8			1277+T23	DC	A(X23)	address of test routine
00001C8C	0017			1278+	DC	H' 23'	test number
00001C8E	00			1279+	DC	X' 00'	
00001C8F	87			1280+	DC	HL1' 135'	i4
00001C90	01			1281+	DC	HL1' 1'	m5
00001C91	03			1282+	DC	HL1' 3'	cc
00001C92	0E			1283+	DC	HL1' 14'	cc failed mask
				1284+V2_23	DC	FD' - 9999999999999999' \	
00001C98	FFDC790D 903F0001			+			binary value for v2 packed decimal
00001CA0	FFFFFFFF FFFFFFFF			1285+V3_23	DC	FD' - 1'	binary value for v3 packed decimal
00001CA8	E5E2D740 40404040			1286+	DC	CL8' VSP'	instruction name

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
00001CB0	00000010			1287+	DC	A(16)	result length
00001CB4	00001CF4			1288+REA23	DC	A(RE23)	result address
				1289+*			INSTRUCTION UNDER TEST ROUTINE
00001CB8				1290+X23	DS	0F	
00001CB8	E320 5010 0004		00001C98	1291+	LG	R2, V2_23	convert v2
00001CBE	E320 8F57 002E		00001157	1292+	CVDG	R2, V2PACKED	
00001CC4	E720 8F57 0006		00001157	1293+	VL	V2, V2PACKED	
00001CCA	E320 5018 0004		00001CA0	1294+	LG	R2, V3_23	convert v3
00001CD0	E320 8F67 002E		00001167	1295+	CVDG	R2, V3PACKED	
00001CD6	E730 8F67 0006		00001167	1296+	VL	V3, V3PACKED	
00001CDC	E612 3018 7073			1297+	VSP	V1, V2, V3, 135, 1	test instruction
00001CE2	E710 8F08 000E		00001108	1298+	VST	V1, V10UTPUT	save result
00001CE8	B98D 0020			1299+	EPSW	R2, R0	exptract psw
00001CEC	5020 8EE8		000010E8	1300+	ST	R2, CCPSW	to save CC
00001CF0	07FB			1301+	BR	R11	return
00001CF4				1302+RE23	DC	0F	
00001CF4				1303+	DROP	R5	
00001CF4	00000000 00000000			1304	DC	XL16' 00000000000000000000000009999998D'	
00001CFC	00000000 9999998D						
				1305			
				1306 * VSP larger #'s , i4=159(iom=1 & rdc=31)			CS=1 for all m5
				1307 * check forced positive			
				1308 VRI_F VSP, - 9999999999999999, +1, 159, 9, 2			m5=9(P2=1)
00001D08				1309+	DS	0FD	
00001D08		00001D08		1310+	USING	*, R5	base for test data and test routine
00001D08	00001D38			1311+T24	DC	A(X24)	address of test routine
00001D0C	0018			1312+	DC	H' 24'	test number
00001D0E	00			1313+	DC	X' 00'	
00001D0F	9F			1314+	DC	HL1' 159'	i4
00001D10	09			1315+	DC	HL1' 9'	m5
00001D11	02			1316+	DC	HL1' 2'	cc
00001D12	0D			1317+	DC	HL1' 13'	cc failed mask
				1318+V2_24	DC	FD' - 9999999999999999' \	
00001D18	FE9CBA87 A2760001			+			binary value for v2 packed decimal
00001D20	00000000 00000001			1319+V3_24	DC	FD' +1'	binary value for v3 packed decimal
00001D28	E5E2D740 40404040			1320+	DC	CL8' VSP'	instruction name
00001D30	00000010			1321+	DC	A(16)	result length
00001D34	00001D74			1322+REA24	DC	A(RE24)	result address
				1323+*			INSTRUCTION UNDER TEST ROUTINE
00001D38				1324+X24	DS	0F	
00001D38	E320 5010 0004		00001D18	1325+	LG	R2, V2_24	convert v2
00001D3E	E320 8F57 002E		00001157	1326+	CVDG	R2, V2PACKED	
00001D44	E720 8F57 0006		00001157	1327+	VL	V2, V2PACKED	
00001D4A	E320 5018 0004		00001D20	1328+	LG	R2, V3_24	convert v3
00001D50	E320 8F67 002E		00001167	1329+	CVDG	R2, V3PACKED	
00001D56	E730 8F67 0006		00001167	1330+	VL	V3, V3PACKED	
00001D5C	E612 3099 F073			1331+	VSP	V1, V2, V3, 159, 9	test instruction
00001D62	E710 8F08 000E		00001108	1332+	VST	V1, V10UTPUT	save result
00001D68	B98D 0020			1333+	EPSW	R2, R0	exptract psw
00001D6C	5020 8EE8		000010E8	1334+	ST	R2, CCPSW	to save CC
00001D70	07FB			1335+	BR	R11	return
00001D74				1336+RE24	DC	0F	
00001D74				1337+	DROP	R5	
00001D74	00000000 00000099			1338	DC	XL16' 00000000000000000999999999999998C'	
00001D7C	99999999 9999998C						
				1339			

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
00001D88				1340	VRI_F VSP, - 9999999999999999, - 1000000000000000, 159, 13, 2	
00001D88		00001D88		1341+	DS OFD	
00001D88	00001DB8			1342+	USING *, R5	base for test data and test routine
00001D8C	0019			1343+T25	DC A(X25)	address of test routine
00001D8E	00			1344+	DC H' 25'	test number
00001D8F	9F			1345+	DC X' 00'	
00001D90	0D			1346+	DC HL1' 159'	i4
00001D91	02			1347+	DC HL1' 13'	m5
00001D92	0D			1348+	DC HL1' 2'	cc
				1349+	DC HL1' 13'	cc failed mask
00001D98	FE9CBA87 A2760001			1350+V2_25	DC FD' - 9999999999999999' \	
				+		binary value for v2 packed decimal
00001DA0	FFDC790D 903F0000			1351+V3_25	DC FD' - 1000000000000000' \	
00001DA8	E5E2D740 40404040			+		binary value for v3 packed decimal
00001DB0	00000010			1352+	DC CL8' VSP'	instruction name
00001DB4	00001DF4			1353+	DC A(16)	result length
				1354+REA25	DC A(RE25)	result address
				1355+*		INSTRUCTION UNDER TEST ROUTINE
00001DB8				1356+X25	DS OF	
00001DB8	E320 5010 0004	00001D98		1357+	LG R2, V2_25	convert v2
00001DBE	E320 8F57 002E	00001157		1358+	CVDG R2, V2PACKED	
00001DC4	E720 8F57 0006	00001157		1359+	VL V2, V2PACKED	
00001DCA	E320 5018 0004	00001DA0		1360+	LG R2, V3_25	convert v3
00001DD0	E320 8F67 002E	00001167		1361+	CVDG R2, V3PACKED	
00001DD6	E730 8F67 0006	00001167		1362+	VL V3, V3PACKED	
00001DDC	E612 30D9 F073			1363+	VSP V1, V2, V3, 159, 13	test instruction
00001DE2	E710 8F08 000E	00001108		1364+	VST V1, V10UTPUT	save result
00001DE8	B98D 0020			1365+	EPSW R2, R0	exptract psw
00001DEC	5020 8EE8	000010E8		1366+	ST R2, CCPSW	to save CC
00001DF0	07FB			1367+	BR R11	return
00001DF4				1368+RE25	DC OF	
00001DF4				1369+	DROP R5	
00001DF4	00000000 00000089			1370	DC XL16' 00000000000000008999999999999999C' m5=13(P2=1, P3=1)	
00001DFC	99999999 9999999C					
				1371		
00001E08				1372	VRI_F VSP, - 9999999999999999, - 1, 159, 3, 2	m5=3(P1=1)
00001E08		00001E08		1373+	DS OFD	
00001E08	00001E38			1374+	USING *, R5	base for test data and test routine
00001E0C	001A			1375+T26	DC A(X26)	address of test routine
00001E0E	00			1376+	DC H' 26'	test number
00001E0F	9F			1377+	DC X' 00'	
00001E10	03			1378+	DC HL1' 159'	i4
00001E11	02			1379+	DC HL1' 3'	m5
00001E12	0D			1380+	DC HL1' 2'	cc
				1381+	DC HL1' 13'	cc failed mask
00001E18	FFDC790D 903F0001			1382+V2_26	DC FD' - 9999999999999999' \	
				+		binary value for v2 packed decimal
00001E20	FFFFFFFF FFFFFFFF			1383+V3_26	DC FD' - 1'	binary value for v3 packed decimal
00001E28	E5E2D740 40404040			1384+	DC CL8' VSP'	instruction name
00001E30	00000010			1385+	DC A(16)	result length
00001E34	00001E74			1386+REA26	DC A(RE26)	result address
				1387+*		INSTRUCTION UNDER TEST ROUTINE
00001E38				1388+X26	DS OF	
00001E38	E320 5010 0004	00001E18		1389+	LG R2, V2_26	convert v2
00001E3E	E320 8F57 002E	00001157		1390+	CVDG R2, V2PACKED	
00001E44	E720 8F57 0006	00001157		1391+	VL V2, V2PACKED	

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
00001E4A	E320 5018 0004		00001E20	1392+	LG	R2, V3_26	convert v3
00001E50	E320 8F67 002E		00001167	1393+	CVDG	R2, V3PACKED	
00001E56	E730 8F67 0006		00001167	1394+	VL	V3, V3PACKED	
00001E5C	E612 3039 F073			1395+	VSP	V1, V2, V3, 159, 3	test instruction
00001E62	E710 8F08 000E		00001108	1396+	VST	V1, V10UTPUT	save result
00001E68	B98D 0020			1397+	EPSW	R2, R0	exptract psw
00001E6C	5020 8EE8		000010E8	1398+	ST	R2, CCPSW	to save CC
00001E70	07FB			1399+	BR	R11	return
00001E74				1400+RE26	DC	0F	
00001E74				1401+	DROP	R5	
00001E74	00000000 00000009			1402	DC	XL16' 0000000000000000099999999999998F'	
00001E7C	99999999 9999998F						
				1403			
				1404	VRI_F	VSP, - 9999999999999999, - 1, 135, 3, 3	i4=135(iom=1 & rdc=7)
00001E88				1405+	DS	0FD	
00001E88		00001E88		1406+	USING	*, R5	base for test data and test routine
00001E88	00001EB8			1407+T27	DC	A(X27)	address of test routine
00001E8C	001B			1408+	DC	H' 27'	test number
00001E8E	00			1409+	DC	X' 00'	
00001E8F	87			1410+	DC	HL1' 135'	i4
00001E90	03			1411+	DC	HL1' 3'	m5
00001E91	03			1412+	DC	HL1' 3'	cc
00001E92	0E			1413+	DC	HL1' 14'	cc failed mask
				1414+V2_27	DC	FD' - 9999999999999999' \	
00001E98	FFDC790D 903F0001			+			binary value for v2 packed decimal
00001EA0	FFFFFFFF FFFFFFFF			1415+V3_27	DC	FD' - 1'	binary value for v3 packed decimal
00001EA8	E5E2D740 40404040			1416+	DC	CL8' VSP'	instruction name
00001EB0	00000010			1417+	DC	A(16)	result length
00001EB4	00001EF4			1418+REA27	DC	A(RE27)	result address
				1419+*			INSTRUCTION UNDER TEST ROUTINE
00001EB8				1420+X27	DS	0F	
00001EB8	E320 5010 0004		00001E98	1421+	LG	R2, V2_27	convert v2
00001EBE	E320 8F57 002E		00001157	1422+	CVDG	R2, V2PACKED	
00001EC4	E720 8F57 0006		00001157	1423+	VL	V2, V2PACKED	
00001ECA	E320 5018 0004		00001EA0	1424+	LG	R2, V3_27	convert v3
00001ED0	E320 8F67 002E		00001167	1425+	CVDG	R2, V3PACKED	
00001ED6	E730 8F67 0006		00001167	1426+	VL	V3, V3PACKED	
00001EDC	E612 3038 7073			1427+	VSP	V1, V2, V3, 135, 3	test instruction
00001EE2	E710 8F08 000E		00001108	1428+	VST	V1, V10UTPUT	save result
00001EE8	B98D 0020			1429+	EPSW	R2, R0	exptract psw
00001EEC	5020 8EE8		000010E8	1430+	ST	R2, CCPSW	to save CC
00001EF0	07FB			1431+	BR	R11	return
00001EF4				1432+RE27	DC	0F	
00001EF4				1433+	DROP	R5	
00001EF4	00000000 00000000			1434	DC	XL16' 0000000000000000000000009999998F'	m5=3(P1=1)
00001EFC	00000000 9999998F						
				1435			
				1436 *			
				1437 * VMP		- VECTOR MULTIPLY DECIMAL	
				1438 *			
				1439 * VMP simple		+ CC checks	
				1440	VRI_F	VMP, +10, +12, 7, 1, 2	
00001F08				1441+	DS	0FD	
00001F08		00001F08		1442+	USING	*, R5	base for test data and test routine
00001F08	00001F38			1443+T28	DC	A(X28)	address of test routine
00001F0C	001C			1444+	DC	H' 28'	test number

[illegible]

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
00001FF4				1500+RE29	DC	0F
00001FF4				1501+	DROP	R5
00001FF4	00000000 00000000			1502	DC	XL16' 0000000000000000000000000000120D'
00001FFC	00000000 0000120D					
				1503		
				1504	VRI_F	VMP, +10, - 12, 1, 1, 3 note rdc=1
00002008				1505+	DS	0FD
00002008		00002008		1506+	USING	*, R5 base for test data and test routine
00002008	00002038			1507+T30	DC	A(X30) address of test routine
0000200C	001E			1508+	DC	H' 30' test number
0000200E	00			1509+	DC	X' 00'
0000200F	01			1510+	DC	HL1' 1' i4
00002010	01			1511+	DC	HL1' 1' m5
00002011	03			1512+	DC	HL1' 3' cc
00002012	0E			1513+	DC	HL1' 14' cc failed mask
00002018	00000000 0000000A			1514+V2_30	DC	FD' +10' binary value for v2 packed decimal
00002020	FFFFFFFF FFFFFFFF4			1515+V3_30	DC	FD' - 12' binary value for v3 packed decimal
00002028	E5D4D740 40404040			1516+	DC	CL8' VMP' instruction name
00002030	00000010			1517+	DC	A(16) result length
00002034	00002074			1518+REA30	DC	A(RE30) result address
				1519+*		INSTRUCTION UNDER TEST ROUTINE
00002038				1520+X30	DS	0F
00002038	E320 5010 0004		00002018	1521+	LG	R2, V2_30 convert v2
0000203E	E320 8F57 002E		00001157	1522+	CVDG	R2, V2PACKED
00002044	E720 8F57 0006		00001157	1523+	VL	V2, V2PACKED
0000204A	E320 5018 0004		00002020	1524+	LG	R2, V3_30 convert v3
00002050	E320 8F67 002E		00001167	1525+	CVDG	R2, V3PACKED
00002056	E730 8F67 0006		00001167	1526+	VL	V3, V3PACKED
0000205C	E612 3010 1078			1527+	VMP	V1, V2, V3, 1, 1 test instruction
00002062	E710 8F08 000E		00001108	1528+	VST	V1, V10UTPUT save result
00002068	B98D 0020			1529+	EPSW	R2, R0 exptract psw
0000206C	5020 8EE8		000010E8	1530+	ST	R2, CCPSW to save CC
00002070	07FB			1531+	BR	R11 return
00002074				1532+RE30	DC	0F
00002074				1533+	DROP	R5
00002074	00000000 00000000			1534	DC	XL16' 000000000000000000000000000000C'
0000207C	00000000 0000000C					
				1535		
				1536	VRI_F	VMP, +10, - 12, 7, 1, 1
00002088				1537+	DS	0FD
00002088		00002088		1538+	USING	*, R5 base for test data and test routine
00002088	000020B8			1539+T31	DC	A(X31) address of test routine
0000208C	001F			1540+	DC	H' 31' test number
0000208E	00			1541+	DC	X' 00'
0000208F	07			1542+	DC	HL1' 7' i4
00002090	01			1543+	DC	HL1' 1' m5
00002091	01			1544+	DC	HL1' 1' cc
00002092	0B			1545+	DC	HL1' 11' cc failed mask
00002098	00000000 0000000A			1546+V2_31	DC	FD' +10' binary value for v2 packed decimal
000020A0	FFFFFFFF FFFFFFFF4			1547+V3_31	DC	FD' - 12' binary value for v3 packed decimal
000020A8	E5D4D740 40404040			1548+	DC	CL8' VMP' instruction name
000020B0	00000010			1549+	DC	A(16) result length
000020B4	000020F4			1550+REA31	DC	A(RE31) result address
				1551+*		INSTRUCTION UNDER TEST ROUTINE
000020B8				1552+X31	DS	0F
000020B8	E320 5010 0004		00002098	1553+	LG	R2, V2_31 convert v2

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
000020BE	E320 8F57 002E		00001157	1554+	CVDG	R2, V2PACKED
000020C4	E720 8F57 0006		00001157	1555+	VL	V2, V2PACKED
000020CA	E320 5018 0004		000020A0	1556+	LG	R2, V3_31
000020D0	E320 8F67 002E		00001167	1557+	CVDG	R2, V3PACKED
000020D6	E730 8F67 0006		00001167	1558+	VL	V3, V3PACKED
000020DC	E612 3010 7078			1559+	VMP	V1, V2, V3, 7, 1
000020E2	E710 8F08 000E		00001108	1560+	VST	V1, V10UTPUT
000020E8	B98D 0020			1561+	EPSW	R2, R0
000020EC	5020 8EE8		000010E8	1562+	ST	R2, CCPSW
000020F0	07FB			1563+	BR	R11
000020F4				1564+RE31	DC	0F
000020F4				1565+	DROP	R5
000020F4	00000000 00000000			1566	DC	XL16' 00000000000000000000000000000000120D'
000020FC	00000000 0000120D					
				1567		
				1568	VRI_F	VMP, - 10, - 12, 7, 1, 2
00002108				1569+	DS	0FD
00002108		00002108		1570+	USING	*, R5
00002108	00002138			1571+T32	DC	A(X32)
0000210C	0020			1572+	DC	H' 32'
0000210E	00			1573+	DC	X' 00'
0000210F	07			1574+	DC	HL1' 7'
00002110	01			1575+	DC	HL1' 1'
00002111	02			1576+	DC	HL1' 2'
00002112	0D			1577+	DC	HL1' 13'
00002118	FFFFFFFF FFFFFFFF6			1578+V2_32	DC	FD' - 10'
00002120	FFFFFFFF FFFFFFFF4			1579+V3_32	DC	FD' - 12'
00002128	E5D4D740 40404040			1580+	DC	CL8' VMP'
00002130	00000010			1581+	DC	A(16)
00002134	00002174			1582+REA32	DC	A(RE32)
				1583+*		INSTRUCTION UNDER TEST ROUTINE
00002138				1584+X32	DS	0F
00002138	E320 5010 0004		00002118	1585+	LG	R2, V2_32
0000213E	E320 8F57 002E		00001157	1586+	CVDG	R2, V2PACKED
00002144	E720 8F57 0006		00001157	1587+	VL	V2, V2PACKED
0000214A	E320 5018 0004		00002120	1588+	LG	R2, V3_32
00002150	E320 8F67 002E		00001167	1589+	CVDG	R2, V3PACKED
00002156	E730 8F67 0006		00001167	1590+	VL	V3, V3PACKED
0000215C	E612 3010 7078			1591+	VMP	V1, V2, V3, 7, 1
00002162	E710 8F08 000E		00001108	1592+	VST	V1, V10UTPUT
00002168	B98D 0020			1593+	EPSW	R2, R0
0000216C	5020 8EE8		000010E8	1594+	ST	R2, CCPSW
00002170	07FB			1595+	BR	R11
00002174				1596+RE32	DC	0F
00002174				1597+	DROP	R5
00002174	00000000 00000000			1598	DC	XL16' 00000000000000000000000000000000120C'
0000217C	00000000 0000120C					
				1599		
				1600	VRI_F	VMP, - 10, - 10, 7, 1, 2
00002188				1601+	DS	0FD
00002188		00002188		1602+	USING	*, R5
00002188	000021B8			1603+T33	DC	A(X33)
0000218C	0021			1604+	DC	H' 33'
0000218E	00			1605+	DC	X' 00'
0000218F	07			1606+	DC	HL1' 7'
00002190	01			1607+	DC	HL1' 1'

LOC	OBJECT CODE	ADDR1	ADDR2	STMT	
0000227C	00000000 0000100C			1663	
				1664 * VMP larger #'s , i4=159(iom=1 & rdc=31)	
00002288				1665 VRI_F VMP, +9999999999999999, +1, 159, 1, 2	
00002288		00002288		1666+ DS OFD	
00002288	000022B8			1667+ USING *, R5	base for test data and test routine
0000228C	0023			1668+T35 DC A(X35)	address of test routine
0000228E	00			1669+ DC H' 35'	test number
0000228F	9F			1670+ DC X' 00'	
00002290	01			1671+ DC HL1' 159'	i4
00002291	02			1672+ DC HL1' 1'	m5
00002292	0D			1673+ DC HL1' 2'	cc
				1674+ DC HL1' 13'	cc failed mask
				1675+V2_35 DC FD' +9999999999999999' \	
00002298	01634578 5D89FFFF			+	binary value for v2 packed decimal
000022A0	00000000 00000001			1676+V3_35 DC FD' +1'	binary value for v3 packed decimal
000022A8	E5D4D740 40404040			1677+ DC CL8' VMP'	instruction name
000022B0	00000010			1678+ DC A(16)	result length
000022B4	000022F4			1679+REA35 DC A(RE35)	result address
				1680+*	INSTRUCTION UNDER TEST ROUTINE
000022B8				1681+X35 DS OF	
000022B8	E320 5010 0004	00002298		1682+ LG R2, V2_35	convert v2
000022BE	E320 8F57 002E	00001157		1683+ CVDG R2, V2PACKED	
000022C4	E720 8F57 0006	00001157		1684+ VL V2, V2PACKED	
000022CA	E320 5018 0004	000022A0		1685+ LG R2, V3_35	convert v3
000022D0	E320 8F67 002E	00001167		1686+ CVDG R2, V3PACKED	
000022D6	E730 8F67 0006	00001167		1687+ VL V3, V3PACKED	
000022DC	E612 3019 F078			1688+ VMP V1, V2, V3, 159, 1	test instruction
000022E2	E710 8F08 000E	00001108		1689+ VST V1, V10UTPUT	save result
000022E8	B98D 0020			1690+ EPSW R2, R0	exptract psw
000022EC	5020 8EE8	000010E8		1691+ ST R2, CCPSW	to save CC
000022F0	07FB			1692+ BR R11	return
000022F4				1693+RE35 DC OF	
000022F4				1694+ DROP R5	
000022F4	00000000 00000099			1695 DC XL16' 00000000000000009999999999999999C'	
000022FC	99999999 9999999C				
				1696	
				1697 VRI_F VMP, +9999999999999999, +1000000000000000, 159, 1, 3	
00002308				1698+ DS OFD	
00002308		00002308		1699+ USING *, R5	base for test data and test routine
00002308	00002338			1700+T36 DC A(X36)	address of test routine
0000230C	0024			1701+ DC H' 36'	test number
0000230E	00			1702+ DC X' 00'	
0000230F	9F			1703+ DC HL1' 159'	i4
00002310	01			1704+ DC HL1' 1'	m5
00002311	03			1705+ DC HL1' 3'	cc
00002312	0E			1706+ DC HL1' 14'	cc failed mask
				1707+V2_36 DC FD' +9999999999999999' \	
00002318	01634578 5D89FFFF			+	binary value for v2 packed decimal
				1708+V3_36 DC FD' +1000000000000000' \	
				+	binary value for v3 packed decimal
00002320	002386F2 6FC10000				instruction name
00002328	E5D4D740 40404040			1709+ DC CL8' VMP'	result length
00002330	00000010			1710+ DC A(16)	result address
00002334	00002374			1711+REA36 DC A(RE36)	INSTRUCTION UNDER TEST ROUTINE
				1712+*	
00002338				1713+X36 DS OF	

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
00002338	E320 5010 0004		00002318	1714+	LG	R2, V2_36	convert v2
0000233E	E320 8F57 002E		00001157	1715+	CVDG	R2, V2PACKED	
00002344	E720 8F57 0006		00001157	1716+	VL	V2, V2PACKED	
0000234A	E320 5018 0004		00002320	1717+	LG	R2, V3_36	convert v3
00002350	E320 8F67 002E		00001167	1718+	CVDG	R2, V3PACKED	
00002356	E730 8F67 0006		00001167	1719+	VL	V3, V3PACKED	
0000235C	E612 3019 F078			1720+	VMP	V1, V2, V3, 159, 1	test instruction
00002362	E710 8F08 000E		00001108	1721+	VST	V1, V10UTPUT	save result
00002368	B98D 0020			1722+	EPSW	R2, R0	exptract psw
0000236C	5020 8EE8		000010E8	1723+	ST	R2, CCPSW	to save CC
00002370	07FB			1724+	BR	R11	return
00002374				1725+RE36	DC	0F	
00002374				1726+	DROP	R5	
00002374	99999999 99999990			1727	DC	XL16' 99999999999999990000000000000000C'	overflowed
0000237C	00000000 0000000C						
				1728			
				1729	VRI_F	VMP, - 9999999999999999, - 1, 159, 1, 2	
00002388				1730+	DS	0FD	
00002388		00002388		1731+	USING	*, R5	base for test data and test routine
00002388	000023B8			1732+T37	DC	A(X37)	address of test routine
0000238C	0025			1733+	DC	H' 37'	test number
0000238E	00			1734+	DC	X' 00'	
0000238F	9F			1735+	DC	HL1' 159'	i4
00002390	01			1736+	DC	HL1' 1'	m5
00002391	02			1737+	DC	HL1' 2'	cc
00002392	0D			1738+	DC	HL1' 13'	cc failed mask
				1739+V2_37	DC	FD' - 9999999999999999' \	
00002398	FFDC790D 903F0001			+			binary value for v2 packed decimal
000023A0	FFFFFFFF FFFFFFFF			1740+V3_37	DC	FD' - 1'	binary value for v3 packed decimal
000023A8	E5D4D740 40404040			1741+	DC	CL8' VMP'	instruction name
000023B0	00000010			1742+	DC	A(16)	result length
000023B4	000023F4			1743+REA37	DC	A(RE37)	result address
				1744+*			INSTRUCTION UNDER TEST ROUTINE
000023B8				1745+X37	DS	0F	
000023B8	E320 5010 0004		00002398	1746+	LG	R2, V2_37	convert v2
000023BE	E320 8F57 002E		00001157	1747+	CVDG	R2, V2PACKED	
000023C4	E720 8F57 0006		00001157	1748+	VL	V2, V2PACKED	
000023CA	E320 5018 0004		000023A0	1749+	LG	R2, V3_37	convert v3
000023D0	E320 8F67 002E		00001167	1750+	CVDG	R2, V3PACKED	
000023D6	E730 8F67 0006		00001167	1751+	VL	V3, V3PACKED	
000023DC	E612 3019 F078			1752+	VMP	V1, V2, V3, 159, 1	test instruction
000023E2	E710 8F08 000E		00001108	1753+	VST	V1, V10UTPUT	save result
000023E8	B98D 0020			1754+	EPSW	R2, R0	exptract psw
000023EC	5020 8EE8		000010E8	1755+	ST	R2, CCPSW	to save CC
000023F0	07FB			1756+	BR	R11	return
000023F4				1757+RE37	DC	0F	
000023F4				1758+	DROP	R5	
000023F4	00000000 00000009			1759	DC	XL16' 0000000000000000999999999999999C'	
000023FC	99999999 9999999C						
				1760			
				1761	VRI_F	VMP, - 9999999999999999, - 1, 135, 1, 3 i4=135(iom=1 & rdc=7)	
00002408				1762+	DS	0FD	
00002408		00002408		1763+	USING	*, R5	base for test data and test routine
00002408	00002438			1764+T38	DC	A(X38)	address of test routine
0000240C	0026			1765+	DC	H' 38'	test number
0000240E	00			1766+	DC	X' 00'	

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
0000240F	87			1767+	DC	HL1' 135'	i4
00002410	01			1768+	DC	HL1' 1'	m5
00002411	03			1769+	DC	HL1' 3'	cc
00002412	0E			1770+	DC	HL1' 14'	cc failed mask
				1771+V2_38	DC	FD' - 9999999999999999' \	
00002418	FFDC790D 903F0001			+			binary value for v2 packed decimal
00002420	FFFFFFFF FFFFFFFF			1772+V3_38	DC	FD' - 1'	binary value for v3 packed decimal
00002428	E5D4D740 40404040			1773+	DC	CL8' VMP'	instruction name
00002430	00000010			1774+	DC	A(16)	result length
00002434	00002474			1775+REA38	DC	A(RE38)	result address
				1776+*			INSTRUCTION UNDER TEST ROUTINE
00002438				1777+X38	DS	0F	
00002438	E320 5010 0004		00002418	1778+	LG	R2, V2_38	convert v2
0000243E	E320 8F57 002E		00001157	1779+	CVDG	R2, V2PACKED	
00002444	E720 8F57 0006		00001157	1780+	VL	V2, V2PACKED	
0000244A	E320 5018 0004		00002420	1781+	LG	R2, V3_38	convert v3
00002450	E320 8F67 002E		00001167	1782+	CVDG	R2, V3PACKED	
00002456	E730 8F67 0006		00001167	1783+	VL	V3, V3PACKED	
0000245C	E612 3018 7078			1784+	VMP	V1, V2, V3, 135, 1	test instruction
00002462	E710 8F08 000E		00001108	1785+	VST	V1, V10UTPUT	save result
00002468	B98D 0020			1786+	EPSW	R2, R0	exptract psw
0000246C	5020 8EE8		000010E8	1787+	ST	R2, CCPSW	to save CC
00002470	07FB			1788+	BR	R11	return
00002474				1789+RE38	DC	0F	
00002474				1790+	DROP	R5	
00002474	00000000 00000000			1791	DC	XL16' 00000000000000000000000009999999C'	overflow RDC
0000247C	00000000 9999999C						
				1792			
				1793	VRI_F	VMP, +9999999999999999, +10000000000000, 159, 1, 2	
00002488				1794+	DS	0FD	
00002488		00002488		1795+	USING	*, R5	base for test data and test routine
00002488	000024B8			1796+T39	DC	A(X39)	address of test routine
0000248C	0027			1797+	DC	H' 39'	test number
0000248E	00			1798+	DC	X' 00'	
0000248F	9F			1799+	DC	HL1' 159'	i4
00002490	01			1800+	DC	HL1' 1'	m5
00002491	02			1801+	DC	HL1' 2'	cc
00002492	0D			1802+	DC	HL1' 13'	cc failed mask
				1803+V2_39	DC	FD' +9999999999999999' \	
00002498	00000918 4E729FFF			+			binary value for v2 packed decimal
				1804+V3_39	DC	FD' +100000000000000' \	
000024A0	00000918 4E72A000			+			binary value for v3 packed decimal
000024A8	E5D4D740 40404040			1805+	DC	CL8' VMP'	instruction name
000024B0	00000010			1806+	DC	A(16)	result length
000024B4	000024F4			1807+REA39	DC	A(RE39)	result address
				1808+*			INSTRUCTION UNDER TEST ROUTINE
000024B8				1809+X39	DS	0F	
000024B8	E320 5010 0004		00002498	1810+	LG	R2, V2_39	convert v2
000024BE	E320 8F57 002E		00001157	1811+	CVDG	R2, V2PACKED	
000024C4	E720 8F57 0006		00001157	1812+	VL	V2, V2PACKED	
000024CA	E320 5018 0004		000024A0	1813+	LG	R2, V3_39	convert v3
000024D0	E320 8F67 002E		00001167	1814+	CVDG	R2, V3PACKED	
000024D6	E730 8F67 0006		00001167	1815+	VL	V3, V3PACKED	
000024DC	E612 3019 F078			1816+	VMP	V1, V2, V3, 159, 1	test instruction
000024E2	E710 8F08 000E		00001108	1817+	VST	V1, V10UTPUT	save result
000024E8	B98D 0020			1818+	EPSW	R2, R0	exptract psw

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
000024EC	5020 8EE8		000010E8	1819+	ST	R2, CCPSW	to save CC
000024F0	07FB			1820+	BR	R11	return
000024F4				1821+RE39	DC	0F	
000024F4				1822+	DROP	R5	
000024F4	00000999 99999999			1823	DC	XL16' 000009999999999900000000000000C'	
000024FC	99000000 0000000C						
				1824			
				1825 *	VMP	larger #'s , i4=159(iom=1 & rdc=31)	CS=1 for all m5
				1826 *	check	forced positive	
				1827	VRI_F	VMP, - 9999999999999999, +1, 159, 9, 2	m5=9(P2=1)
00002508				1828+	DS	0FD	
00002508		00002508		1829+	USING	*, R5	base for test data and test routine
00002508	00002538			1830+T40	DC	A(X40)	address of test routine
0000250C	0028			1831+	DC	H' 40'	test number
0000250E	00			1832+	DC	X' 00'	
0000250F	9F			1833+	DC	HL1' 159'	i4
00002510	09			1834+	DC	HL1' 9'	m5
00002511	02			1835+	DC	HL1' 2'	cc
00002512	0D			1836+	DC	HL1' 13'	cc failed mask
				1837+V2_40	DC	FD' - 9999999999999999' \	
00002518	FE9CBA87 A2760001			+			binary value for v2 packed decimal
00002520	00000000 00000001			1838+V3_40	DC	FD' +1'	binary value for v3 packed decimal
00002528	E5D4D740 40404040			1839+	DC	CL8' VMP'	instruction name
00002530	00000010			1840+	DC	A(16)	result length
00002534	00002574			1841+REA40	DC	A(RE40)	result address
				1842+*			INSTRUCTION UNDER TEST ROUTINE
00002538				1843+X40	DS	0F	
00002538	E320 5010 0004		00002518	1844+	LG	R2, V2_40	convert v2
0000253E	E320 8F57 002E		00001157	1845+	CVDG	R2, V2PACKED	
00002544	E720 8F57 0006		00001157	1846+	VL	V2, V2PACKED	
0000254A	E320 5018 0004		00002520	1847+	LG	R2, V3_40	convert v3
00002550	E320 8F67 002E		00001167	1848+	CVDG	R2, V3PACKED	
00002556	E730 8F67 0006		00001167	1849+	VL	V3, V3PACKED	
0000255C	E612 3099 F078			1850+	VMP	V1, V2, V3, 159, 9	test instruction
00002562	E710 8F08 000E		00001108	1851+	VST	V1, V10UTPUT	save result
00002568	B98D 0020			1852+	EPSW	R2, R0	exptract psw
0000256C	5020 8EE8		000010E8	1853+	ST	R2, CCPSW	to save CC
00002570	07FB			1854+	BR	R11	return
00002574				1855+RE40	DC	0F	
00002574				1856+	DROP	R5	
00002574	00000000 00000099			1857	DC	XL16' 000000000000000999999999999999C'	
0000257C	99999999 9999999C						
				1858			
				1859 *			m5=13(P2=1, P3=1)
				1860	VRI_F	VMP, - 9999999999999999, - 1000000000000000, 159, 13, 3	
00002588				1861+	DS	0FD	
00002588		00002588		1862+	USING	*, R5	base for test data and test routine
00002588	000025B8			1863+T41	DC	A(X41)	address of test routine
0000258C	0029			1864+	DC	H' 41'	test number
0000258E	00			1865+	DC	X' 00'	
0000258F	9F			1866+	DC	HL1' 159'	i4
00002590	0D			1867+	DC	HL1' 13'	m5
00002591	03			1868+	DC	HL1' 3'	cc
00002592	0E			1869+	DC	HL1' 14'	cc failed mask
				1870+V2_41	DC	FD' - 9999999999999999' \	
00002598	FE9CBA87 A2760001			+			binary value for v2 packed decimal

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
				1871+V3_41	DC	FD' - 10000000000000000' \
000025A0	FFDC790D 903F0000			+		binary value for v3 packed decimal
000025A8	E5D4D740 40404040			1872+	DC	CL8' VMP'
000025B0	00000010			1873+	DC	A(16)
000025B4	000025F4			1874+REA41	DC	A(RE41)
				1875+*		INSTRUCTION UNDER TEST ROUTINE
000025B8				1876+X41	DS	OF
000025B8	E320 5010 0004		00002598	1877+	LG	R2, V2_41
000025BE	E320 8F57 002E		00001157	1878+	CVDG	R2, V2PACKED
000025C4	E720 8F57 0006		00001157	1879+	VL	V2, V2PACKED
000025CA	E320 5018 0004		000025A0	1880+	LG	R2, V3_41
000025D0	E320 8F67 002E		00001167	1881+	CVDG	R2, V3PACKED
000025D6	E730 8F67 0006		00001167	1882+	VL	V3, V3PACKED
000025DC	E612 30D9 F078			1883+	VMP	V1, V2, V3, 159, 13
000025E2	E710 8F08 000E		00001108	1884+	VST	V1, V10UTPUT
000025E8	B98D 0020			1885+	EPSW	R2, R0
000025EC	5020 8EE8		000010E8	1886+	ST	R2, CCPSW
000025F0	07FB			1887+	BR	R11
000025F4				1888+RE41	DC	OF
000025F4				1889+	DROP	R5
000025F4	99999999 99999990			1890	DC	XL16' 99999999999999990000000000000000C'
000025FC	00000000 0000000C					overflowed
				1891		
00002608				1892	VRI_F	VMP, - 9999999999999999, - 1, 159, 3, 2
00002608		00002608		1893+	DS	OFD
00002608	00002638			1894+	USING	*, R5
0000260C	002A			1895+T42	DC	A(X42)
0000260E	00			1896+	DC	H' 42'
0000260F	9F			1897+	DC	X' 00'
00002610	03			1898+	DC	HL1' 159'
00002611	02			1899+	DC	HL1' 3'
00002612	0D			1900+	DC	HL1' 2'
				1901+	DC	HL1' 13'
				1902+V2_42	DC	FD' - 9999999999999999' \
00002618	FFDC790D 903F0001			+		binary value for v2 packed decimal
00002620	FFFFFFFF FFFFFFFF			1903+V3_42	DC	FD' - 1'
00002628	E5D4D740 40404040			1904+	DC	CL8' VMP'
00002630	00000010			1905+	DC	A(16)
00002634	00002674			1906+REA42	DC	A(RE42)
				1907+*		INSTRUCTION UNDER TEST ROUTINE
00002638				1908+X42	DS	OF
00002638	E320 5010 0004		00002618	1909+	LG	R2, V2_42
0000263E	E320 8F57 002E		00001157	1910+	CVDG	R2, V2PACKED
00002644	E720 8F57 0006		00001157	1911+	VL	V2, V2PACKED
0000264A	E320 5018 0004		00002620	1912+	LG	R2, V3_42
00002650	E320 8F67 002E		00001167	1913+	CVDG	R2, V3PACKED
00002656	E730 8F67 0006		00001167	1914+	VL	V3, V3PACKED
0000265C	E612 3039 F078			1915+	VMP	V1, V2, V3, 159, 3
00002662	E710 8F08 000E		00001108	1916+	VST	V1, V10UTPUT
00002668	B98D 0020			1917+	EPSW	R2, R0
0000266C	5020 8EE8		000010E8	1918+	ST	R2, CCPSW
00002670	07FB			1919+	BR	R11
00002674				1920+RE42	DC	OF
00002674				1921+	DROP	R5
00002674	00000000 00000009			1922	DC	XL16' 0000000000000000999999999999999F'
0000267C	99999999 9999999F					

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
				1923		
				1924	VRI_F VMP, - 9999999999999999, - 1, 135, 13, 3	i4=135(iom=1 & rdc=7)
00002688				1925+	DS	OFD
00002688		00002688		1926+	USING	*, R5
00002688	000026B8			1927+T43	DC	A(X43)
0000268C	002B			1928+	DC	H' 43'
0000268E	00			1929+	DC	X' 00'
0000268F	87			1930+	DC	HL1' 135'
00002690	0D			1931+	DC	HL1' 13'
00002691	03			1932+	DC	HL1' 3'
00002692	0E			1933+	DC	HL1' 14'
				1934+V2_43	DC	FD' - 9999999999999999' \
00002698	FFDC790D 903F0001			+		binary value for v2 packed decimal
000026A0	FFFFFFFF FFFFFFFF			1935+V3_43	DC	FD' - 1'
000026A8	E5D4D740 40404040			1936+	DC	CL8' VMP'
000026B0	00000010			1937+	DC	A(16)
000026B4	000026F4			1938+REA43	DC	A(RE43)
				1939+*		INSTRUCTION UNDER TEST ROUTINE
000026B8				1940+X43	DS	OF
000026B8	E320 5010 0004		00002698	1941+	LG	R2, V2_43
000026BE	E320 8F57 002E		00001157	1942+	CVDG	R2, V2PACKED
000026C4	E720 8F57 0006		00001157	1943+	VL	V2, V2PACKED
000026CA	E320 5018 0004		000026A0	1944+	LG	R2, V3_43
000026D0	E320 8F67 002E		00001167	1945+	CVDG	R2, V3PACKED
000026D6	E730 8F67 0006		00001167	1946+	VL	V3, V3PACKED
000026DC	E612 30D8 7078			1947+	VMP	V1, V2, V3, 135, 13
000026E2	E710 8F08 000E		00001108	1948+	VST	V1, V10UTPUT
000026E8	B98D 0020			1949+	EPSW	R2, R0
000026EC	5020 8EE8		000010E8	1950+	ST	R2, CCPSW
000026F0	07FB			1951+	BR	R11
000026F4				1952+RE43	DC	OF
000026F4				1953+	DROP	R5
				1954 *		m5=13(P2=1, P3=1)
000026F4	00000000 00000000			1955	DC	XL16' 00000000000000000000000009999999C'
000026FC	00000000 9999999C					overflow RDC
				1956		
				1957	VRI_F VMP, +99999999999999, +10000000000000, 159, 3, 2	m5=3(P1=1)
00002708				1958+	DS	OFD
00002708		00002708		1959+	USING	*, R5
00002708	00002738			1960+T44	DC	A(X44)
0000270C	002C			1961+	DC	H' 44'
0000270E	00			1962+	DC	X' 00'
0000270F	9F			1963+	DC	HL1' 159'
00002710	03			1964+	DC	HL1' 3'
00002711	02			1965+	DC	HL1' 2'
00002712	0D			1966+	DC	HL1' 13'
				1967+V2_44	DC	FD' +99999999999999' \
00002718	00000918 4E729FFF			+		binary value for v2 packed decimal
				1968+V3_44	DC	FD' +10000000000000' \
00002720	00000918 4E72A000			+		binary value for v3 packed decimal
00002728	E5D4D740 40404040			1969+	DC	CL8' VMP'
00002730	00000010			1970+	DC	A(16)
00002734	00002774			1971+REA44	DC	A(RE44)
				1972+*		INSTRUCTION UNDER TEST ROUTINE
00002738				1973+X44	DS	OF
00002738	E320 5010 0004		00002718	1974+	LG	R2, V2_44

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
0000273E	E320 8F57 002E		00001157	1975+	CVDG	R2, V2PACKED	
00002744	E720 8F57 0006		00001157	1976+	VL	V2, V2PACKED	
0000274A	E320 5018 0004		00002720	1977+	LG	R2, V3_44	convert v3
00002750	E320 8F67 002E		00001167	1978+	CVDG	R2, V3PACKED	
00002756	E730 8F67 0006		00001167	1979+	VL	V3, V3PACKED	
0000275C	E612 3039 F078			1980+	VMP	V1, V2, V3, 159, 3	test instruction
00002762	E710 8F08 000E		00001108	1981+	VST	V1, V10OUTPUT	save result
00002768	B98D 0020			1982+	EPSW	R2, R0	exptract psw
0000276C	5020 8EE8		000010E8	1983+	ST	R2, CCPSW	to save CC
00002770	07FB			1984+	BR	R11	return
00002774				1985+RE44	DC	0F	
00002774				1986+	DROP	R5	
00002774	00000999 99999999			1987	DC	XL16' 0000099999999999999900000000000000F'	
0000277C	99000000 0000000F						
				1988			
				1989 *			
				1990 * VDP		- VECTOR DIVIDE DECIMAL	
				1991 *			
				1992 * VDP simple + CC checks			
				1993	VRI_F	VDP, +10, +12, 7, 1, 0	
00002788				1994+	DS	0FD	
00002788		00002788		1995+	USING	*, R5	base for test data and test routine
00002788	000027B8			1996+T45	DC	A(X45)	address of test routine
0000278C	002D			1997+	DC	H' 45'	test number
0000278E	00			1998+	DC	X' 00'	
0000278F	07			1999+	DC	HL1' 7'	i4
00002790	01			2000+	DC	HL1' 1'	m5
00002791	00			2001+	DC	HL1' 0'	cc
00002792	07			2002+	DC	HL1' 7'	cc failed mask
00002798	00000000 0000000A			2003+V2_45	DC	FD' +10'	binary value for v2 packed decimal
000027A0	00000000 0000000C			2004+V3_45	DC	FD' +12'	binary value for v3 packed decimal
000027A8	E5C4D740 40404040			2005+	DC	CL8' VDP'	instruction name
000027B0	00000010			2006+	DC	A(16)	result length
000027B4	000027F4			2007+REA45	DC	A(RE45)	result address
				2008+*			INSTRUCTION UNDER TEST ROUTINE
000027B8				2009+X45	DS	0F	
000027B8	E320 5010 0004		00002798	2010+	LG	R2, V2_45	convert v2
000027BE	E320 8F57 002E		00001157	2011+	CVDG	R2, V2PACKED	
000027C4	E720 8F57 0006		00001157	2012+	VL	V2, V2PACKED	
000027CA	E320 5018 0004		000027A0	2013+	LG	R2, V3_45	convert v3
000027D0	E320 8F67 002E		00001167	2014+	CVDG	R2, V3PACKED	
000027D6	E730 8F67 0006		00001167	2015+	VL	V3, V3PACKED	
000027DC	E612 3010 707A			2016+	VDP	V1, V2, V3, 7, 1	test instruction
000027E2	E710 8F08 000E		00001108	2017+	VST	V1, V10OUTPUT	save result
000027E8	B98D 0020			2018+	EPSW	R2, R0	exptract psw
000027EC	5020 8EE8		000010E8	2019+	ST	R2, CCPSW	to save CC
000027F0	07FB			2020+	BR	R11	return
000027F4				2021+RE45	DC	0F	
000027F4				2022+	DROP	R5	
000027F4	00000000 00000000			2023	DC	XL16' 00000000000000000000000000000000C'	
000027FC	00000000 0000000C						
				2024			
				2025	VRI_F	VDP, - 100, +12, 7, 1, 1	
00002808				2026+	DS	0FD	
00002808		00002808		2027+	USING	*, R5	base for test data and test routine
00002808	00002838			2028+T46	DC	A(X46)	address of test routine

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
000028F0	07FB			2084+	BR R11	return
000028F4				2085+RE47	DC 0F	
000028F4				2086+	DROP R5	
000028F4	00000000 00000000			2087	DC XL16'	000000000000000000000000000008D'
000028FC	00000000 0000008D					
				2088		
				2089	VRI_F VDP, +100, - 12, 7, 1, 1	
00002908				2090+	DS 0FD	
00002908		00002908		2091+	USING *, R5	base for test data and test routine
00002908	00002938			2092+T48	DC A(X48)	address of test routine
0000290C	0030			2093+	DC H' 48'	test number
0000290E	00			2094+	DC X' 00'	
0000290F	07			2095+	DC HL1' 7'	i4
00002910	01			2096+	DC HL1' 1'	m5
00002911	01			2097+	DC HL1' 1'	cc
00002912	0B			2098+	DC HL1' 11'	cc failed mask
00002918	00000000 00000064			2099+V2_48	DC FD' +100'	binary value for v2 packed decimal
00002920	FFFFFFFF FFFFFFFF4			2100+V3_48	DC FD' - 12'	binary value for v3 packed decimal
00002928	E5C4D740 40404040			2101+	DC CL8' VDP'	instruction name
00002930	00000010			2102+	DC A(16)	result length
00002934	00002974			2103+REA48	DC A(RE48)	result address
				2104+*		INSTRUCTION UNDER TEST ROUTINE
00002938				2105+X48	DS 0F	
00002938	E320 5010 0004		00002918	2106+	LG R2, V2_48	convert v2
0000293E	E320 8F57 002E		00001157	2107+	CVDG R2, V2PACKED	
00002944	E720 8F57 0006		00001157	2108+	VL V2, V2PACKED	
0000294A	E320 5018 0004		00002920	2109+	LG R2, V3_48	convert v3
00002950	E320 8F67 002E		00001167	2110+	CVDG R2, V3PACKED	
00002956	E730 8F67 0006		00001167	2111+	VL V3, V3PACKED	
0000295C	E612 3010 707A			2112+	VDP V1, V2, V3, 7, 1	test instruction
00002962	E710 8F08 000E		00001108	2113+	VST V1, V10UTPUT	save result
00002968	B98D 0020			2114+	EPSW R2, R0	exptract psw
0000296C	5020 8EE8		000010E8	2115+	ST R2, CCPSW	to save CC
00002970	07FB			2116+	BR R11	return
00002974				2117+RE48	DC 0F	
00002974				2118+	DROP R5	
00002974	00000000 00000000			2119	DC XL16'	000000000000000000000000000008D'
0000297C	00000000 0000008D					
				2120		
				2121	VRI_F VDP, - 100, - 12, 7, 1, 2	
00002988				2122+	DS 0FD	
00002988		00002988		2123+	USING *, R5	base for test data and test routine
00002988	000029B8			2124+T49	DC A(X49)	address of test routine
0000298C	0031			2125+	DC H' 49'	test number
0000298E	00			2126+	DC X' 00'	
0000298F	07			2127+	DC HL1' 7'	i4
00002990	01			2128+	DC HL1' 1'	m5
00002991	02			2129+	DC HL1' 2'	cc
00002992	0D			2130+	DC HL1' 13'	cc failed mask
00002998	FFFFFFFF FFFFFFFF9C			2131+V2_49	DC FD' - 100'	binary value for v2 packed decimal
000029A0	FFFFFFFF FFFFFFFF4			2132+V3_49	DC FD' - 12'	binary value for v3 packed decimal
000029A8	E5C4D740 40404040			2133+	DC CL8' VDP'	instruction name
000029B0	00000010			2134+	DC A(16)	result length
000029B4	000029F4			2135+REA49	DC A(RE49)	result address
				2136+*		INSTRUCTION UNDER TEST ROUTINE
000029B8				2137+X49	DS 0F	

LOC	OBJECT	CODE	ADDR1	ADDR2	STMT	
00002A90	01				2192+	DC HL1' 1' m5
00002A91	03				2193+	DC HL1' 3' cc
00002A92	0E				2194+	DC HL1' 14' cc failed mask
00002A98	00000002	540BE40A			2195+V2_51	DC FD' +10000000010' binary value for v2 packed decimal
00002AA0	00000000	0000000A			2196+V3_51	DC FD' +10' binary value for v3 packed decimal
00002AA8	E5C4D740	40404040			2197+	DC CL8' VDP' instruction name
00002AB0	00000010				2198+	DC A(16) result length
00002AB4	00002AF4				2199+REA51	DC A(RE51) result address
					2200+*	INSTRUCTION UNDER TEST ROUTINE
00002AB8					2201+X51	DS OF
00002AB8	E320	5010	0004	00002A98	2202+	LG R2, V2_51 convert v2
00002ABE	E320	8F57	002E	00001157	2203+	CVDG R2, V2PACKED
00002AC4	E720	8F57	0006	00001157	2204+	VL V2, V2PACKED
00002ACA	E320	5018	0004	00002AA0	2205+	LG R2, V3_51 convert v3
00002AD0	E320	8F67	002E	00001167	2206+	CVDG R2, V3PACKED
00002AD6	E730	8F67	0006	00001167	2207+	VL V3, V3PACKED
00002ADC	E612	3018	707A		2208+	VDP V1, V2, V3, 135, 1 test instruction
00002AE2	E710	8F08	000E	00001108	2209+	VST V1, V10UTPUT save result
00002AE8	B98D	0020			2210+	EPSW R2, R0 exptract psw
00002AEC	5020	8EE8		000010E8	2211+	ST R2, CCPSW to save CC
00002AF0	07FB				2212+	BR R11 return
00002AF4					2213+RE51	DC OF
00002AF4					2214+	DROP R5
00002AF4	00000000	00000000			2215	DC XL16' 00000000000000000000000000000001C' note RDC
00002AFC	00000000	0000001C			2216	
					2217 * VDP larger #'s , i4=159(iom=1 & rdc=31)	
					2218 VRI_F	VDP, +999999999999999999, +1, 159, 1, 2
00002B08					2219+	DS OFD
00002B08			00002B08		2220+	USING *, R5 base for test data and test routine
00002B08	00002B38				2221+T52	DC A(X52) address of test routine
00002B0C	0034				2222+	DC H' 52' test number
00002B0E	00				2223+	DC X' 00'
00002B0F	9F				2224+	DC HL1' 159' i4
00002B10	01				2225+	DC HL1' 1' m5
00002B11	02				2226+	DC HL1' 2' cc
00002B12	0D				2227+	DC HL1' 13' cc failed mask
					2228+V2_52	DC FD' +999999999999999999' \
00002B18	01634578	5D89FFFF			+	binary value for v2 packed decimal
00002B20	00000000	00000001			2229+V3_52	DC FD' +1' binary value for v3 packed decimal
00002B28	E5C4D740	40404040			2230+	DC CL8' VDP' instruction name
00002B30	00000010				2231+	DC A(16) result length
00002B34	00002B74				2232+REA52	DC A(RE52) result address
					2233+*	INSTRUCTION UNDER TEST ROUTINE
00002B38					2234+X52	DS OF
00002B38	E320	5010	0004	00002B18	2235+	LG R2, V2_52 convert v2
00002B3E	E320	8F57	002E	00001157	2236+	CVDG R2, V2PACKED
00002B44	E720	8F57	0006	00001157	2237+	VL V2, V2PACKED
00002B4A	E320	5018	0004	00002B20	2238+	LG R2, V3_52 convert v3
00002B50	E320	8F67	002E	00001167	2239+	CVDG R2, V3PACKED
00002B56	E730	8F67	0006	00001167	2240+	VL V3, V3PACKED
00002B5C	E612	3019	F07A		2241+	VDP V1, V2, V3, 159, 1 test instruction
00002B62	E710	8F08	000E	00001108	2242+	VST V1, V10UTPUT save result
00002B68	B98D	0020			2243+	EPSW R2, R0 exptract psw
00002B6C	5020	8EE8		000010E8	2244+	ST R2, CCPSW to save CC
00002B70	07FB				2245+	BR R11 return

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
00002B74				2246+RE52	DC	0F	
00002B74				2247+	DROP	R5	
00002B74	00000000 00000099			2248	DC	XL16'	00000000000000009999999999999999C'
00002B7C	99999999 9999999C						
				2249			
				2250	VRI_F	VDP, - 9999999999999999, +1000, 159, 1, 1	
00002B88				2251+	DS	0FD	
00002B88		00002B88		2252+	USING	*, R5	base for test data and test routine
00002B88	00002BB8			2253+T53	DC	A(X53)	address of test routine
00002B8C	0035			2254+	DC	H' 53'	test number
00002B8E	00			2255+	DC	X' 00'	
00002B8F	9F			2256+	DC	HL1' 159'	i4
00002B90	01			2257+	DC	HL1' 1'	m5
00002B91	01			2258+	DC	HL1' 1'	cc
00002B92	0B			2259+	DC	HL1' 11'	cc failed mask
				2260+V2_53	DC	FD' - 9999999999999999' \	
00002B98	FE9CBA87 A2760001			+			binary value for v2 packed decimal
00002BA0	00000000 000003E8			2261+V3_53	DC	FD' +1000'	binary value for v3 packed decimal
00002BA8	E5C4D740 40404040			2262+	DC	CL8' VDP'	instruction name
00002BB0	00000010			2263+	DC	A(16)	result length
00002BB4	00002BF4			2264+REA53	DC	A(RE53)	result address
				2265+*			INSTRUCTION UNDER TEST ROUTINE
00002BB8				2266+X53	DS	0F	
00002BB8	E320 5010 0004		00002B98	2267+	LG	R2, V2_53	convert v2
00002BBE	E320 8F57 002E		00001157	2268+	CVDG	R2, V2PACKED	
00002BC4	E720 8F57 0006		00001157	2269+	VL	V2, V2PACKED	
00002BCA	E320 5018 0004		00002BA0	2270+	LG	R2, V3_53	convert v3
00002BD0	E320 8F67 002E		00001167	2271+	CVDG	R2, V3PACKED	
00002BD6	E730 8F67 0006		00001167	2272+	VL	V3, V3PACKED	
00002BDC	E612 3019 F07A			2273+	VDP	V1, V2, V3, 159, 1	test instruction
00002BE2	E710 8F08 000E		00001108	2274+	VST	V1, V10UTPUT	save result
00002BE8	B98D 0020			2275+	EPSW	R2, R0	exptract psw
00002BEC	5020 8EE8		000010E8	2276+	ST	R2, CCPSW	to save CC
00002BF0	07FB			2277+	BR	R11	return
00002BF4				2278+RE53	DC	0F	
00002BF4				2279+	DROP	R5	
00002BF4	00000000 00000000			2280	DC	XL16'	00000000000000000999999999999999D'
00002BFC	09999999 9999999D						
				2281			
				2282	VRI_F	VDP, - 9999999999999999, - 1, 159, 1, 2	
00002C08				2283+	DS	0FD	
00002C08		00002C08		2284+	USING	*, R5	base for test data and test routine
00002C08	00002C38			2285+T54	DC	A(X54)	address of test routine
00002C0C	0036			2286+	DC	H' 54'	test number
00002C0E	00			2287+	DC	X' 00'	
00002C0F	9F			2288+	DC	HL1' 159'	i4
00002C10	01			2289+	DC	HL1' 1'	m5
00002C11	02			2290+	DC	HL1' 2'	cc
00002C12	0D			2291+	DC	HL1' 13'	cc failed mask
				2292+V2_54	DC	FD' - 9999999999999999' \	
00002C18	FFDC790D 903F0001			+			binary value for v2 packed decimal
00002C20	FFFFFFFF FFFFFFFF			2293+V3_54	DC	FD' - 1'	binary value for v3 packed decimal
00002C28	E5C4D740 40404040			2294+	DC	CL8' VDP'	instruction name
00002C30	00000010			2295+	DC	A(16)	result length
00002C34	00002C74			2296+REA54	DC	A(RE54)	result address
				2297+*			INSTRUCTION UNDER TEST ROUTINE

LOC	OBJECT	CODE	ADDR1	ADDR2	STMT		
00002C38					2298+X54	DS	0F
00002C38	E320	5010	0004	00002C18	2299+	LG	R2, V2_54
00002C3E	E320	8F57	002E	00001157	2300+	CVDG	R2, V2PACKED
00002C44	E720	8F57	0006	00001157	2301+	VL	V2, V2PACKED
00002C4A	E320	5018	0004	00002C20	2302+	LG	R2, V3_54
00002C50	E320	8F67	002E	00001167	2303+	CVDG	R2, V3PACKED
00002C56	E730	8F67	0006	00001167	2304+	VL	V3, V3PACKED
00002C5C	E612	3019	F07A		2305+	VDP	V1, V2, V3, 159, 1
00002C62	E710	8F08	000E	00001108	2306+	VST	V1, V10UTPUT
00002C68	B98D	0020			2307+	EPSW	R2, R0
00002C6C	5020	8EE8		000010E8	2308+	ST	R2, CCPSW
00002C70	07FB				2309+	BR	R11
00002C74					2310+RE54	DC	0F
00002C74					2311+	DROP	R5
00002C74	00000000	00000009			2312	DC	XL16' 00000000000000009999999999999999C'
00002C7C	99999999	9999999C					
					2313		
					2314	VRI_F	VDP, - 9999999999999999, - 1, 135, 1, 3 i4=135(iom=1 & rdc=7)
00002C88					2315+	DS	0FD
00002C88			00002C88		2316+	USING	*, R5
00002C88	00002CB8				2317+T55	DC	A(X55)
00002C8C	0037				2318+	DC	H' 55'
00002C8E	00				2319+	DC	X' 00'
00002C8F	87				2320+	DC	HL1' 135'
00002C90	01				2321+	DC	HL1' 1'
00002C91	03				2322+	DC	HL1' 3'
00002C92	0E				2323+	DC	HL1' 14'
					2324+V2_55	DC	FD' - 9999999999999999' \
00002C98	FFDC790D	903F0001			+		binary value for v2 packed decimal
00002CA0	FFFFFFFF	FFFFFFFF			2325+V3_55	DC	FD' - 1'
00002CA8	E5C4D740	40404040			2326+	DC	CL8' VDP'
00002CB0	00000010				2327+	DC	A(16)
00002CB4	00002CF4				2328+REA55	DC	A(RE55)
					2329+*		INSTRUCTION UNDER TEST ROUTINE
00002CB8					2330+X55	DS	0F
00002CB8	E320	5010	0004	00002C98	2331+	LG	R2, V2_55
00002CBE	E320	8F57	002E	00001157	2332+	CVDG	R2, V2PACKED
00002CC4	E720	8F57	0006	00001157	2333+	VL	V2, V2PACKED
00002CCA	E320	5018	0004	00002CA0	2334+	LG	R2, V3_55
00002CD0	E320	8F67	002E	00001167	2335+	CVDG	R2, V3PACKED
00002CD6	E730	8F67	0006	00001167	2336+	VL	V3, V3PACKED
00002CDC	E612	3018	707A		2337+	VDP	V1, V2, V3, 135, 1
00002CE2	E710	8F08	000E	00001108	2338+	VST	V1, V10UTPUT
00002CE8	B98D	0020			2339+	EPSW	R2, R0
00002CEC	5020	8EE8		000010E8	2340+	ST	R2, CCPSW
00002CF0	07FB				2341+	BR	R11
00002CF4					2342+RE55	DC	0F
00002CF4					2343+	DROP	R5
00002CF4	00000000	00000000			2344	DC	XL16' 00000000000000000000000099999999C'
00002CFC	00000000	9999999C					overflow RDC
					2345		
					2346	VRI_F	VDP, +99999999999999, +1234, 159, 1, 2
00002D08					2347+	DS	0FD
00002D08			00002D08		2348+	USING	*, R5
00002D08	00002D38				2349+T56	DC	A(X56)
00002D0C	0038				2350+	DC	H' 56'

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
00002D0E	00			2351+	DC	X' 00'	
00002D0F	9F			2352+	DC	HL1' 159'	i4
00002D10	01			2353+	DC	HL1' 1'	m5
00002D11	02			2354+	DC	HL1' 2'	cc
00002D12	0D			2355+	DC	HL1' 13'	cc failed mask
				2356+V2_56	DC	FD' +99999999999999'	\
00002D18	00000918	4E729FFF		+			binary value for v2 packed decimal
00002D20	00000000	000004D2		2357+V3_56	DC	FD' +1234'	binary value for v3 packed decimal
00002D28	E5C4D740	40404040		2358+	DC	CL8' VDP'	instruction name
00002D30	00000010			2359+	DC	A(16)	result length
00002D34	00002D74			2360+REA56	DC	A(RE56)	result address
				2361+*			INSTRUCTION UNDER TEST ROUTINE
00002D38				2362+X56	DS	0F	
00002D38	E320 5010 0004		00002D18	2363+	LG	R2, V2_56	convert v2
00002D3E	E320 8F57 002E		00001157	2364+	CVDG	R2, V2PACKED	
00002D44	E720 8F57 0006		00001157	2365+	VL	V2, V2PACKED	
00002D4A	E320 5018 0004		00002D20	2366+	LG	R2, V3_56	convert v3
00002D50	E320 8F67 002E		00001167	2367+	CVDG	R2, V3PACKED	
00002D56	E730 8F67 0006		00001167	2368+	VL	V3, V3PACKED	
00002D5C	E612 3019 F07A			2369+	VDP	V1, V2, V3, 159, 1	test instruction
00002D62	E710 8F08 000E		00001108	2370+	VST	V1, V10UTPUT	save result
00002D68	B98D 0020			2371+	EPSW	R2, R0	exptract psw
00002D6C	5020 8EE8		000010E8	2372+	ST	R2, CCPSW	to save CC
00002D70	07FB			2373+	BR	R11	return
00002D74				2374+RE56	DC	0F	
00002D74				2375+	DROP	R5	
00002D74	00000000 00000000			2376	DC	XL16' 00000000000000000000000008103727714C'	
00002D7C	00000810 3727714C						
				2377			
00002D88				2378	VRI_F	VDP, +999999999999999999, +1234, 159, 1, 2	
00002D88		00002D88		2379+	DS	0FD	
00002D88	00002DB8			2380+	USING	*, R5	base for test data and test routine
00002D8C	0039			2381+T57	DC	A(X57)	address of test routine
00002D8E	00			2382+	DC	H' 57'	test number
00002D8F	9F			2383+	DC	X' 00'	
00002D90	01			2384+	DC	HL1' 159'	i4
00002D91	02			2385+	DC	HL1' 1'	m5
00002D92	0D			2386+	DC	HL1' 2'	cc
				2387+	DC	HL1' 13'	cc failed mask
				2388+V2_57	DC	FD' +999999999999999999'	\
00002D98	0DE0B6B3	A763FFFF		+			binary value for v2 packed decimal
00002DA0	00000000	000004D2		2389+V3_57	DC	FD' +1234'	binary value for v3 packed decimal
00002DA8	E5C4D740	40404040		2390+	DC	CL8' VDP'	instruction name
00002DB0	00000010			2391+	DC	A(16)	result length
00002DB4	00002DF4			2392+REA57	DC	A(RE57)	result address
				2393+*			INSTRUCTION UNDER TEST ROUTINE
00002DB8				2394+X57	DS	0F	
00002DB8	E320 5010 0004		00002D98	2395+	LG	R2, V2_57	convert v2
00002DBE	E320 8F57 002E		00001157	2396+	CVDG	R2, V2PACKED	
00002DC4	E720 8F57 0006		00001157	2397+	VL	V2, V2PACKED	
00002DCA	E320 5018 0004		00002DA0	2398+	LG	R2, V3_57	convert v3
00002DD0	E320 8F67 002E		00001167	2399+	CVDG	R2, V3PACKED	
00002DD6	E730 8F67 0006		00001167	2400+	VL	V3, V3PACKED	
00002DDC	E612 3019 F07A			2401+	VDP	V1, V2, V3, 159, 1	test instruction
00002DE2	E710 8F08 000E		00001108	2402+	VST	V1, V10UTPUT	save result
00002DE8	B98D 0020			2403+	EPSW	R2, R0	exptract psw

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
00002DEC	5020 8EE8		000010E8	2404+	ST	R2, CCPSW	to save CC
00002DF0	07FB			2405+	BR	R11	return
00002DF4				2406+RE57	DC	0F	
00002DF4				2407+	DROP	R5	
00002DF4	00000000 00000000			2408	DC	XL16' 00000000000000000810372771474878C'	
00002DFC	81037277 1474878C						
				2409			
				2410 *	VDP larger #'s , i4=159(iom=1 & rdc=31)		CS=1 for all m5
				2411 *	check forced positive		
				2412	VRI_F VDP, - 9999999999999999, +1, 159, 9, 2		m5=9(P2=1)
00002E08				2413+	DS	0FD	
00002E08		00002E08		2414+	USING	*, R5	base for test data and test routine
00002E08	00002E38			2415+T58	DC	A(X58)	address of test routine
00002E0C	003A			2416+	DC	H' 58'	test number
00002E0E	00			2417+	DC	X' 00'	
00002E0F	9F			2418+	DC	HL1' 159'	i4
00002E10	09			2419+	DC	HL1' 9'	m5
00002E11	02			2420+	DC	HL1' 2'	cc
00002E12	0D			2421+	DC	HL1' 13'	cc failed mask
				2422+V2_58	DC	FD' - 9999999999999999' \	
00002E18	FE9CBA87 A2760001			+			binary value for v2 packed decimal
00002E20	00000000 00000001			2423+V3_58	DC	FD' +1'	binary value for v3 packed decimal
00002E28	E5C4D740 40404040			2424+	DC	CL8' VDP'	instruction name
00002E30	00000010			2425+	DC	A(16)	result length
00002E34	00002E74			2426+REA58	DC	A(RE58)	result address
				2427+*			INSTRUCTION UNDER TEST ROUTINE
00002E38				2428+X58	DS	0F	
00002E38	E320 5010 0004		00002E18	2429+	LG	R2, V2_58	convert v2
00002E3E	E320 8F57 002E		00001157	2430+	CVDG	R2, V2PACKED	
00002E44	E720 8F57 0006		00001157	2431+	VL	V2, V2PACKED	
00002E4A	E320 5018 0004		00002E20	2432+	LG	R2, V3_58	convert v3
00002E50	E320 8F67 002E		00001167	2433+	CVDG	R2, V3PACKED	
00002E56	E730 8F67 0006		00001167	2434+	VL	V3, V3PACKED	
00002E5C	E612 3099 F07A			2435+	VDP	V1, V2, V3, 159, 9	test instruction
00002E62	E710 8F08 000E		00001108	2436+	VST	V1, V10UTPUT	save result
00002E68	B98D 0020			2437+	EPSW	R2, R0	exptract psw
00002E6C	5020 8EE8		000010E8	2438+	ST	R2, CCPSW	to save CC
00002E70	07FB			2439+	BR	R11	return
00002E74				2440+RE58	DC	0F	
00002E74				2441+	DROP	R5	
00002E74	00000000 00000099			2442	DC	XL16' 00000000000000009999999999999999C'	
00002E7C	99999999 9999999C						
				2443			
				2444	VRI_F	VDP, +9999999999999999, - 1000, 159, 13, 2	m5=13(P2=1, P3=1)
00002E88				2445+	DS	0FD	
00002E88		00002E88		2446+	USING	*, R5	base for test data and test routine
00002E88	00002EB8			2447+T59	DC	A(X59)	address of test routine
00002E8C	003B			2448+	DC	H' 59'	test number
00002E8E	00			2449+	DC	X' 00'	
00002E8F	9F			2450+	DC	HL1' 159'	i4
00002E90	0D			2451+	DC	HL1' 13'	m5
00002E91	02			2452+	DC	HL1' 2'	cc
00002E92	0D			2453+	DC	HL1' 13'	cc failed mask
				2454+V2_59	DC	FD' +9999999999999999' \	
00002E98	01634578 5D89FFFF			+			binary value for v2 packed decimal
00002EA0	FFFFFFFF FFFFC18			2455+V3_59	DC	FD' - 1000'	binary value for v3 packed decimal

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
00002EA8	E5C4D740 40404040			2456+	DC	CL8' VDP'	instruction name
00002EB0	00000010			2457+	DC	A(16)	result length
00002EB4	00002EF4			2458+REA59	DC	A(RE59)	result address
				2459+*			INSTRUCTION UNDER TEST ROUTINE
00002EB8				2460+X59	DS	OF	
00002EB8	E320 5010 0004		00002E98	2461+	LG	R2, V2_59	convert v2
00002EBE	E320 8F57 002E		00001157	2462+	CVDG	R2, V2PACKED	
00002EC4	E720 8F57 0006		00001157	2463+	VL	V2, V2PACKED	
00002ECA	E320 5018 0004		00002EA0	2464+	LG	R2, V3_59	convert v3
00002ED0	E320 8F67 002E		00001167	2465+	CVDG	R2, V3PACKED	
00002ED6	E730 8F67 0006		00001167	2466+	VL	V3, V3PACKED	
00002EDC	E612 30D9 F07A			2467+	VDP	V1, V2, V3, 159, 13	test instruction
00002EE2	E710 8F08 000E		00001108	2468+	VST	V1, V10OUTPUT	save result
00002EE8	B98D 0020			2469+	EPSW	R2, R0	exptract psw
00002EEC	5020 8EE8		000010E8	2470+	ST	R2, CCPSW	to save CC
00002EF0	07FB			2471+	BR	R11	return
00002EF4				2472+RE59	DC	OF	
00002EF4				2473+	DROP	R5	
00002EF4	00000000 00000000			2474	DC	XL16' 0000000000000000099999999999999C'	
00002EFC	09999999 9999999C						
				2475			
				2476	VRI_F	VDP, - 9999999999999999, - 1, 159, 3, 2	m5=3(P1=1)
00002F08				2477+	DS	OFD	
00002F08		00002F08		2478+	USING	*, R5	base for test data and test routine
00002F08	00002F38			2479+T60	DC	A(X60)	address of test routine
00002F0C	003C			2480+	DC	H' 60'	test number
00002F0E	00			2481+	DC	X' 00'	
00002F0F	9F			2482+	DC	HL1' 159'	i4
00002F10	03			2483+	DC	HL1' 3'	m5
00002F11	02			2484+	DC	HL1' 2'	cc
00002F12	0D			2485+	DC	HL1' 13'	cc failed mask
				2486+V2_60	DC	FD' - 9999999999999999' \	
00002F18	FFDC790D 903F0001			+			binary value for v2 packed decimal
00002F20	FFFFFFFF FFFFFFFF			2487+V3_60	DC	FD' - 1'	binary value for v3 packed decimal
00002F28	E5C4D740 40404040			2488+	DC	CL8' VDP'	instruction name
00002F30	00000010			2489+	DC	A(16)	result length
00002F34	00002F74			2490+REA60	DC	A(RE60)	result address
				2491+*			INSTRUCTION UNDER TEST ROUTINE
00002F38				2492+X60	DS	OF	
00002F38	E320 5010 0004		00002F18	2493+	LG	R2, V2_60	convert v2
00002F3E	E320 8F57 002E		00001157	2494+	CVDG	R2, V2PACKED	
00002F44	E720 8F57 0006		00001157	2495+	VL	V2, V2PACKED	
00002F4A	E320 5018 0004		00002F20	2496+	LG	R2, V3_60	convert v3
00002F50	E320 8F67 002E		00001167	2497+	CVDG	R2, V3PACKED	
00002F56	E730 8F67 0006		00001167	2498+	VL	V3, V3PACKED	
00002F5C	E612 3039 F07A			2499+	VDP	V1, V2, V3, 159, 3	test instruction
00002F62	E710 8F08 000E		00001108	2500+	VST	V1, V10OUTPUT	save result
00002F68	B98D 0020			2501+	EPSW	R2, R0	exptract psw
00002F6C	5020 8EE8		000010E8	2502+	ST	R2, CCPSW	to save CC
00002F70	07FB			2503+	BR	R11	return
00002F74				2504+RE60	DC	OF	
00002F74				2505+	DROP	R5	
00002F74	00000000 00000009			2506	DC	XL16' 0000000000000000099999999999999F'	
00002F7C	99999999 9999999F						
				2507			
				2508 *			m5=13(P2=1, P3=1)

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
00002F88				2509	VRI_F VDP, +9999999999999999, -1, 135, 13, 3	i4=135(iom=1 & rdc=7)
00002F88		00002F88		2510+	DS OFD	
00002F88	00002FB8			2511+	USING *, R5	base for test data and test routine
00002F8C	003D			2512+T61	DC A(X61)	address of test routine
00002F8E	00			2513+	DC H' 61'	test number
00002F8F	87			2514+	DC X' 00'	
00002F90	0D			2515+	DC HL1' 135'	i4
00002F91	03			2516+	DC HL1' 13'	m5
00002F92	0E			2517+	DC HL1' 3'	cc
				2518+	DC HL1' 14'	cc failed mask
				2519+V2_61	DC FD' +9999999999999999' \	
00002F98	002386F2 6FC0FFFF			+		binary value for v2 packed decimal
00002FA0	FFFFFFFF FFFFFFFF			2520+V3_61	DC FD' - 1'	binary value for v3 packed decimal
00002FA8	E5C4D740 40404040			2521+	DC CL8' VDP'	instruction name
00002FB0	00000010			2522+	DC A(16)	result length
00002FB4	00002FF4			2523+REA61	DC A(RE61)	result address
				2524+*		INSTRUCTION UNDER TEST ROUTINE
00002FB8				2525+X61	DS OF	
00002FB8	E320 5010 0004		00002F98	2526+	LG R2, V2_61	convert v2
00002FBE	E320 8F57 002E		00001157	2527+	CVDG R2, V2PACKED	
00002FC4	E720 8F57 0006		00001157	2528+	VL V2, V2PACKED	
00002FCA	E320 5018 0004		00002FA0	2529+	LG R2, V3_61	convert v3
00002FD0	E320 8F67 002E		00001167	2530+	CVDG R2, V3PACKED	
00002FD6	E730 8F67 0006		00001167	2531+	VL V3, V3PACKED	
00002FDC	E612 30D8 707A			2532+	VDP V1, V2, V3, 135, 13	test instruction
00002FE2	E710 8F08 000E		00001108	2533+	VST V1, V10UTPUT	save result
00002FE8	B98D 0020			2534+	EPSW R2, R0	exptract psw
00002FEC	5020 8EE8		000010E8	2535+	ST R2, CCPSW	to save CC
00002FF0	07FB			2536+	BR R11	return
00002FF4				2537+RE61	DC OF	
00002FF4				2538+	DROP R5	
00002FF4	00000000 00000000			2539	DC XL16' 00000000000000000000000009999999C'	overflow RDC
00002FFC	00000000 9999999C					
				2540		
00003008				2541	VRI_F VDP, +9999999999999999, +1234, 159, 3, 2	m5=3(P1=1)
00003008		00003008		2542+	DS OFD	
00003008	00003038			2543+	USING *, R5	base for test data and test routine
0000300C	003E			2544+T62	DC A(X62)	address of test routine
0000300E	00			2545+	DC H' 62'	test number
0000300F	9F			2546+	DC X' 00'	
00003010	03			2547+	DC HL1' 159'	i4
00003011	02			2548+	DC HL1' 3'	m5
00003012	0D			2549+	DC HL1' 2'	cc
				2550+	DC HL1' 13'	cc failed mask
				2551+V2_62	DC FD' +9999999999999999' \	
00003018	00000918 4E729FFF			+		binary value for v2 packed decimal
00003020	00000000 000004D2			2552+V3_62	DC FD' +1234'	binary value for v3 packed decimal
00003028	E5C4D740 40404040			2553+	DC CL8' VDP'	instruction name
00003030	00000010			2554+	DC A(16)	result length
00003034	00003074			2555+REA62	DC A(RE62)	result address
				2556+*		INSTRUCTION UNDER TEST ROUTINE
00003038				2557+X62	DS OF	
00003038	E320 5010 0004		00003018	2558+	LG R2, V2_62	convert v2
0000303E	E320 8F57 002E		00001157	2559+	CVDG R2, V2PACKED	
00003044	E720 8F57 0006		00001157	2560+	VL V2, V2PACKED	
0000304A	E320 5018 0004		00003020	2561+	LG R2, V3_62	convert v3

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
00003050	E320 8F67 002E		00001167	2562+	CVDG	R2, V3PACKED	
00003056	E730 8F67 0006		00001167	2563+	VL	V3, V3PACKED	
0000305C	E612 3039 F07A			2564+	VDP	V1, V2, V3, 159, 3	test instruction
00003062	E710 8F08 000E		00001108	2565+	VST	V1, V10OUTPUT	save result
00003068	B98D 0020			2566+	EPSW	R2, R0	exptract psw
0000306C	5020 8EE8		000010E8	2567+	ST	R2, CCPSW	to save CC
00003070	07FB			2568+	BR	R11	return
00003074				2569+RE62	DC	0F	
00003074				2570+	DROP	R5	
00003074	00000000 00000000			2571	DC	XL16' 000000000000000000000008103727714F'	
0000307C	00000810 3727714F						
				2572			
				2573 *			m5=15(P1=1, P2=1, P3=1)
				2574	VRI_F	VDP, - 999999999999999999, - 1234, 159, 15, 2	
00003088				2575+	DS	0FD	
00003088		00003088		2576+	USING	*, R5	base for test data and test routine
00003088	000030B8			2577+T63	DC	A(X63)	address of test routine
0000308C	003F			2578+	DC	H' 63'	test number
0000308E	00			2579+	DC	X' 00'	
0000308F	9F			2580+	DC	HL1' 159'	i4
00003090	0F			2581+	DC	HL1' 15'	m5
00003091	02			2582+	DC	HL1' 2'	cc
00003092	0D			2583+	DC	HL1' 13'	cc failed mask
				2584+V2_63	DC	FD' - 999999999999999999' \	
00003098	F21F494C 589C0001			+			binary value for v2 packed decimal
000030A0	FFFFFFFF FFFFB2E			2585+V3_63	DC	FD' - 1234'	binary value for v3 packed decimal
000030A8	E5C4D740 40404040			2586+	DC	CL8' VDP'	instruction name
000030B0	00000010			2587+	DC	A(16)	result length
000030B4	000030F4			2588+REA63	DC	A(RE63)	result address
				2589+*			INSTRUCTION UNDER TEST ROUTINE
000030B8				2590+X63	DS	0F	
000030B8	E320 5010 0004		00003098	2591+	LG	R2, V2_63	convert v2
000030BE	E320 8F57 002E		00001157	2592+	CVDG	R2, V2PACKED	
000030C4	E720 8F57 0006		00001157	2593+	VL	V2, V2PACKED	
000030CA	E320 5018 0004		000030A0	2594+	LG	R2, V3_63	convert v3
000030D0	E320 8F67 002E		00001167	2595+	CVDG	R2, V3PACKED	
000030D6	E730 8F67 0006		00001167	2596+	VL	V3, V3PACKED	
000030DC	E612 30F9 F07A			2597+	VDP	V1, V2, V3, 159, 15	test instruction
000030E2	E710 8F08 000E		00001108	2598+	VST	V1, V10OUTPUT	save result
000030E8	B98D 0020			2599+	EPSW	R2, R0	exptract psw
000030EC	5020 8EE8		000010E8	2600+	ST	R2, CCPSW	to save CC
000030F0	07FB			2601+	BR	R11	return
000030F4				2602+RE63	DC	0F	
000030F4				2603+	DROP	R5	
000030F4	00000000 00000000			2604	DC	XL16' 0000000000000000000810372771474878F'	
000030FC	81037277 1474878F						
				2605			
				2606 *			
				2607 * VRP		- VECTOR REMAINDER DECIMAL	
				2608 *			
				2609 * VRP simple		+ CC checks	
				2610	VRI_F	VRP, +10, +12, 7, 1, 2	
00003108				2611+	DS	0FD	
00003108		00003108		2612+	USING	*, R5	base for test data and test routine
00003108	00003138			2613+T64	DC	A(X64)	address of test routine
0000310C	0040			2614+	DC	H' 64'	test number

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
0000310E	00			2615+	DC	X' 00'
0000310F	07			2616+	DC	HL1' 7' i4
00003110	01			2617+	DC	HL1' 1' m5
00003111	02			2618+	DC	HL1' 2' cc
00003112	0D			2619+	DC	HL1' 13' cc failed mask
00003118	00000000 0000000A			2620+V2_64	DC	FD' +10' binary value for v2 packed decimal
00003120	00000000 0000000C			2621+V3_64	DC	FD' +12' binary value for v3 packed decimal
00003128	E5D9D740 40404040			2622+	DC	CL8' VRP' instruction name
00003130	00000010			2623+	DC	A(16) result length
00003134	00003174			2624+REA64	DC	A(RE64) result address
				2625+*		INSTRUCTION UNDER TEST ROUTINE
00003138				2626+X64	DS	0F
00003138	E320 5010 0004		00003118	2627+	LG	R2, V2_64 convert v2
0000313E	E320 8F57 002E		00001157	2628+	CVDG	R2, V2PACKED
00003144	E720 8F57 0006		00001157	2629+	VL	V2, V2PACKED
0000314A	E320 5018 0004		00003120	2630+	LG	R2, V3_64 convert v3
00003150	E320 8F67 002E		00001167	2631+	CVDG	R2, V3PACKED
00003156	E730 8F67 0006		00001167	2632+	VL	V3, V3PACKED
0000315C	E612 3010 707B			2633+	VRP	V1, V2, V3, 7, 1 test instruction
00003162	E710 8F08 000E		00001108	2634+	VST	V1, V10OUTPUT save result
00003168	B98D 0020			2635+	EPSW	R2, R0 exptract psw
0000316C	5020 8EE8		000010E8	2636+	ST	R2, CCPSW to save CC
00003170	07FB			2637+	BR	R11 return
00003174				2638+RE64	DC	0F
00003174				2639+	DROP	R5
00003174	00000000 00000000			2640	DC	XL16' 0000000000000000000000000000000010C'
0000317C	00000000 0000010C					
				2641		
				2642	VRI_F	VRP, - 100, +12, 7, 1, 1
00003188				2643+	DS	0FD
00003188		00003188		2644+	USING	*, R5 base for test data and test routine
00003188	000031B8			2645+T65	DC	A(X65) address of test routine
0000318C	0041			2646+	DC	H' 65' test number
0000318E	00			2647+	DC	X' 00'
0000318F	07			2648+	DC	HL1' 7' i4
00003190	01			2649+	DC	HL1' 1' m5
00003191	01			2650+	DC	HL1' 1' cc
00003192	0B			2651+	DC	HL1' 11' cc failed mask
00003198	FFFFFFFF FFFFFFF9C			2652+V2_65	DC	FD' - 100' binary value for v2 packed decimal
000031A0	00000000 0000000C			2653+V3_65	DC	FD' +12' binary value for v3 packed decimal
000031A8	E5D9D740 40404040			2654+	DC	CL8' VRP' instruction name
000031B0	00000010			2655+	DC	A(16) result length
000031B4	000031F4			2656+REA65	DC	A(RE65) result address
				2657+*		INSTRUCTION UNDER TEST ROUTINE
000031B8				2658+X65	DS	0F
000031B8	E320 5010 0004		00003198	2659+	LG	R2, V2_65 convert v2
000031BE	E320 8F57 002E		00001157	2660+	CVDG	R2, V2PACKED
000031C4	E720 8F57 0006		00001157	2661+	VL	V2, V2PACKED
000031CA	E320 5018 0004		000031A0	2662+	LG	R2, V3_65 convert v3
000031D0	E320 8F67 002E		00001167	2663+	CVDG	R2, V3PACKED
000031D6	E730 8F67 0006		00001167	2664+	VL	V3, V3PACKED
000031DC	E612 3010 707B			2665+	VRP	V1, V2, V3, 7, 1 test instruction
000031E2	E710 8F08 000E		00001108	2666+	VST	V1, V10OUTPUT save result
000031E8	B98D 0020			2667+	EPSW	R2, R0 exptract psw
000031EC	5020 8EE8		000010E8	2668+	ST	R2, CCPSW to save CC
000031F0	07FB			2669+	BR	R11 return

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
000031F4				2670+RE65	DC	0F
000031F4				2671+	DROP	R5
000031F4	00000000 00000000			2672	DC	XL16' 0000000000000000000000000000004D'
000031FC	00000000 0000004D					
				2673		
				2674	VRI_F	VRP, +100, - 12, 1, 1, 2 note rdc=1
00003208				2675+	DS	0FD
00003208		00003208		2676+	USING	*, R5 base for test data and test routine
00003208	00003238			2677+T66	DC	A(X66) address of test routine
0000320C	0042			2678+	DC	H' 66' test number
0000320E	00			2679+	DC	X' 00'
0000320F	01			2680+	DC	HL1' 1' i4
00003210	01			2681+	DC	HL1' 1' m5
00003211	02			2682+	DC	HL1' 2' cc
00003212	0D			2683+	DC	HL1' 13' cc failed mask
00003218	00000000 00000064			2684+V2_66	DC	FD' +100' binary value for v2 packed decimal
00003220	FFFFFFFF FFFFFFFF4			2685+V3_66	DC	FD' - 12' binary value for v3 packed decimal
00003228	E5D9D740 40404040			2686+	DC	CL8' VRP' instruction name
00003230	00000010			2687+	DC	A(16) result length
00003234	00003274			2688+REA66	DC	A(RE66) result address
				2689+*		INSTRUCTION UNDER TEST ROUTINE
00003238				2690+X66	DS	0F
00003238	E320 5010 0004		00003218	2691+	LG	R2, V2_66 convert v2
0000323E	E320 8F57 002E		00001157	2692+	CVDG	R2, V2PACKED
00003244	E720 8F57 0006		00001157	2693+	VL	V2, V2PACKED
0000324A	E320 5018 0004		00003220	2694+	LG	R2, V3_66 convert v3
00003250	E320 8F67 002E		00001167	2695+	CVDG	R2, V3PACKED
00003256	E730 8F67 0006		00001167	2696+	VL	V3, V3PACKED
0000325C	E612 3010 107B			2697+	VRP	V1, V2, V3, 1, 1 test instruction
00003262	E710 8F08 000E		00001108	2698+	VST	V1, V10UTPUT save result
00003268	B98D 0020			2699+	EPSW	R2, R0 exptract psw
0000326C	5020 8EE8		000010E8	2700+	ST	R2, CCPSW to save CC
00003270	07FB			2701+	BR	R11 return
00003274				2702+RE66	DC	0F
00003274				2703+	DROP	R5
00003274	00000000 00000000			2704	DC	XL16' 0000000000000000000000000000004C'
0000327C	00000000 0000004C					
				2705		
				2706	VRI_F	VRP, +100, - 12, 7, 1, 2
00003288				2707+	DS	0FD
00003288		00003288		2708+	USING	*, R5 base for test data and test routine
00003288	000032B8			2709+T67	DC	A(X67) address of test routine
0000328C	0043			2710+	DC	H' 67' test number
0000328E	00			2711+	DC	X' 00'
0000328F	07			2712+	DC	HL1' 7' i4
00003290	01			2713+	DC	HL1' 1' m5
00003291	02			2714+	DC	HL1' 2' cc
00003292	0D			2715+	DC	HL1' 13' cc failed mask
00003298	00000000 00000064			2716+V2_67	DC	FD' +100' binary value for v2 packed decimal
000032A0	FFFFFFFF FFFFFFFF4			2717+V3_67	DC	FD' - 12' binary value for v3 packed decimal
000032A8	E5D9D740 40404040			2718+	DC	CL8' VRP' instruction name
000032B0	00000010			2719+	DC	A(16) result length
000032B4	000032F4			2720+REA67	DC	A(RE67) result address
				2721+*		INSTRUCTION UNDER TEST ROUTINE
000032B8				2722+X67	DS	0F
000032B8	E320 5010 0004		00003298	2723+	LG	R2, V2_67 convert v2

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
0000353E	E320 8F57 002E		00001157	2885+	CVDG	R2, V2PACKED	
00003544	E720 8F57 0006		00001157	2886+	VL	V2, V2PACKED	
0000354A	E320 5018 0004		00003520	2887+	LG	R2, V3_72	convert v3
00003550	E320 8F67 002E		00001167	2888+	CVDG	R2, V3PACKED	
00003556	E730 8F67 0006		00001167	2889+	VL	V3, V3PACKED	
0000355C	E612 3019 F07B			2890+	VRP	V1, V2, V3, 159, 1	test instruction
00003562	E710 8F08 000E		00001108	2891+	VST	V1, V10OUTPUT	save result
00003568	B98D 0020			2892+	EPSW	R2, R0	exptract psw
0000356C	5020 8EE8		000010E8	2893+	ST	R2, CCPSW	to save CC
00003570	07FB			2894+	BR	R11	return
00003574				2895+RE72	DC	0F	
00003574				2896+	DROP	R5	
00003574	00000000 00000000			2897	DC	XL16' 0000000000000000000000000000999D'	
0000357C	00000000 0000999D						
				2898			
				2899	VRI_F	VRP, - 9999999999999999, - 47, 159, 1, 1	
00003588				2900+	DS	0FD	
00003588		00003588		2901+	USING	*, R5	base for test data and test routine
00003588	000035B8			2902+T73	DC	A(X73)	address of test routine
0000358C	0049			2903+	DC	H' 73'	test number
0000358E	00			2904+	DC	X' 00'	
0000358F	9F			2905+	DC	HL1' 159'	i4
00003590	01			2906+	DC	HL1' 1'	m5
00003591	01			2907+	DC	HL1' 1'	cc
00003592	0B			2908+	DC	HL1' 11'	cc failed mask
				2909+V2_73	DC	FD' - 9999999999999999' \	
00003598	FFDC790D 903F0001			+			binary value for v2 packed decimal
000035A0	FFFFFFFF FFFFFFFD1			2910+V3_73	DC	FD' - 47'	binary value for v3 packed decimal
000035A8	E5D9D740 40404040			2911+	DC	CL8' VRP'	instruction name
000035B0	00000010			2912+	DC	A(16)	result length
000035B4	000035F4			2913+REA73	DC	A(RE73)	result address
				2914+*			INSTRUCTION UNDER TEST ROUTINE
000035B8				2915+X73	DS	0F	
000035B8	E320 5010 0004		00003598	2916+	LG	R2, V2_73	convert v2
000035BE	E320 8F57 002E		00001157	2917+	CVDG	R2, V2PACKED	
000035C4	E720 8F57 0006		00001157	2918+	VL	V2, V2PACKED	
000035CA	E320 5018 0004		000035A0	2919+	LG	R2, V3_73	convert v3
000035D0	E320 8F67 002E		00001167	2920+	CVDG	R2, V3PACKED	
000035D6	E730 8F67 0006		00001167	2921+	VL	V3, V3PACKED	
000035DC	E612 3019 F07B			2922+	VRP	V1, V2, V3, 159, 1	test instruction
000035E2	E710 8F08 000E		00001108	2923+	VST	V1, V10OUTPUT	save result
000035E8	B98D 0020			2924+	EPSW	R2, R0	exptract psw
000035EC	5020 8EE8		000010E8	2925+	ST	R2, CCPSW	to save CC
000035F0	07FB			2926+	BR	R11	return
000035F4				2927+RE73	DC	0F	
000035F4				2928+	DROP	R5	
000035F4	00000000 00000000			2929	DC	XL16' 000000000000000000000000000023D'	
000035FC	00000000 0000023D						
				2930			
				2931	VRI_F	VRP, - 9999999999999, - 123456, 135, 1, 1 i4=135(iom=1 & rdc=7)	
00003608				2932+	DS	0FD	
00003608		00003608		2933+	USING	*, R5	base for test data and test routine
00003608	00003638			2934+T74	DC	A(X74)	address of test routine
0000360C	004A			2935+	DC	H' 74'	test number
0000360E	00			2936+	DC	X' 00'	
0000360F	87			2937+	DC	HL1' 135'	i4

LOC	OBJECT	CODE	ADDR1	ADDR2	STMT	
00003610	01				2938+	DC HL1' 1' m5
00003611	01				2939+	DC HL1' 1' cc
00003612	0B				2940+	DC HL1' 11' cc failed mask
00003618	FFFFFF17	2B5AF001			2941+V2_74	DC FD' - 999999999999' binary value for v2 packed decimal
00003620	FFFFFFFF	FFFE1DC0			2942+V3_74	DC FD' - 123456' binary value for v3 packed decimal
00003628	E5D9D740	40404040			2943+	DC CL8' VRP' instruction name
00003630	00000010				2944+	DC A(16) result length
00003634	00003674				2945+REA74	DC A(RE74) result address
					2946+*	INSTRUCTION UNDER TEST ROUTINE
00003638					2947+X74	DS OF
00003638	E320	5010	0004	00003618	2948+	LG R2, V2_74 convert v2
0000363E	E320	8F57	002E	00001157	2949+	CVDG R2, V2PACKED
00003644	E720	8F57	0006	00001157	2950+	VL V2, V2PACKED
0000364A	E320	5018	0004	00003620	2951+	LG R2, V3_74 convert v3
00003650	E320	8F67	002E	00001167	2952+	CVDG R2, V3PACKED
00003656	E730	8F67	0006	00001167	2953+	VL V3, V3PACKED
0000365C	E612	3018	707B		2954+	VRP V1, V2, V3, 135, 1 test instruction
00003662	E710	8F08	000E	00001108	2955+	VST V1, V10UTPUT save result
00003668	B98D	0020			2956+	EPSW R2, R0 exptract psw
0000366C	5020	8EE8		000010E8	2957+	ST R2, CCPSW to save CC
00003670	07FB				2958+	BR R11 return
00003674					2959+RE74	DC OF
00003674					2960+	DROP R5
00003674	00000000	00000000			2961	DC XL16' 0000000000000000000000000103743D'
0000367C	00000000	0103743D				
					2962	
					2963	VRI_F VRP, +999999999999, +1234, 159, 1, 2
00003688					2964+	DS OFD
00003688			00003688		2965+	USING *, R5 base for test data and test routine
00003688	000036B8				2966+T75	DC A(X75) address of test routine
0000368C	004B				2967+	DC H' 75' test number
0000368E	00				2968+	DC X' 00'
0000368F	9F				2969+	DC HL1' 159' i4
00003690	01				2970+	DC HL1' 1' m5
00003691	02				2971+	DC HL1' 2' cc
00003692	0D				2972+	DC HL1' 13' cc failed mask
					2973+V2_75	DC FD' +999999999999' \
00003698	00000918	4E729FFF			+	binary value for v2 packed decimal
000036A0	00000000	000004D2			2974+V3_75	DC FD' +1234' binary value for v3 packed decimal
000036A8	E5D9D740	40404040			2975+	DC CL8' VRP' instruction name
000036B0	00000010				2976+	DC A(16) result length
000036B4	000036F4				2977+REA75	DC A(RE75) result address
					2978+*	INSTRUCTION UNDER TEST ROUTINE
000036B8					2979+X75	DS OF
000036B8	E320	5010	0004	00003698	2980+	LG R2, V2_75 convert v2
000036BE	E320	8F57	002E	00001157	2981+	CVDG R2, V2PACKED
000036C4	E720	8F57	0006	00001157	2982+	VL V2, V2PACKED
000036CA	E320	5018	0004	000036A0	2983+	LG R2, V3_75 convert v3
000036D0	E320	8F67	002E	00001167	2984+	CVDG R2, V3PACKED
000036D6	E730	8F67	0006	00001167	2985+	VL V3, V3PACKED
000036DC	E612	3019	F07B		2986+	VRP V1, V2, V3, 159, 1 test instruction
000036E2	E710	8F08	000E	00001108	2987+	VST V1, V10UTPUT save result
000036E8	B98D	0020			2988+	EPSW R2, R0 exptract psw
000036EC	5020	8EE8		000010E8	2989+	ST R2, CCPSW to save CC
000036F0	07FB				2990+	BR R11 return
000036F4					2991+RE75	DC OF

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
000036F4				2992+	DROP R5	
000036F4	00000000 00000000			2993	DC XL16' 00000000000000000000000000000923C'	
000036FC	00000000 0000923C					
				2994		
				2995	VRI_F VRP, +9999999999999999, +1234, 159, 1, 2	
00003708				2996+	DS OFD	
00003708		00003708		2997+	USING *, R5	base for test data and test routine
00003708	00003738			2998+T76	DC A(X76)	address of test routine
0000370C	004C			2999+	DC H' 76'	test number
0000370E	00			3000+	DC X' 00'	
0000370F	9F			3001+	DC HL1' 159'	i4
00003710	01			3002+	DC HL1' 1'	m5
00003711	02			3003+	DC HL1' 2'	cc
00003712	0D			3004+	DC HL1' 13'	cc failed mask
				3005+V2_76	DC FD' +9999999999999999' \	
00003718	0DE0B6B3 A763FFFF			+		binary value for v2 packed decimal
00003720	00000000 000004D2			3006+V3_76	DC FD' +1234'	binary value for v3 packed decimal
00003728	E5D9D740 40404040			3007+	DC CL8' VRP'	instruction name
00003730	00000010			3008+	DC A(16)	result length
00003734	00003774			3009+REA76	DC A(RE76)	result address
				3010+*		INSTRUCTION UNDER TEST ROUTINE
00003738				3011+X76	DS OF	
00003738	E320 5010 0004		00003718	3012+	LG R2, V2_76	convert v2
0000373E	E320 8F57 002E		00001157	3013+	CVDG R2, V2PACKED	
00003744	E720 8F57 0006		00001157	3014+	VL V2, V2PACKED	
0000374A	E320 5018 0004		00003720	3015+	LG R2, V3_76	convert v3
00003750	E320 8F67 002E		00001167	3016+	CVDG R2, V3PACKED	
00003756	E730 8F67 0006		00001167	3017+	VL V3, V3PACKED	
0000375C	E612 3019 F07B			3018+	VRP V1, V2, V3, 159, 1	test instruction
00003762	E710 8F08 000E		00001108	3019+	VST V1, V10UTPUT	save result
00003768	B98D 0020			3020+	EPSW R2, R0	exptract psw
0000376C	5020 8EE8		000010E8	3021+	ST R2, CCPSW	to save CC
00003770	07FB			3022+	BR R11	return
00003774				3023+RE76	DC OF	
00003774				3024+	DROP R5	
00003774	00000000 00000000			3025	DC XL16' 0000000000000000000000000000547C'	
0000377C	00000000 0000547C					
				3026		
				3027 *	VRP larger #'s , i4=159(iom=1 & rdc=31)	CS=1 for all m5
				3028 *	check forced positive	
				3029	VRI_F VRP, - 9999999999999999, +13, 159, 9, 2	m5=9(P2=1)
00003788				3030+	DS OFD	
00003788		00003788		3031+	USING *, R5	base for test data and test routine
00003788	000037B8			3032+T77	DC A(X77)	address of test routine
0000378C	004D			3033+	DC H' 77'	test number
0000378E	00			3034+	DC X' 00'	
0000378F	9F			3035+	DC HL1' 159'	i4
00003790	09			3036+	DC HL1' 9'	m5
00003791	02			3037+	DC HL1' 2'	cc
00003792	0D			3038+	DC HL1' 13'	cc failed mask
				3039+V2_77	DC FD' - 9999999999999999' \	
00003798	FE9CBA87 A2760001			+		binary value for v2 packed decimal
000037A0	00000000 0000000D			3040+V3_77	DC FD' +13'	binary value for v3 packed decimal
000037A8	E5D9D740 40404040			3041+	DC CL8' VRP'	instruction name
000037B0	00000010			3042+	DC A(16)	result length
000037B4	000037F4			3043+REA77	DC A(RE77)	result address

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
0000388C	004F			3097+	DC	H' 79' test number
0000388E	00			3098+	DC	X' 00'
0000388F	9F			3099+	DC	HL1' 159' i4
00003890	03			3100+	DC	HL1' 3' m5
00003891	02			3101+	DC	HL1' 2' cc
00003892	0D			3102+	DC	HL1' 13' cc failed mask
				3103+V2_79	DC	FD' - 9999999999999999' \
00003898	FFDC790D 903F0001			+		binary value for v2 packed decimal
000038A0	FFFFFFFF FFFFFFFD1			3104+V3_79	DC	FD' - 47' binary value for v3 packed decimal
000038A8	E5D9D740 40404040			3105+	DC	CL8' VRP' instruction name
000038B0	00000010			3106+	DC	A(16) result length
000038B4	000038F4			3107+REA79	DC	A(RE79) result address
				3108+*		INSTRUCTION UNDER TEST ROUTINE
000038B8				3109+X79	DS	0F
000038B8	E320 5010 0004		00003898	3110+	LG	R2, V2_79 convert v2
000038BE	E320 8F57 002E		00001157	3111+	CVDG	R2, V2PACKED
000038C4	E720 8F57 0006		00001157	3112+	VL	V2, V2PACKED
000038CA	E320 5018 0004		000038A0	3113+	LG	R2, V3_79 convert v3
000038D0	E320 8F67 002E		00001167	3114+	CVDG	R2, V3PACKED
000038D6	E730 8F67 0006		00001167	3115+	VL	V3, V3PACKED
000038DC	E612 3039 F07B			3116+	VRP	V1, V2, V3, 159, 3 test instruction
000038E2	E710 8F08 000E		00001108	3117+	VST	V1, V10OUTPUT save result
000038E8	B98D 0020			3118+	EPSW	R2, R0 exptrect psw
000038EC	5020 8EE8		000010E8	3119+	ST	R2, CCPSW to save CC
000038F0	07FB			3120+	BR	R11 return
000038F4				3121+RE79	DC	0F
000038F4				3122+	DROP	R5
000038F4	00000000 00000000			3123	DC	XL16' 0000000000000000000000000000023F'
000038FC	00000000 0000023F					
				3124		
				3125 *		m5=13(P2=1, P3=1)
				3126	VRI_F	VRP, - 999999999999, - 123456, 135, 13, 2 i4=135(iom=1 & rdc=7)
00003908				3127+	DS	0FD
00003908		00003908		3128+	USING	*, R5 base for test data and test routine
00003908	00003938			3129+T80	DC	A(X80) address of test routine
0000390C	0050			3130+	DC	H' 80' test number
0000390E	00			3131+	DC	X' 00'
0000390F	87			3132+	DC	HL1' 135' i4
00003910	0D			3133+	DC	HL1' 13' m5
00003911	02			3134+	DC	HL1' 2' cc
00003912	0D			3135+	DC	HL1' 13' cc failed mask
00003918	FFFFFF17 2B5AF001			3136+V2_80	DC	FD' - 999999999999' binary value for v2 packed decimal
00003920	FFFFFFFF FFFE1DC0			3137+V3_80	DC	FD' - 123456' binary value for v3 packed decimal
00003928	E5D9D740 40404040			3138+	DC	CL8' VRP' instruction name
00003930	00000010			3139+	DC	A(16) result length
00003934	00003974			3140+REA80	DC	A(RE80) result address
				3141+*		INSTRUCTION UNDER TEST ROUTINE
00003938				3142+X80	DS	0F
00003938	E320 5010 0004		00003918	3143+	LG	R2, V2_80 convert v2
0000393E	E320 8F57 002E		00001157	3144+	CVDG	R2, V2PACKED
00003944	E720 8F57 0006		00001157	3145+	VL	V2, V2PACKED
0000394A	E320 5018 0004		00003920	3146+	LG	R2, V3_80 convert v3
00003950	E320 8F67 002E		00001167	3147+	CVDG	R2, V3PACKED
00003956	E730 8F67 0006		00001167	3148+	VL	V3, V3PACKED
0000395C	E612 30D8 707B			3149+	VRP	V1, V2, V3, 135, 13 test instruction
00003962	E710 8F08 000E		00001108	3150+	VST	V1, V10OUTPUT save result

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
00003A30	00000010			3203+	DC	A(16)	result length
00003A34	00003A74			3204+REA82	DC	A(RE82)	result address
				3205+*			INSTRUCTION UNDER TEST ROUTINE
00003A38				3206+X82	DS	OF	
00003A38	E320 5010 0004		00003A18	3207+	LG	R2, V2_82	convert v2
00003A3E	E320 8F57 002E		00001157	3208+	CVDG	R2, V2PACKED	
00003A44	E720 8F57 0006		00001157	3209+	VL	V2, V2PACKED	
00003A4A	E320 5018 0004		00003A20	3210+	LG	R2, V3_82	convert v3
00003A50	E320 8F67 002E		00001167	3211+	CVDG	R2, V3PACKED	
00003A56	E730 8F67 0006		00001167	3212+	VL	V3, V3PACKED	
00003A5C	E612 3039 F07B			3213+	VRP	V1, V2, V3, 159, 3	test instruction
00003A62	E710 8F08 000E		00001108	3214+	VST	V1, V10OUTPUT	save result
00003A68	B98D 0020			3215+	EPSW	R2, R0	exptract psw
00003A6C	5020 8EE8		000010E8	3216+	ST	R2, CCPSW	to save CC
00003A70	07FB			3217+	BR	R11	return
00003A74				3218+RE82	DC	OF	
00003A74				3219+	DROP	R5	
00003A74	00000000 00000000			3220	DC	XL16' 0000000000000000000000000000000547F'	
00003A7C	00000000 0000547F						
				3221			
				3222 *			
				3223 *	VMSP	- VECTOR MULTIPLY AND SHIFT DECIMAL	
				3224 *			
				3225 *	VMSP	simple + CC checks	
				3226 *		i4=128(iom=1 & shamt=0)	
				3227 *		i4=129(iom=1 & shamt=1)	
				3228 *		i4=132(iom=1 & shamt=4)	
				3229 *		i4=135(iom=1 & shamt=7)	
				3230 *		i4=142(iom=1 & shamt=14)	
				3231 *		i4=159(iom=1 & shamt=31)	
				3232			
				3233	VRI_F	VMSP, +10, +12, 129, 1, 2	shamt=1
00003A88				3234+	DS	OFD	
00003A88		00003A88		3235+	USING	*, R5	base for test data and test routine
00003A88	00003AB8			3236+T83	DC	A(X83)	address of test routine
00003A8C	0053			3237+	DC	H' 83'	test number
00003A8E	00			3238+	DC	X' 00'	
00003A8F	81			3239+	DC	HL1' 129'	i4
00003A90	01			3240+	DC	HL1' 1'	m5
00003A91	02			3241+	DC	HL1' 2'	cc
00003A92	0D			3242+	DC	HL1' 13'	cc failed mask
00003A98	00000000 0000000A			3243+V2_83	DC	FD' +10'	binary value for v2 packed decimal
00003AA0	00000000 0000000C			3244+V3_83	DC	FD' +12'	binary value for v3 packed decimal
00003AA8	E5D4E2D7 40404040			3245+	DC	CL8' VMSP'	instruction name
00003AB0	00000010			3246+	DC	A(16)	result length
00003AB4	00003AF4			3247+REA83	DC	A(RE83)	result address
				3248+*			INSTRUCTION UNDER TEST ROUTINE
00003AB8				3249+X83	DS	OF	
00003AB8	E320 5010 0004		00003A98	3250+	LG	R2, V2_83	convert v2
00003ABE	E320 8F57 002E		00001157	3251+	CVDG	R2, V2PACKED	
00003AC4	E720 8F57 0006		00001157	3252+	VL	V2, V2PACKED	
00003ACA	E320 5018 0004		00003AA0	3253+	LG	R2, V3_83	convert v3
00003AD0	E320 8F67 002E		00001167	3254+	CVDG	R2, V3PACKED	
00003AD6	E730 8F67 0006		00001167	3255+	VL	V3, V3PACKED	
00003ADC	E612 3018 1079			3256+	VMSP	V1, V2, V3, 129, 1	test instruction
00003AE2	E710 8F08 000E		00001108	3257+	VST	V1, V10OUTPUT	save result

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
00003AE8	B98D 0020			3258+	EPSW	R2, R0	exptract psw
00003AEC	5020 8EE8		000010E8	3259+	ST	R2, CCPSW	to save CC
00003AF0	07FB			3260+	BR	R11	return
00003AF4				3261+RE83	DC	0F	
00003AF4				3262+	DROP	R5	
00003AF4	00000000 00000000			3263	DC	XL16' 0000000000000000000000000000000012C'	
00003AFC	00000000 0000012C						
				3264			
				3265	VRI_F	VMSP, - 100, +12, 129, 1, 1	shamt=1
00003B08				3266+	DS	0FD	
00003B08		00003B08		3267+	USING	*, R5	base for test data and test routine
00003B08	00003B38			3268+T84	DC	A(X84)	address of test routine
00003B0C	0054			3269+	DC	H' 84'	test number
00003B0E	00			3270+	DC	X' 00'	
00003B0F	81			3271+	DC	HL1' 129'	i4
00003B10	01			3272+	DC	HL1' 1'	m5
00003B11	01			3273+	DC	HL1' 1'	cc
00003B12	0B			3274+	DC	HL1' 11'	cc failed mask
00003B18	FFFFFFFF FFFFFFF9C			3275+V2_84	DC	FD' - 100'	binary value for v2 packed decimal
00003B20	00000000 0000000C			3276+V3_84	DC	FD' +12'	binary value for v3 packed decimal
00003B28	E5D4E2D7 40404040			3277+	DC	CL8' VMSP'	instruction name
00003B30	00000010			3278+	DC	A(16)	result length
00003B34	00003B74			3279+REA84	DC	A(RE84)	result address
				3280+*			INSTRUCTION UNDER TEST ROUTINE
00003B38				3281+X84	DS	0F	
00003B38	E320 5010 0004		00003B18	3282+	LG	R2, V2_84	convert v2
00003B3E	E320 8F57 002E		00001157	3283+	CVDG	R2, V2PACKED	
00003B44	E720 8F57 0006		00001157	3284+	VL	V2, V2PACKED	
00003B4A	E320 5018 0004		00003B20	3285+	LG	R2, V3_84	convert v3
00003B50	E320 8F67 002E		00001167	3286+	CVDG	R2, V3PACKED	
00003B56	E730 8F67 0006		00001167	3287+	VL	V3, V3PACKED	
00003B5C	E612 3018 1079			3288+	VMSP	V1, V2, V3, 129, 1	test instruction
00003B62	E710 8F08 000E		00001108	3289+	VST	V1, V10UTPUT	save result
00003B68	B98D 0020			3290+	EPSW	R2, R0	exptract psw
00003B6C	5020 8EE8		000010E8	3291+	ST	R2, CCPSW	to save CC
00003B70	07FB			3292+	BR	R11	return
00003B74				3293+RE84	DC	0F	
00003B74				3294+	DROP	R5	
00003B74	00000000 00000000			3295	DC	XL16' 00000000000000000000000000000000120D'	
00003B7C	00000000 0000120D						
				3296			
				3297	VRI_F	VMSP, +100, - 12, 128, 1, 1	shamt=0
00003B88				3298+	DS	0FD	
00003B88		00003B88		3299+	USING	*, R5	base for test data and test routine
00003B88	00003BB8			3300+T85	DC	A(X85)	address of test routine
00003B8C	0055			3301+	DC	H' 85'	test number
00003B8E	00			3302+	DC	X' 00'	
00003B8F	80			3303+	DC	HL1' 128'	i4
00003B90	01			3304+	DC	HL1' 1'	m5
00003B91	01			3305+	DC	HL1' 1'	cc
00003B92	0B			3306+	DC	HL1' 11'	cc failed mask
00003B98	00000000 00000064			3307+V2_85	DC	FD' +100'	binary value for v2 packed decimal
00003BA0	FFFFFFFF FFFFFFFF4			3308+V3_85	DC	FD' - 12'	binary value for v3 packed decimal
00003BA8	E5D4E2D7 40404040			3309+	DC	CL8' VMSP'	instruction name
00003BB0	00000010			3310+	DC	A(16)	result length
00003BB4	00003BF4			3311+REA85	DC	A(RE85)	result address

[illegible]

[illegible]

[illegible]

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
00003E38				3474+X90	DS	0F	
00003E38	E320 5010 0004		00003E18	3475+	LG	R2, V2_90	convert v2
00003E3E	E320 8F57 002E		00001157	3476+	CVDG	R2, V2PACKED	
00003E44	E720 8F57 0006		00001157	3477+	VL	V2, V2PACKED	
00003E4A	E320 5018 0004		00003E20	3478+	LG	R2, V3_90	convert v3
00003E50	E320 8F67 002E		00001167	3479+	CVDG	R2, V3PACKED	
00003E56	E730 8F67 0006		00001167	3480+	VL	V3, V3PACKED	
00003E5C	E612 3018 E079			3481+	VMSP	V1, V2, V3, 142, 1	test instruction
00003E62	E710 8F08 000E		00001108	3482+	VST	V1, V10UTPUT	save result
00003E68	B98D 0020			3483+	EPSW	R2, R0	exptract psw
00003E6C	5020 8EE8		000010E8	3484+	ST	R2, CCPSW	to save CC
00003E70	07FB			3485+	BR	R11	return
00003E74				3486+RE90	DC	0F	
00003E74				3487+	DROP	R5	
00003E74	00000000 00000000			3488	DC	XL16' 0000000000000000000000000000999C'	
00003E7C	00000000 0000999C						
				3489			
				3490 *			shamt=14
				3491	VRI_F	VMSP, +9999999999999999, +10000000000000000, 142, 1, 2	
00003E88				3492+	DS	0FD	
00003E88		00003E88		3493+	USING	*, R5	base for test data and test routine
00003E88	00003EB8			3494+T91	DC	A(X91)	address of test routine
00003E8C	005B			3495+	DC	H' 91'	test number
00003E8E	00			3496+	DC	X' 00'	
00003E8F	8E			3497+	DC	HL1' 142'	i4
00003E90	01			3498+	DC	HL1' 1'	m5
00003E91	02			3499+	DC	HL1' 2'	cc
00003E92	0D			3500+	DC	HL1' 13'	cc failed mask
				3501+V2_91	DC	FD' +9999999999999999' \	
00003E98	01634578 5D89FFFF			+			binary value for v2 packed decimal
				3502+V3_91	DC	FD' +10000000000000000' \	
				+			binary value for v3 packed decimal
00003EA0	002386F2 6FC10000			3503+	DC	CL8' VMSP'	instruction name
00003EA8	E5D4E2D7 40404040			3504+	DC	A(16)	result length
00003EB0	00000010			3505+REA91	DC	A(RE91)	result address
00003EB4	00003EF4			3506+*			INSTRUCTION UNDER TEST ROUTINE
00003EB8				3507+X91	DS	0F	
00003EB8	E320 5010 0004		00003E98	3508+	LG	R2, V2_91	convert v2
00003EBE	E320 8F57 002E		00001157	3509+	CVDG	R2, V2PACKED	
00003EC4	E720 8F57 0006		00001157	3510+	VL	V2, V2PACKED	
00003ECA	E320 5018 0004		00003EA0	3511+	LG	R2, V3_91	convert v3
00003ED0	E320 8F67 002E		00001167	3512+	CVDG	R2, V3PACKED	
00003ED6	E730 8F67 0006		00001167	3513+	VL	V3, V3PACKED	
00003EDC	E612 3018 E079			3514+	VMSP	V1, V2, V3, 142, 1	test instruction
00003EE2	E710 8F08 000E		00001108	3515+	VST	V1, V10UTPUT	save result
00003EE8	B98D 0020			3516+	EPSW	R2, R0	exptract psw
00003EEC	5020 8EE8		000010E8	3517+	ST	R2, CCPSW	to save CC
00003EF0	07FB			3518+	BR	R11	return
00003EF4				3519+RE91	DC	0F	
00003EF4				3520+	DROP	R5	
00003EF4	00000000 00009999			3521	DC	XL16' 000000000000999999999999999900C'	
00003EFC	99999999 9999900C						
				3522			
				3523	VRI_F	VMSP, - 9999999999999999, - 1, 159, 1, 0	shamt=31
00003F08				3524+	DS	0FD	
00003F08		00003F08		3525+	USING	*, R5	base for test data and test routine

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
00003F08	00003F38			3526+T92	DC	A(X92)	address of test routine
00003F0C	005C			3527+	DC	H' 92'	test number
00003F0E	00			3528+	DC	X' 00'	
00003F0F	9F			3529+	DC	HL1' 159'	i4
00003F10	01			3530+	DC	HL1' 1'	m5
00003F11	00			3531+	DC	HL1' 0'	cc
00003F12	07			3532+	DC	HL1' 7'	cc failed mask
				3533+V2_92	DC	FD' - 9999999999999999' \	
00003F18	FFDC790D 903F0001			+			binary value for v2 packed decimal
00003F20	FFFFFFFF FFFFFFFF			3534+V3_92	DC	FD' - 1'	binary value for v3 packed decimal
00003F28	E5D4E2D7 40404040			3535+	DC	CL8' VMSP'	instruction name
00003F30	00000010			3536+	DC	A(16)	result length
00003F34	00003F74			3537+REA92	DC	A(RE92)	result address
				3538+*			INSTRUCTION UNDER TEST ROUTINE
00003F38				3539+X92	DS	0F	
00003F38	E320 5010 0004		00003F18	3540+	LG	R2, V2_92	convert v2
00003F3E	E320 8F57 002E		00001157	3541+	CVDG	R2, V2PACKED	
00003F44	E720 8F57 0006		00001157	3542+	VL	V2, V2PACKED	
00003F4A	E320 5018 0004		00003F20	3543+	LG	R2, V3_92	convert v3
00003F50	E320 8F67 002E		00001167	3544+	CVDG	R2, V3PACKED	
00003F56	E730 8F67 0006		00001167	3545+	VL	V3, V3PACKED	
00003F5C	E612 3019 F079			3546+	VMSP	V1, V2, V3, 159, 1	test instruction
00003F62	E710 8F08 000E		00001108	3547+	VST	V1, V10UTPUT	save result
00003F68	B98D 0020			3548+	EPSW	R2, R0	exptract psw
00003F6C	5020 8EE8		000010E8	3549+	ST	R2, CCPSW	to save CC
00003F70	07FB			3550+	BR	R11	return
00003F74				3551+RE92	DC	0F	
00003F74				3552+	DROP	R5	
00003F74	00000000 00000000			3553	DC	XL16' 00000000000000000000000000000000C'	
00003F7C	00000000 0000000C						
				3554			
				3555	VRI_F	VMSP, - 9999999999999999, - 1, 135, 1, 2	shamt=7
00003F88				3556+	DS	0FD	
00003F88		00003F88		3557+	USING	*, R5	base for test data and test routine
00003F88	00003FB8			3558+T93	DC	A(X93)	address of test routine
00003F8C	005D			3559+	DC	H' 93'	test number
00003F8E	00			3560+	DC	X' 00'	
00003F8F	87			3561+	DC	HL1' 135'	i4
00003F90	01			3562+	DC	HL1' 1'	m5
00003F91	02			3563+	DC	HL1' 2'	cc
00003F92	0D			3564+	DC	HL1' 13'	cc failed mask
				3565+V2_93	DC	FD' - 9999999999999999' \	
00003F98	FFDC790D 903F0001			+			binary value for v2 packed decimal
00003FA0	FFFFFFFF FFFFFFFF			3566+V3_93	DC	FD' - 1'	binary value for v3 packed decimal
00003FA8	E5D4E2D7 40404040			3567+	DC	CL8' VMSP'	instruction name
00003FB0	00000010			3568+	DC	A(16)	result length
00003FB4	00003FF4			3569+REA93	DC	A(RE93)	result address
				3570+*			INSTRUCTION UNDER TEST ROUTINE
00003FB8				3571+X93	DS	0F	
00003FB8	E320 5010 0004		00003F98	3572+	LG	R2, V2_93	convert v2
00003FBE	E320 8F57 002E		00001157	3573+	CVDG	R2, V2PACKED	
00003FC4	E720 8F57 0006		00001157	3574+	VL	V2, V2PACKED	
00003FCA	E320 5018 0004		00003FA0	3575+	LG	R2, V3_93	convert v3
00003FD0	E320 8F67 002E		00001167	3576+	CVDG	R2, V3PACKED	
00003FD6	E730 8F67 0006		00001167	3577+	VL	V3, V3PACKED	
00003FDC	E612 3018 7079			3578+	VMSP	V1, V2, V3, 135, 1	test instruction

LOC	OBJECT CODE			ADDR1	ADDR2	STMT				
00003FE2	E710	8F08	000E		00001108	3579+	VST	V1, V10	OUTPUT	save result
00003FE8	B98D	0020				3580+	EPSW	R2, R0		exptrect psw
00003FEC	5020	8EE8			000010E8	3581+	ST	R2, CCPSW		to save CC
00003FF0	07FB					3582+	BR	R11		return
00003FF4						3583+RE93	DC	OF		
00003FF4						3584+	DROP	R5		
00003FF4	00000000	00000000				3585	DC	XL16'	0000000000000000000000000999999999C'	
00003FFC	00000099	9999999C								
						3586				
						3587	VRI_F	VMSP, - 99999999999999, +10000000000000, 159, 1, 0 shamt=31		
00004008						3588+	DS	OFD		
00004008				00004008		3589+	USING	*, R5		base for test data and test routine
00004008	00004038					3590+T94	DC	A(X94)		address of test routine
0000400C	005E					3591+	DC	H' 94'		test number
0000400E	00					3592+	DC	X' 00'		
0000400F	9F					3593+	DC	HL1' 159'		i4
00004010	01					3594+	DC	HL1' 1'		m5
00004011	00					3595+	DC	HL1' 0'		cc
00004012	07					3596+	DC	HL1' 7'		cc failed mask
						3597+V2_94	DC	FD' - 99999999999999'	\	
00004018	FFFFF6E7	B18D6001				+				binary value for v2 packed decimal
						3598+V3_94	DC	FD' +100000000000000'	\	
00004020	00000918	4E72A000				+				binary value for v3 packed decimal
00004028	E5D4E2D7	40404040				3599+	DC	CL8' VMSP'		instruction name
00004030	00000010					3600+	DC	A(16)		result length
00004034	00004074					3601+REA94	DC	A(RE94)		result address
						3602+*				INSTRUCTION UNDER TEST ROUTINE
00004038						3603+X94	DS	OF		
00004038	E320	5010	0004		00004018	3604+	LG	R2, V2_94		convert v2
0000403E	E320	8F57	002E		00001157	3605+	CVDG	R2, V2PACKED		
00004044	E720	8F57	0006		00001157	3606+	VL	V2, V2PACKED		
0000404A	E320	5018	0004		00004020	3607+	LG	R2, V3_94		convert v3
00004050	E320	8F67	002E		00001167	3608+	CVDG	R2, V3PACKED		
00004056	E730	8F67	0006		00001167	3609+	VL	V3, V3PACKED		
0000405C	E612	3019	F079			3610+	VMSP	V1, V2, V3, 159, 1		test instruction
00004062	E710	8F08	000E		00001108	3611+	VST	V1, V10	OUTPUT	save result
00004068	B98D	0020				3612+	EPSW	R2, R0		exptrect psw
0000406C	5020	8EE8			000010E8	3613+	ST	R2, CCPSW		to save CC
00004070	07FB					3614+	BR	R11		return
00004074						3615+RE94	DC	OF		
00004074						3616+	DROP	R5		
00004074	00000000	00000000				3617	DC	XL16'	00000000000000000000000000000000C' NOTE Plus 0	
0000407C	00000000	0000000C								
						3618				
						3619 *	VMSP larger #'s , i4=159(iom=1 & rdc=31)			CS=1 for all m5
						3620 *	check forced positive			
						3621 *				shamt=1
						3622	VRI_F	VMSP, - 999999999999999999, +1, 129, 9, 2		m5=9(P2=1)
00004088						3623+	DS	OFD		
00004088				00004088		3624+	USING	*, R5		base for test data and test routine
00004088	000040B8					3625+T95	DC	A(X95)		address of test routine
0000408C	005F					3626+	DC	H' 95'		test number
0000408E	00					3627+	DC	X' 00'		
0000408F	81					3628+	DC	HL1' 129'		i4
00004090	09					3629+	DC	HL1' 9'		m5
00004091	02					3630+	DC	HL1' 2'		cc

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
00004092	0D			3631+	DC	HL1' 13'	cc failed mask
				3632+V2_95	DC	FD' - 9999999999999999'	\
00004098	FE9CBA87 A2760001			+			binary value for v2 packed decimal
000040A0	00000000 00000001			3633+V3_95	DC	FD' +1'	binary value for v3 packed decimal
000040A8	E5D4E2D7 40404040			3634+	DC	CL8' VMSP'	instruction name
000040B0	00000010			3635+	DC	A(16)	result length
000040B4	000040F4			3636+REA95	DC	A(RE95)	result address
				3637+*			INSTRUCTION UNDER TEST ROUTINE
000040B8				3638+X95	DS	0F	
000040B8	E320 5010 0004		00004098	3639+	LG	R2, V2_95	convert v2
000040BE	E320 8F57 002E		00001157	3640+	CVDG	R2, V2PACKED	
000040C4	E720 8F57 0006		00001157	3641+	VL	V2, V2PACKED	
000040CA	E320 5018 0004		000040A0	3642+	LG	R2, V3_95	convert v3
000040D0	E320 8F67 002E		00001167	3643+	CVDG	R2, V3PACKED	
000040D6	E730 8F67 0006		00001167	3644+	VL	V3, V3PACKED	
000040DC	E612 3098 1079			3645+	VMSP	V1, V2, V3, 129, 9	test instruction
000040E2	E710 8F08 000E		00001108	3646+	VST	V1, V10UTPUT	save result
000040E8	B98D 0020			3647+	EPSW	R2, R0	exptract psw
000040EC	5020 8EE8		000010E8	3648+	ST	R2, CCPSW	to save CC
000040F0	07FB			3649+	BR	R11	return
000040F4				3650+RE95	DC	0F	
000040F4				3651+	DROP	R5	
000040F4	00000000 00000009			3652	DC	XL16' 00000000000000009999999999999999C'	
000040FC	99999999 9999999C						
				3653			
				3654 *			shamt=7
				3655 *			m5=13(P2=1, P3=1)
				3656	VRI_F	VMSP, - 9999999999999999, - 1000000000000000, 135, 13, 2	
00004108				3657+	DS	0FD	
00004108		00004108		3658+	USING	*, R5	base for test data and test routine
00004108	00004138			3659+T96	DC	A(X96)	address of test routine
0000410C	0060			3660+	DC	H' 96'	test number
0000410E	00			3661+	DC	X' 00'	
0000410F	87			3662+	DC	HL1' 135'	i4
00004110	0D			3663+	DC	HL1' 13'	m5
00004111	02			3664+	DC	HL1' 2'	cc
00004112	0D			3665+	DC	HL1' 13'	cc failed mask
				3666+V2_96	DC	FD' - 9999999999999999'	\
00004118	FE9CBA87 A2760001			+			binary value for v2 packed decimal
				3667+V3_96	DC	FD' - 1000000000000000'	\
				+			binary value for v3 packed decimal
00004120	FFDC790D 903F0000						
00004128	E5D4E2D7 40404040			3668+	DC	CL8' VMSP'	instruction name
00004130	00000010			3669+	DC	A(16)	result length
00004134	00004174			3670+REA96	DC	A(RE96)	result address
				3671+*			INSTRUCTION UNDER TEST ROUTINE
00004138				3672+X96	DS	0F	
00004138	E320 5010 0004		00004118	3673+	LG	R2, V2_96	convert v2
0000413E	E320 8F57 002E		00001157	3674+	CVDG	R2, V2PACKED	
00004144	E720 8F57 0006		00001157	3675+	VL	V2, V2PACKED	
0000414A	E320 5018 0004		00004120	3676+	LG	R2, V3_96	convert v3
00004150	E320 8F67 002E		00001167	3677+	CVDG	R2, V3PACKED	
00004156	E730 8F67 0006		00001167	3678+	VL	V3, V3PACKED	
0000415C	E612 30D8 7079			3679+	VMSP	V1, V2, V3, 135, 13	test instruction
00004162	E710 8F08 000E		00001108	3680+	VST	V1, V10UTPUT	save result
00004168	B98D 0020			3681+	EPSW	R2, R0	exptract psw
0000416C	5020 8EE8		000010E8	3682+	ST	R2, CCPSW	to save CC

[illegible]

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
00004228	E5D4E2D7 40404040			3735+	DC	CL8' VMSP'	instruction name
00004230	00000010			3736+	DC	A(16)	result length
00004234	00004274			3737+REA98	DC	A(RE98)	result address
				3738+*			INSTRUCTION UNDER TEST ROUTINE
00004238				3739+X98	DS	OF	
00004238	E320 5010 0004		00004218	3740+	LG	R2, V2_98	convert v2
0000423E	E320 8F57 002E		00001157	3741+	CVDG	R2, V2PACKED	
00004244	E720 8F57 0006		00001157	3742+	VL	V2, V2PACKED	
0000424A	E320 5018 0004		00004220	3743+	LG	R2, V3_98	convert v3
00004250	E320 8F67 002E		00001167	3744+	CVDG	R2, V3PACKED	
00004256	E730 8F67 0006		00001167	3745+	VL	V3, V3PACKED	
0000425C	E612 30D8 4079			3746+	VMSP	V1, V2, V3, 132, 13	test instruction
00004262	E710 8F08 000E		00001108	3747+	VST	V1, V10OUTPUT	save result
00004268	B98D 0020			3748+	EPSW	R2, R0	exptract psw
0000426C	5020 8EE8		000010E8	3749+	ST	R2, CCPSW	to save CC
00004270	07FB			3750+	BR	R11	return
00004274				3751+RE98	DC	OF	
00004274				3752+	DROP	R5	
00004274	00000000 00000000			3753	DC	XL16' 00000000000000000000099999999999C'	
0000427C	00099999 9999999C						
				3754			
				3755 *			shamt=31
				3756 *			m5=3(P1=1)
				3757	VRI_F	VMSP, +9999999999999999, +1000000000000000, 159, 3, 2	
00004288				3758+	DS	OFD	
00004288		00004288		3759+	USING	*, R5	base for test data and test routine
00004288	000042B8			3760+T99	DC	A(X99)	address of test routine
0000428C	0063			3761+	DC	H' 99'	test number
0000428E	00			3762+	DC	X' 00'	
0000428F	9F			3763+	DC	HL1' 159'	i4
00004290	03			3764+	DC	HL1' 3'	m5
00004291	02			3765+	DC	HL1' 2'	cc
00004292	0D			3766+	DC	HL1' 13'	cc failed mask
				3767+V2_99	DC	FD' +9999999999999999' \	
00004298	01634578 5D89FFFF			+			binary value for v2 packed decimal
				3768+V3_99	DC	FD' +1000000000000000' \	
				+			binary value for v3 packed decimal
000042A0	002386F2 6FC10000			3769+	DC	CL8' VMSP'	instruction name
000042A8	E5D4E2D7 40404040			3770+	DC	A(16)	result length
000042B0	00000010			3771+REA99	DC	A(RE99)	result address
000042B4	000042F4			3772+*			INSTRUCTION UNDER TEST ROUTINE
000042B8				3773+X99	DS	OF	
000042B8	E320 5010 0004		00004298	3774+	LG	R2, V2_99	convert v2
000042BE	E320 8F57 002E		00001157	3775+	CVDG	R2, V2PACKED	
000042C4	E720 8F57 0006		00001157	3776+	VL	V2, V2PACKED	
000042CA	E320 5018 0004		000042A0	3777+	LG	R2, V3_99	convert v3
000042D0	E320 8F67 002E		00001167	3778+	CVDG	R2, V3PACKED	
000042D6	E730 8F67 0006		00001167	3779+	VL	V3, V3PACKED	
000042DC	E612 3039 F079			3780+	VMSP	V1, V2, V3, 159, 3	test instruction
000042E2	E710 8F08 000E		00001108	3781+	VST	V1, V10OUTPUT	save result
000042E8	B98D 0020			3782+	EPSW	R2, R0	exptract psw
000042EC	5020 8EE8		000010E8	3783+	ST	R2, CCPSW	to save CC
000042F0	07FB			3784+	BR	R11	return
000042F4				3785+RE99	DC	OF	
000042F4				3786+	DROP	R5	
000042F4	00000000 00000000			3787	DC	XL16' 000000000000000000000000000099F'	

LOC	OBJECT CODE	ADDR1	ADDR2	STMT	
000042FC	00000000	0000099F		3788	
				3789 *	-----
				3790 * VSDP	- VECTOR SHIFT AND DIVIDE DECIMAL
				3791 *	-----
				3792 * VSDP	simple + CC checks
				3793 *	i4=128(iom=1 & shamt=0)
				3794 *	i4=129(iom=1 & shamt=1)
				3795 *	i4=132(iom=1 & shamt=4)
				3796 *	i4=135(iom=1 & shamt=7)
				3797 *	i4=142(iom=1 & shamt=14)
				3798 *	i4=159(iom=1 & shamt=31)
				3799	
				3800	VRI_F VSDP, +10, +12, 128, 1, 0 shamt=0
00004308				3801+	DS OFD
00004308		00004308		3802+	USING *, R5 base for test data and test routine
00004308	00004338			3803+T100	DC A(X100) address of test routine
0000430C	0064			3804+	DC H' 100' test number
0000430E	00			3805+	DC X' 00'
0000430F	80			3806+	DC HL1' 128' i4
00004310	01			3807+	DC HL1' 1' m5
00004311	00			3808+	DC HL1' 0' cc
00004312	07			3809+	DC HL1' 7' cc failed mask
00004318	00000000	0000000A		3810+V2_100	DC FD' +10' binary value for v2 packed decimal
00004320	00000000	0000000C		3811+V3_100	DC FD' +12' binary value for v3 packed decimal
00004328	E5E2C4D7	40404040		3812+	DC CL8' VSDP' instruction name
00004330	00000010			3813+	DC A(16) result length
00004334	00004374			3814+REA100	DC A(RE100) result address
				3815+*	INSTRUCTION UNDER TEST ROUTINE
00004338				3816+X100	DS OF
00004338	E320 5010 0004		00004318	3817+	LG R2, V2_100 convert v2
0000433E	E320 8F57 002E		00001157	3818+	CVDG R2, V2PACKED
00004344	E720 8F57 0006		00001157	3819+	VL V2, V2PACKED
0000434A	E320 5018 0004		00004320	3820+	LG R2, V3_100 convert v3
00004350	E320 8F67 002E		00001167	3821+	CVDG R2, V3PACKED
00004356	E730 8F67 0006		00001167	3822+	VL V3, V3PACKED
0000435C	E612 3018 007E			3823+	VSDP V1, V2, V3, 128, 1 test instruction
00004362	E710 8F08 000E		00001108	3824+	VST V1, V10UTPUT save result
00004368	B98D 0020			3825+	EPSW R2, R0 exptrect psw
0000436C	5020 8EE8		000010E8	3826+	ST R2, CCPSW to save CC
00004370	07FB			3827+	BR R11 return
00004374				3828+RE100	DC OF
00004374				3829+	DROP R5
00004374	00000000	00000000		3830	DC XL16' 00000000000000000000000000000000C'
0000437C	00000000	0000000C			
				3831	
				3832	VRI_F VSDP, +10, +12, 129, 1, 2 shamt=1
00004388				3833+	DS OFD
00004388		00004388		3834+	USING *, R5 base for test data and test routine
00004388	000043B8			3835+T101	DC A(X101) address of test routine
0000438C	0065			3836+	DC H' 101' test number
0000438E	00			3837+	DC X' 00'
0000438F	81			3838+	DC HL1' 129' i4
00004390	01			3839+	DC HL1' 1' m5
00004391	02			3840+	DC HL1' 2' cc
00004392	0D			3841+	DC HL1' 13' cc failed mask

LOC	OBJECT CODE			ADDR1	ADDR2	STMT			
0000455C	E612	3018	007E			3951+	VSDP	V1, V2, V3, 128, 1	test instruction
00004562	E710	8F08	000E		00001108	3952+	VST	V1, V10OUTPUT	save result
00004568	B98D	0020				3953+	EPSW	R2, R0	exptrect psw
0000456C	5020	8EE8			000010E8	3954+	ST	R2, CCPSW	to save CC
00004570	07FB					3955+	BR	R11	return
00004574						3956+RE104	DC	OF	
00004574						3957+	DROP	R5	
00004574	00000000	00000000				3958	DC	XL16' 000000000000000000000000000008D'	
0000457C	00000000	0000008D							
						3959			
						3960	VRI_F	VSDP, - 100, - 12, 129, 1, 2	shamt=1
00004588						3961+	DS	OFD	
00004588				00004588		3962+	USING	*, R5	base for test data and test routine
00004588	000045B8					3963+T105	DC	A(X105)	address of test routine
0000458C	0069					3964+	DC	H' 105'	test number
0000458E	00					3965+	DC	X' 00'	
0000458F	81					3966+	DC	HL1' 129'	i4
00004590	01					3967+	DC	HL1' 1'	m5
00004591	02					3968+	DC	HL1' 2'	cc
00004592	0D					3969+	DC	HL1' 13'	cc failed mask
00004598	FFFFFFFF	FFFFFF9C				3970+V2_105	DC	FD' - 100'	binary value for v2 packed decimal
000045A0	FFFFFFFF	FFFFFFF4				3971+V3_105	DC	FD' - 12'	binary value for v3 packed decimal
000045A8	E5E2C4D7	40404040				3972+	DC	CL8' VSDP'	instruction name
000045B0	00000010					3973+	DC	A(16)	result length
000045B4	000045F4					3974+REA105	DC	A(RE105)	result address
						3975+*			INSTRUCTION UNDER TEST ROUTINE
000045B8						3976+X105	DS	OF	
000045B8	E320	5010	0004		00004598	3977+	LG	R2, V2_105	convert v2
000045BE	E320	8F57	002E		00001157	3978+	CVDG	R2, V2PACKED	
000045C4	E720	8F57	0006		00001157	3979+	VL	V2, V2PACKED	
000045CA	E320	5018	0004		000045A0	3980+	LG	R2, V3_105	convert v3
000045D0	E320	8F67	002E		00001167	3981+	CVDG	R2, V3PACKED	
000045D6	E730	8F67	0006		00001167	3982+	VL	V3, V3PACKED	
000045DC	E612	3018	107E			3983+	VSDP	V1, V2, V3, 129, 1	test instruction
000045E2	E710	8F08	000E		00001108	3984+	VST	V1, V10OUTPUT	save result
000045E8	B98D	0020				3985+	EPSW	R2, R0	exptrect psw
000045EC	5020	8EE8			000010E8	3986+	ST	R2, CCPSW	to save CC
000045F0	07FB					3987+	BR	R11	return
000045F4						3988+RE105	DC	OF	
000045F4						3989+	DROP	R5	
000045F4	00000000	00000000				3990	DC	XL16' 000000000000000000000000000083C'	
000045FC	00000000	0000083C							
						3991			
						3992	VRI_F	VSDP, - 100, - 10, 135, 1, 2	shamt=7
00004608						3993+	DS	OFD	
00004608				00004608		3994+	USING	*, R5	base for test data and test routine
00004608	00004638					3995+T106	DC	A(X106)	address of test routine
0000460C	006A					3996+	DC	H' 106'	test number
0000460E	00					3997+	DC	X' 00'	
0000460F	87					3998+	DC	HL1' 135'	i4
00004610	01					3999+	DC	HL1' 1'	m5
00004611	02					4000+	DC	HL1' 2'	cc
00004612	0D					4001+	DC	HL1' 13'	cc failed mask
00004618	FFFFFFFF	FFFFFF9C				4002+V2_106	DC	FD' - 100'	binary value for v2 packed decimal
00004620	FFFFFFFF	FFFFFFF6				4003+V3_106	DC	FD' - 10'	binary value for v3 packed decimal
00004628	E5E2C4D7	40404040				4004+	DC	CL8' VSDP'	instruction name

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
00004630	00000010			4005+	DC	A(16)	result length
00004634	00004674			4006+REA106	DC	A(RE106)	result address
				4007+*			INSTRUCTION UNDER TEST ROUTINE
00004638				4008+X106	DS	0F	
00004638	E320 5010 0004		00004618	4009+	LG	R2, V2_106	convert v2
0000463E	E320 8F57 002E		00001157	4010+	CVDG	R2, V2PACKED	
00004644	E720 8F57 0006		00001157	4011+	VL	V2, V2PACKED	
0000464A	E320 5018 0004		00004620	4012+	LG	R2, V3_106	convert v3
00004650	E320 8F67 002E		00001167	4013+	CVDG	R2, V3PACKED	
00004656	E730 8F67 0006		00001167	4014+	VL	V3, V3PACKED	
0000465C	E612 3018 707E			4015+	VSDP	V1, V2, V3, 135, 1	test instruction
00004662	E710 8F08 000E		00001108	4016+	VST	V1, V10UTPUT	save result
00004668	B98D 0020			4017+	EPSW	R2, R0	exptract psw
0000466C	5020 8EE8		000010E8	4018+	ST	R2, CCPSW	to save CC
00004670	07FB			4019+	BR	R11	return
00004674				4020+RE106	DC	0F	
00004674				4021+	DROP	R5	
00004674	00000000 00000000			4022	DC	XL16' 000000000000000000000000100000000C'	
0000467C	00000010 0000000C						
				4023			
				4024	VRI_F	VSDP, +10000000010, +10, 135, 1, 2	shamt=7
00004688				4025+	DS	0FD	
00004688		00004688		4026+	USING	*, R5	base for test data and test routine
00004688	000046B8			4027+T107	DC	A(X107)	address of test routine
0000468C	006B			4028+	DC	H' 107'	test number
0000468E	00			4029+	DC	X' 00'	
0000468F	87			4030+	DC	HL1' 135'	i4
00004690	01			4031+	DC	HL1' 1'	m5
00004691	02			4032+	DC	HL1' 2'	cc
00004692	0D			4033+	DC	HL1' 13'	cc failed mask
00004698	00000002 540BE40A			4034+V2_107	DC	FD' +10000000010'	binary value for v2 packed decimal
000046A0	00000000 0000000A			4035+V3_107	DC	FD' +10'	binary value for v3 packed decimal
000046A8	E5E2C4D7 40404040			4036+	DC	CL8' VSDP'	instruction name
000046B0	00000010			4037+	DC	A(16)	result length
000046B4	000046F4			4038+REA107	DC	A(RE107)	result address
				4039+*			INSTRUCTION UNDER TEST ROUTINE
000046B8				4040+X107	DS	0F	
000046B8	E320 5010 0004		00004698	4041+	LG	R2, V2_107	convert v2
000046BE	E320 8F57 002E		00001157	4042+	CVDG	R2, V2PACKED	
000046C4	E720 8F57 0006		00001157	4043+	VL	V2, V2PACKED	
000046CA	E320 5018 0004		000046A0	4044+	LG	R2, V3_107	convert v3
000046D0	E320 8F67 002E		00001167	4045+	CVDG	R2, V3PACKED	
000046D6	E730 8F67 0006		00001167	4046+	VL	V3, V3PACKED	
000046DC	E612 3018 707E			4047+	VSDP	V1, V2, V3, 135, 1	test instruction
000046E2	E710 8F08 000E		00001108	4048+	VST	V1, V10UTPUT	save result
000046E8	B98D 0020			4049+	EPSW	R2, R0	exptract psw
000046EC	5020 8EE8		000010E8	4050+	ST	R2, CCPSW	to save CC
000046F0	07FB			4051+	BR	R11	return
000046F4				4052+RE107	DC	0F	
000046F4				4053+	DROP	R5	
000046F4	00000000 00000010			4054	DC	XL16' 00000000000000001000000010000000C'	
000046FC	00000001 0000000C						
				4055			
				4056 * VSDP larger #'s			
				4057	VRI_F	VSDP, +9999999999999999, +1, 132, 1, 2	shamt=4
00004708				4058+	DS	0FD	

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
000047DC	E612 3018 007E			4112+	VSDP	V1, V2, V3, 128, 1	test instruction
000047E2	E710 8F08 000E		00001108	4113+	VST	V1, V10OUTPUT	save result
000047E8	B98D 0020			4114+	EPSW	R2, R0	exptract psw
000047EC	5020 8EE8		000010E8	4115+	ST	R2, CCPSW	to save CC
000047F0	07FB			4116+	BR	R11	return
000047F4				4117+RE109	DC	0F	
000047F4				4118+	DROP	R5	
000047F4	00000000 00000000			4119	DC	XL16' 000000000000000000999999999999D'	
000047FC	09999999 9999999D						
				4120			
				4121	VRI_F	VSDP, - 9999999999999999, - 1, 128, 1, 2	shamt=0
00004808				4122+	DS	0FD	
00004808		00004808		4123+	USING	*, R5	base for test data and test routine
00004808	00004838			4124+T110	DC	A(X110)	address of test routine
0000480C	006E			4125+	DC	H' 110'	test number
0000480E	00			4126+	DC	X' 00'	
0000480F	80			4127+	DC	HL1' 128'	i4
00004810	01			4128+	DC	HL1' 1'	m5
00004811	02			4129+	DC	HL1' 2'	cc
00004812	0D			4130+	DC	HL1' 13'	cc failed mask
				4131+V2_110	DC	FD' - 9999999999999999' \	
00004818	FFDC790D 903F0001			+			binary value for v2 packed decimal
00004820	FFFFFFFF FFFFFFFF			4132+V3_110	DC	FD' - 1'	binary value for v3 packed decimal
00004828	E5E2C4D7 40404040			4133+	DC	CL8' VSDP'	instruction name
00004830	00000010			4134+	DC	A(16)	result length
00004834	00004874			4135+REA110	DC	A(RE110)	result address
				4136+*			INSTRUCTION UNDER TEST ROUTINE
00004838				4137+X110	DS	0F	
00004838	E320 5010 0004		00004818	4138+	LG	R2, V2_110	convert v2
0000483E	E320 8F57 002E		00001157	4139+	CVDG	R2, V2PACKED	
00004844	E720 8F57 0006		00001157	4140+	VL	V2, V2PACKED	
0000484A	E320 5018 0004		00004820	4141+	LG	R2, V3_110	convert v3
00004850	E320 8F67 002E		00001167	4142+	CVDG	R2, V3PACKED	
00004856	E730 8F67 0006		00001167	4143+	VL	V3, V3PACKED	
0000485C	E612 3018 007E			4144+	VSDP	V1, V2, V3, 128, 1	test instruction
00004862	E710 8F08 000E		00001108	4145+	VST	V1, V10OUTPUT	save result
00004868	B98D 0020			4146+	EPSW	R2, R0	exptract psw
0000486C	5020 8EE8		000010E8	4147+	ST	R2, CCPSW	to save CC
00004870	07FB			4148+	BR	R11	return
00004874				4149+RE110	DC	0F	
00004874				4150+	DROP	R5	
00004874	00000000 00000009			4151	DC	XL16' 000000000000000000999999999999C'	
0000487C	99999999 9999999C						
				4152			
				4153	VRI_F	VSDP, - 9999999999999999, - 1, 142, 1, 2	shamt=14
00004888				4154+	DS	0FD	
00004888		00004888		4155+	USING	*, R5	base for test data and test routine
00004888	000048B8			4156+T111	DC	A(X111)	address of test routine
0000488C	006F			4157+	DC	H' 111'	test number
0000488E	00			4158+	DC	X' 00'	
0000488F	8E			4159+	DC	HL1' 142'	i4
00004890	01			4160+	DC	HL1' 1'	m5
00004891	02			4161+	DC	HL1' 2'	cc
00004892	0D			4162+	DC	HL1' 13'	cc failed mask
				4163+V2_111	DC	FD' - 9999999999999999' \	
00004898	FFDC790D 903F0001			+			binary value for v2 packed decimal

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
000048A0	FFFFFFFF FFFFFFFF			4164+V3_111	DC	FD' - 1'
000048A8	E5E2C4D7 40404040			4165+	DC	CL8' VSDP'
000048B0	00000010			4166+	DC	A(16)
000048B4	000048F4			4167+REA111	DC	A(RE111)
				4168+*		INSTRUCTION UNDER TEST ROUTINE
000048B8				4169+X111	DS	OF
000048B8	E320 5010 0004		00004898	4170+	LG	R2, V2_111
000048BE	E320 8F57 002E		00001157	4171+	CVDG	R2, V2PACKED
000048C4	E720 8F57 0006		00001157	4172+	VL	V2, V2PACKED
000048CA	E320 5018 0004		000048A0	4173+	LG	R2, V3_111
000048D0	E320 8F67 002E		00001167	4174+	CVDG	R2, V3PACKED
000048D6	E730 8F67 0006		00001167	4175+	VL	V3, V3PACKED
000048DC	E612 3018 E07E			4176+	VSDP	V1, V2, V3, 142, 1
000048E2	E710 8F08 000E		00001108	4177+	VST	V1, V10OUTPUT
000048E8	B98D 0020			4178+	EPSW	R2, R0
000048EC	5020 8EE8		000010E8	4179+	ST	R2, CCPSW
000048F0	07FB			4180+	BR	R11
000048F4				4181+RE111	DC	OF
000048F4				4182+	DROP	R5
000048F4	09999999 99999999			4183	DC	XL16' 099999999999999900000000000000C'
000048FC	90000000 0000000C					
				4184		
				4185	VRI_F	VSDP, +99999999999999, +1234, 129, 1, 2
00004908				4186+	DS	OFD
00004908		00004908		4187+	USING	*, R5
00004908	00004938			4188+T112	DC	A(X112)
0000490C	0070			4189+	DC	H' 112'
0000490E	00			4190+	DC	X' 00'
0000490F	81			4191+	DC	HL1' 129'
00004910	01			4192+	DC	HL1' 1'
00004911	02			4193+	DC	HL1' 2'
00004912	0D			4194+	DC	HL1' 13'
				4195+V2_112	DC	FD' +99999999999999' \
00004918	00000918 4E729FFF			+		binary value for v2 packed decimal
00004920	00000000 000004D2			4196+V3_112	DC	FD' +1234'
00004928	E5E2C4D7 40404040			4197+	DC	CL8' VSDP'
00004930	00000010			4198+	DC	A(16)
00004934	00004974			4199+REA112	DC	A(RE112)
				4200+*		INSTRUCTION UNDER TEST ROUTINE
00004938				4201+X112	DS	OF
00004938	E320 5010 0004		00004918	4202+	LG	R2, V2_112
0000493E	E320 8F57 002E		00001157	4203+	CVDG	R2, V2PACKED
00004944	E720 8F57 0006		00001157	4204+	VL	V2, V2PACKED
0000494A	E320 5018 0004		00004920	4205+	LG	R2, V3_112
00004950	E320 8F67 002E		00001167	4206+	CVDG	R2, V3PACKED
00004956	E730 8F67 0006		00001167	4207+	VL	V3, V3PACKED
0000495C	E612 3018 107E			4208+	VSDP	V1, V2, V3, 129, 1
00004962	E710 8F08 000E		00001108	4209+	VST	V1, V10OUTPUT
00004968	B98D 0020			4210+	EPSW	R2, R0
0000496C	5020 8EE8		000010E8	4211+	ST	R2, CCPSW
00004970	07FB			4212+	BR	R11
00004974				4213+RE112	DC	OF
00004974				4214+	DROP	R5
00004974	00000000 00000000			4215	DC	XL16' 0000000000000000000000081037277147C'
0000497C	00008103 7277147C					

4216

LOC	OBJECT CODE	ADDR1	ADDR2	STMT		
				4217	VRI_F VSDP, +999999999999999, +12345, 129, 1, 2	shamt=1
00004988				4218+	DS OFD	
00004988		00004988		4219+	USING *, R5	base for test data and test routine
00004988	000049B8			4220+T113	DC A(X113)	address of test routine
0000498C	0071			4221+	DC H' 113'	test number
0000498E	00			4222+	DC X' 00'	
0000498F	81			4223+	DC HL1' 129'	i4
00004990	01			4224+	DC HL1' 1'	m5
00004991	02			4225+	DC HL1' 2'	cc
00004992	0D			4226+	DC HL1' 13'	cc failed mask
				4227+V2_113	DC FD' +999999999999999' \	
00004998	00038D7E A4C67FFF			+		binary value for v2 packed decimal
000049A0	00000000 00003039			4228+V3_113	DC FD' +12345'	binary value for v3 packed decimal
000049A8	E5E2C4D7 40404040			4229+	DC CL8' VSDP'	instruction name
000049B0	00000010			4230+	DC A(16)	result length
000049B4	000049F4			4231+REA113	DC A(RE113)	result address
				4232+*		INSTRUCTION UNDER TEST ROUTINE
000049B8				4233+X113	DS OF	
000049B8	E320 5010 0004		00004998	4234+	LG R2, V2_113	convert v2
000049BE	E320 8F57 002E		00001157	4235+	CVDG R2, V2PACKED	
000049C4	E720 8F57 0006		00001157	4236+	VL V2, V2PACKED	
000049CA	E320 5018 0004		000049A0	4237+	LG R2, V3_113	convert v3
000049D0	E320 8F67 002E		00001167	4238+	CVDG R2, V3PACKED	
000049D6	E730 8F67 0006		00001167	4239+	VL V3, V3PACKED	
000049DC	E612 3018 107E			4240+	VSDP V1, V2, V3, 129, 1	test instruction
000049E2	E710 8F08 000E		00001108	4241+	VST V1, V10UTPUT	save result
000049E8	B98D 0020			4242+	EPSW R2, R0	exptract psw
000049EC	5020 8EE8		000010E8	4243+	ST R2, CCPSW	to save CC
000049F0	07FB			4244+	BR R11	return
000049F4				4245+RE113	DC OF	
000049F4				4246+	DROP R5	
000049F4	00000000 00000000			4247	DC XL16' 000000000000000000000810044552450C'	
000049FC	00081004 4552450C					
				4248		
				4249 *	VSDP larger #'s	CS=1 for all m5
				4250 *	check forced positive	
				4251 *		
				4252	VRI_F VSDP, - 999999999999999, +1, 129, 9, 2	shamt=1
00004A08				4253+	DS OFD	m5=9(P2=1)
00004A08		00004A08		4254+	USING *, R5	base for test data and test routine
00004A08	00004A38			4255+T114	DC A(X114)	address of test routine
00004A0C	0072			4256+	DC H' 114'	test number
00004A0E	00			4257+	DC X' 00'	
00004A0F	81			4258+	DC HL1' 129'	i4
00004A10	09			4259+	DC HL1' 9'	m5
00004A11	02			4260+	DC HL1' 2'	cc
00004A12	0D			4261+	DC HL1' 13'	cc failed mask
				4262+V2_114	DC FD' - 999999999999999' \	
00004A18	FE9CBA87 A2760001			+		binary value for v2 packed decimal
00004A20	00000000 00000001			4263+V3_114	DC FD' +1'	binary value for v3 packed decimal
00004A28	E5E2C4D7 40404040			4264+	DC CL8' VSDP'	instruction name
00004A30	00000010			4265+	DC A(16)	result length
00004A34	00004A74			4266+REA114	DC A(RE114)	result address
				4267+*		INSTRUCTION UNDER TEST ROUTINE
00004A38				4268+X114	DS OF	
00004A38	E320 5010 0004		00004A18	4269+	LG R2, V2_114	convert v2

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
00004B0E	00			4323+	DC	X' 00'	
00004B0F	83			4324+	DC	HL1' 131'	i4
00004B10	03			4325+	DC	HL1' 3'	m5
00004B11	02			4326+	DC	HL1' 2'	cc
00004B12	0D			4327+	DC	HL1' 13'	cc failed mask
				4328+V2_116	DC	FD' - 9999999999999999'	\
00004B18	FFDC790D	903F0001		+			binary value for v2 packed decimal
00004B20	FFFFFFFF	FFFFFFFF		4329+V3_116	DC	FD' - 1'	binary value for v3 packed decimal
00004B28	E5E2C4D7	40404040		4330+	DC	CL8' VSDP'	instruction name
00004B30	00000010			4331+	DC	A(16)	result length
00004B34	00004B74			4332+REA116	DC	A(RE116)	result address
				4333+*			INSTRUCTION UNDER TEST ROUTINE
00004B38				4334+X116	DS	0F	
00004B38	E320 5010 0004		00004B18	4335+	LG	R2, V2_116	convert v2
00004B3E	E320 8F57 002E		00001157	4336+	CVDG	R2, V2PACKED	
00004B44	E720 8F57 0006		00001157	4337+	VL	V2, V2PACKED	
00004B4A	E320 5018 0004		00004B20	4338+	LG	R2, V3_116	convert v3
00004B50	E320 8F67 002E		00001167	4339+	CVDG	R2, V3PACKED	
00004B56	E730 8F67 0006		00001167	4340+	VL	V3, V3PACKED	
00004B5C	E612 3038 307E			4341+	VSDP	V1, V2, V3, 131, 3	test instruction
00004B62	E710 8F08 000E		00001108	4342+	VST	V1, V10UTPUT	save result
00004B68	B98D 0020			4343+	EPSW	R2, R0	exptract psw
00004B6C	5020 8EE8		000010E8	4344+	ST	R2, CCPSW	to save CC
00004B70	07FB			4345+	BR	R11	return
00004B74				4346+RE116	DC	0F	
00004B74				4347+	DROP	R5	
00004B74	00000000	00009999		4348	DC	XL16' 0000000000000999999999999999000F'	
00004B7C	99999999	9999000F					
				4349			
				4350 *			shamt=7
				4351 *			m5=13(P2=1, P3=1)
				4352	VRI_F	VSDP, +9999999999999999, - 1, 135, 13, 2	
00004B88				4353+	DS	0FD	
00004B88		00004B88		4354+	USING	*, R5	base for test data and test routine
00004B88	00004BB8			4355+T117	DC	A(X117)	address of test routine
00004B8C	0075			4356+	DC	H' 117'	test number
00004B8E	00			4357+	DC	X' 00'	
00004B8F	87			4358+	DC	HL1' 135'	i4
00004B90	0D			4359+	DC	HL1' 13'	m5
00004B91	02			4360+	DC	HL1' 2'	cc
00004B92	0D			4361+	DC	HL1' 13'	cc failed mask
				4362+V2_117	DC	FD' +9999999999999999'	\
00004B98	002386F2	6FC0FFFF		+			binary value for v2 packed decimal
00004BA0	FFFFFFFF	FFFFFFFF		4363+V3_117	DC	FD' - 1'	binary value for v3 packed decimal
00004BA8	E5E2C4D7	40404040		4364+	DC	CL8' VSDP'	instruction name
00004BB0	00000010			4365+	DC	A(16)	result length
00004BB4	00004BF4			4366+REA117	DC	A(RE117)	result address
				4367+*			INSTRUCTION UNDER TEST ROUTINE
00004BB8				4368+X117	DS	0F	
00004BB8	E320 5010 0004		00004B98	4369+	LG	R2, V2_117	convert v2
00004BBE	E320 8F57 002E		00001157	4370+	CVDG	R2, V2PACKED	
00004BC4	E720 8F57 0006		00001157	4371+	VL	V2, V2PACKED	
00004BCA	E320 5018 0004		00004BA0	4372+	LG	R2, V3_117	convert v3
00004BD0	E320 8F67 002E		00001167	4373+	CVDG	R2, V3PACKED	
00004BD6	E730 8F67 0006		00001167	4374+	VL	V3, V3PACKED	
00004BDC	E612 30D8 707E			4375+	VSDP	V1, V2, V3, 135, 13	test instruction

LOC	OBJECT CODE			ADDR1	ADDR2	STMT			
00004BE2	E710	8F08	000E		00001108	4376+	VST	V1, V10OUTPUT	save result
00004BE8	B98D	0020				4377+	EPSW	R2, R0	expract psw
00004BEC	5020	8EE8			000010E8	4378+	ST	R2, CCPSW	to save CC
00004BF0	07FB					4379+	BR	R11	return
00004BF4						4380+RE117	DC	0F	
00004BF4						4381+	DROP	R5	
00004BF4	00000000	99999999				4382	DC	XL16' 00000000999999999999999900000000C'	
00004BFC	99999999	0000000C							
						4383			
						4384 *	shamt=14		
						4385	VRI_F	VSDP, +99999999999999, +3, 142, 3, 2	m5=3(P1=1)
00004C08					00004C08	4386+	DS	0FD	
00004C08					00004C08	4387+	USING	*, R5	base for test data and test routine
00004C08	00004C38					4388+T118	DC	A(X118)	address of test routine
00004C0C	0076					4389+	DC	H' 118'	test number
00004C0E	00					4390+	DC	X' 00'	
00004C0F	8E					4391+	DC	HL1' 142'	i4
00004C10	03					4392+	DC	HL1' 3'	m5
00004C11	02					4393+	DC	HL1' 2'	cc
00004C12	0D					4394+	DC	HL1' 13'	cc failed mask
						4395+V2_118	DC	FD' +99999999999999'	\
00004C18	00000918	4E729FFF				+	binary value for v2 packed decimal		
00004C20	00000000	00000003				4396+V3_118	DC	FD' +3'	binary value for v3 packed decimal
00004C28	E5E2C4D7	40404040				4397+	DC	CL8' VSDP'	instruction name
00004C30	00000010					4398+	DC	A(16)	result length
00004C34	00004C74					4399+REA118	DC	A(RE118)	result address
						4400+*	INSTRUCTION UNDER TEST ROUTINE		
00004C38						4401+X118	DS	0F	
00004C38	E320	5010	0004		00004C18	4402+	LG	R2, V2_118	convert v2
00004C3E	E320	8F57	002E		00001157	4403+	CVDG	R2, V2PACKED	
00004C44	E720	8F57	0006		00001157	4404+	VL	V2, V2PACKED	
00004C4A	E320	5018	0004		00004C20	4405+	LG	R2, V3_118	convert v3
00004C50	E320	8F67	002E		00001167	4406+	CVDG	R2, V3PACKED	
00004C56	E730	8F67	0006		00001167	4407+	VL	V3, V3PACKED	
00004C5C	E612	3038	E07E			4408+	VSDP	V1, V2, V3, 142, 3	test instruction
00004C62	E710	8F08	000E		00001108	4409+	VST	V1, V10OUTPUT	save result
00004C68	B98D	0020				4410+	EPSW	R2, R0	expract psw
00004C6C	5020	8EE8			000010E8	4411+	ST	R2, CCPSW	to save CC
00004C70	07FB					4412+	BR	R11	return
00004C74						4413+RE118	DC	0F	
00004C74						4414+	DROP	R5	
00004C74	00003333	33333333				4415	DC	XL16' 00003333333333333300000000000000F'	
00004C7C	30000000	0000000F							
						4416			
						4417 *	shamt=31		
						4418 *	m5=15(P1=1, P2=1, P3=1)		
						4419	VRI_F	VSDP, - 999999999999999999, - 3, 159, 15, 3	
00004C88					00004C88	4420+	DS	0FD	
00004C88					00004C88	4421+	USING	*, R5	base for test data and test routine
00004C88	00004CB8					4422+T119	DC	A(X119)	address of test routine
00004C8C	0077					4423+	DC	H' 119'	test number
00004C8E	00					4424+	DC	X' 00'	
00004C8F	9F					4425+	DC	HL1' 159'	i4
00004C90	0F					4426+	DC	HL1' 15'	m5
00004C91	03					4427+	DC	HL1' 3'	cc
00004C92	0E					4428+	DC	HL1' 14'	cc failed mask

LOC	OBJECT CODE		ADDR1	ADDR2	STMT			
					4429+V2_119	DC	FD' - 999999999999999999' \	
00004C98	F21F494C	589C0001			+		binary value for v2 packed decimal	
00004CA0	FFFFFFFF	FFFFFFFFD			4430+V3_119	DC	FD' - 3'	
00004CA8	E5E2C4D7	40404040			4431+	DC	CL8' VSDP'	
00004CB0	00000010				4432+	DC	A(16)	
00004CB4	00004CF4				4433+REA119	DC	A(RE119)	
					4434+*		result address	
00004CB8					4435+X119	DS	OF	
00004CB8	E320 5010 0004			00004C98	4436+	LG	R2, V2_119	convert v2
00004CBE	E320 8F57 002E			00001157	4437+	CVDG	R2, V2PACKED	
00004CC4	E720 8F57 0006			00001157	4438+	VL	V2, V2PACKED	
00004CCA	E320 5018 0004			00004CA0	4439+	LG	R2, V3_119	convert v3
00004CD0	E320 8F67 002E			00001167	4440+	CVDG	R2, V3PACKED	
00004CD6	E730 8F67 0006			00001167	4441+	VL	V3, V3PACKED	
00004CDC	E612 30F9 F07E				4442+	VSDP	V1, V2, V3, 159, 15	test instruction
00004CE2	E710 8F08 000E			00001108	4443+	VST	V1, V10UTPUT	save result
00004CE8	B98D 0020				4444+	EPSW	R2, R0	exptract psw
00004CEC	5020 8EE8			000010E8	4445+	ST	R2, CCPSW	to save CC
00004CF0	07FB				4446+	BR	R11	return
00004CF4					4447+RE119	DC	OF	
00004CF4					4448+	DROP	R5	
00004CF4	00000000 00000000				4449	DC	XL16' 00000000000000000000000000000000F'	
00004CFC	00000000 0000000F							
					4450			
					4451			
00004D04	00000000				4452	DC	F' 0'	END OF TABLE
00004D08	00000000				4453	DC	F' 0'	
					4454 *			
					4455 *	table of pointers to individual load test		
					4456 *			
00004D0C					4457 E6TESTS	DS	OF	
					4458	PTTABLE		
00004D0C					4459+TTABLE	DS	OF	
00004D0C	00001188				4460+	DC	A(T1)	address of test
00004D10	00001208				4461+	DC	A(T2)	address of test
00004D14	00001288				4462+	DC	A(T3)	address of test
00004D18	00001308				4463+	DC	A(T4)	address of test
00004D1C	00001388				4464+	DC	A(T5)	address of test
00004D20	00001408				4465+	DC	A(T6)	address of test
00004D24	00001488				4466+	DC	A(T7)	address of test
00004D28	00001508				4467+	DC	A(T8)	address of test
00004D2C	00001588				4468+	DC	A(T9)	address of test
00004D30	00001608				4469+	DC	A(T10)	address of test
00004D34	00001688				4470+	DC	A(T11)	address of test
00004D38	00001708				4471+	DC	A(T12)	address of test
00004D3C	00001788				4472+	DC	A(T13)	address of test
00004D40	00001808				4473+	DC	A(T14)	address of test
00004D44	00001888				4474+	DC	A(T15)	address of test
00004D48	00001908				4475+	DC	A(T16)	address of test
00004D4C	00001988				4476+	DC	A(T17)	address of test
00004D50	00001A08				4477+	DC	A(T18)	address of test
00004D54	00001A88				4478+	DC	A(T19)	address of test
00004D58	00001B08				4479+	DC	A(T20)	address of test
00004D5C	00001B88				4480+	DC	A(T21)	address of test
00004D60	00001C08				4481+	DC	A(T22)	address of test
00004D64	00001C88				4482+	DC	A(T23)	address of test

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
00004D68	00001D08			4483+	DC	A(T24)	address of test
00004D6C	00001D88			4484+	DC	A(T25)	address of test
00004D70	00001E08			4485+	DC	A(T26)	address of test
00004D74	00001E88			4486+	DC	A(T27)	address of test
00004D78	00001F08			4487+	DC	A(T28)	address of test
00004D7C	00001F88			4488+	DC	A(T29)	address of test
00004D80	00002008			4489+	DC	A(T30)	address of test
00004D84	00002088			4490+	DC	A(T31)	address of test
00004D88	00002108			4491+	DC	A(T32)	address of test
00004D8C	00002188			4492+	DC	A(T33)	address of test
00004D90	00002208			4493+	DC	A(T34)	address of test
00004D94	00002288			4494+	DC	A(T35)	address of test
00004D98	00002308			4495+	DC	A(T36)	address of test
00004D9C	00002388			4496+	DC	A(T37)	address of test
00004DA0	00002408			4497+	DC	A(T38)	address of test
00004DA4	00002488			4498+	DC	A(T39)	address of test
00004DA8	00002508			4499+	DC	A(T40)	address of test
00004DAC	00002588			4500+	DC	A(T41)	address of test
00004DB0	00002608			4501+	DC	A(T42)	address of test
00004DB4	00002688			4502+	DC	A(T43)	address of test
00004DB8	00002708			4503+	DC	A(T44)	address of test
00004DBC	00002788			4504+	DC	A(T45)	address of test
00004DC0	00002808			4505+	DC	A(T46)	address of test
00004DC4	00002888			4506+	DC	A(T47)	address of test
00004DC8	00002908			4507+	DC	A(T48)	address of test
00004DCC	00002988			4508+	DC	A(T49)	address of test
00004DD0	00002A08			4509+	DC	A(T50)	address of test
00004DD4	00002A88			4510+	DC	A(T51)	address of test
00004DD8	00002B08			4511+	DC	A(T52)	address of test
00004DDC	00002B88			4512+	DC	A(T53)	address of test
00004DE0	00002C08			4513+	DC	A(T54)	address of test
00004DE4	00002C88			4514+	DC	A(T55)	address of test
00004DE8	00002D08			4515+	DC	A(T56)	address of test
00004DEC	00002D88			4516+	DC	A(T57)	address of test
00004DF0	00002E08			4517+	DC	A(T58)	address of test
00004DF4	00002E88			4518+	DC	A(T59)	address of test
00004DF8	00002F08			4519+	DC	A(T60)	address of test
00004DFC	00002F88			4520+	DC	A(T61)	address of test
00004E00	00003008			4521+	DC	A(T62)	address of test
00004E04	00003088			4522+	DC	A(T63)	address of test
00004E08	00003108			4523+	DC	A(T64)	address of test
00004E0C	00003188			4524+	DC	A(T65)	address of test
00004E10	00003208			4525+	DC	A(T66)	address of test
00004E14	00003288			4526+	DC	A(T67)	address of test
00004E18	00003308			4527+	DC	A(T68)	address of test
00004E1C	00003388			4528+	DC	A(T69)	address of test
00004E20	00003408			4529+	DC	A(T70)	address of test
00004E24	00003488			4530+	DC	A(T71)	address of test
00004E28	00003508			4531+	DC	A(T72)	address of test
00004E2C	00003588			4532+	DC	A(T73)	address of test
00004E30	00003608			4533+	DC	A(T74)	address of test
00004E34	00003688			4534+	DC	A(T75)	address of test
00004E38	00003708			4535+	DC	A(T76)	address of test
00004E3C	00003788			4536+	DC	A(T77)	address of test
00004E40	00003808			4537+	DC	A(T78)	address of test
00004E44	00003888			4538+	DC	A(T79)	address of test

LOC	OBJECT CODE	ADDR1	ADDR2	STMT			
00004E48	00003908			4539+	DC	A(T80)	address of test
00004E4C	00003988			4540+	DC	A(T81)	address of test
00004E50	00003A08			4541+	DC	A(T82)	address of test
00004E54	00003A88			4542+	DC	A(T83)	address of test
00004E58	00003B08			4543+	DC	A(T84)	address of test
00004E5C	00003B88			4544+	DC	A(T85)	address of test
00004E60	00003C08			4545+	DC	A(T86)	address of test
00004E64	00003C88			4546+	DC	A(T87)	address of test
00004E68	00003D08			4547+	DC	A(T88)	address of test
00004E6C	00003D88			4548+	DC	A(T89)	address of test
00004E70	00003E08			4549+	DC	A(T90)	address of test
00004E74	00003E88			4550+	DC	A(T91)	address of test
00004E78	00003F08			4551+	DC	A(T92)	address of test
00004E7C	00003F88			4552+	DC	A(T93)	address of test
00004E80	00004008			4553+	DC	A(T94)	address of test
00004E84	00004088			4554+	DC	A(T95)	address of test
00004E88	00004108			4555+	DC	A(T96)	address of test
00004E8C	00004188			4556+	DC	A(T97)	address of test
00004E90	00004208			4557+	DC	A(T98)	address of test
00004E94	00004288			4558+	DC	A(T99)	address of test
00004E98	00004308			4559+	DC	A(T100)	address of test
00004E9C	00004388			4560+	DC	A(T101)	address of test
00004EA0	00004408			4561+	DC	A(T102)	address of test
00004EA4	00004488			4562+	DC	A(T103)	address of test
00004EA8	00004508			4563+	DC	A(T104)	address of test
00004EAC	00004588			4564+	DC	A(T105)	address of test
00004EB0	00004608			4565+	DC	A(T106)	address of test
00004EB4	00004688			4566+	DC	A(T107)	address of test
00004EB8	00004708			4567+	DC	A(T108)	address of test
00004EBC	00004788			4568+	DC	A(T109)	address of test
00004EC0	00004808			4569+	DC	A(T110)	address of test
00004EC4	00004888			4570+	DC	A(T111)	address of test
00004EC8	00004908			4571+	DC	A(T112)	address of test
00004ECC	00004988			4572+	DC	A(T113)	address of test
00004ED0	00004A08			4573+	DC	A(T114)	address of test
00004ED4	00004A88			4574+	DC	A(T115)	address of test
00004ED8	00004B08			4575+	DC	A(T116)	address of test
00004EDC	00004B88			4576+	DC	A(T117)	address of test
00004EE0	00004C08			4577+	DC	A(T118)	address of test
00004EE4	00004C88			4578+	DC	A(T119)	address of test
				4579+*			
00004EE8	00000000			4580+	DC	A(0)	END OF TABLE
00004EEC	00000000			4581+	DC	A(0)	
				4582			
00004EF0	00000000			4583	DC	F' 0'	END OF TABLE
00004EF4	00000000			4584	DC	F' 0'	

LOC	OBJECT CODE	ADDR1	ADDR2	STMT
				4586 *****
				4587 * Register equates
				4588 *****
		00000000	00000001	4590 R0 EQU 0
		00000001	00000001	4591 R1 EQU 1
		00000002	00000001	4592 R2 EQU 2
		00000003	00000001	4593 R3 EQU 3
		00000004	00000001	4594 R4 EQU 4
		00000005	00000001	4595 R5 EQU 5
		00000006	00000001	4596 R6 EQU 6
		00000007	00000001	4597 R7 EQU 7
		00000008	00000001	4598 R8 EQU 8
		00000009	00000001	4599 R9 EQU 9
		0000000A	00000001	4600 R10 EQU 10
		0000000B	00000001	4601 R11 EQU 11
		0000000C	00000001	4602 R12 EQU 12
		0000000D	00000001	4603 R13 EQU 13
		0000000E	00000001	4604 R14 EQU 14
		0000000F	00000001	4605 R15 EQU 15
				4607 *****
				4608 * Register equates
				4609 *****
		00000000	00000001	4611 V0 EQU 0
		00000001	00000001	4612 V1 EQU 1
		00000002	00000001	4613 V2 EQU 2
		00000003	00000001	4614 V3 EQU 3
		00000004	00000001	4615 V4 EQU 4
		00000005	00000001	4616 V5 EQU 5
		00000006	00000001	4617 V6 EQU 6
		00000007	00000001	4618 V7 EQU 7
		00000008	00000001	4619 V8 EQU 8
		00000009	00000001	4620 V9 EQU 9
		0000000A	00000001	4621 V10 EQU 10
		0000000B	00000001	4622 V11 EQU 11
		0000000C	00000001	4623 V12 EQU 12
		0000000D	00000001	4624 V13 EQU 13
		0000000E	00000001	4625 V14 EQU 14
		0000000F	00000001	4626 V15 EQU 15
		00000010	00000001	4627 V16 EQU 16
		00000011	00000001	4628 V17 EQU 17
		00000012	00000001	4629 V18 EQU 18
		00000013	00000001	4630 V19 EQU 19
		00000014	00000001	4631 V20 EQU 20
		00000015	00000001	4632 V21 EQU 21

SYMBOL	TYPE	VALUE	LENGTH	DEFN	REFERENCES													
BEGIN	I	00000200	2	104	70	101	102											
CC	U	00000009	1	440	182													
CCFOUND	X	000010F0	1	413	169	189												
CCMASK	U	0000000A	1	441	141													
CCMSG	U	00000276	1	158	153													
CCPRTEXP	C	00001097	1	393	186													
CCPRTGOT	C	000010A7	1	396	193													
CCPRTLNE	C	00001054	16	388	398	196												
CCPRTLNG	U	00000055	1	398	195													
CCPRTNAME	C	00001081	8	391	179													
CCPRTNUM	C	00001064	3	389	177													
CCPSW	F	000010E8	4	412	166	588	620	652	684	716	748	781	813	845	879	911	943	
					979	1011	1043	1075	1107	1139	1171	1204	1236	1268	1300	1334	1366	
					1398	1430	1466	1498	1530	1562	1594	1626	1658	1691	1723	1755	1787	
					1819	1853	1886	1918	1950	1983	2019	2051	2083	2115	2147	2179	2211	
					2244	2276	2308	2340	2372	2404	2438	2470	2502	2535	2567	2600	2636	
					2668	2700	2732	2764	2796	2828	2861	2893	2925	2957	2989	3021	3055	
					3087	3119	3152	3184	3216	3259	3291	3323	3355	3387	3419	3451	3484	
					3517	3549	3581	3613	3648	3682	3715	3749	3783	3826	3858	3890	3922	
					3954	3986	4018	4050	4083	4115	4147	4179	4211	4243	4278	4311	4344	
					4378	4411	4445											
CTLRO	F	000004AC	4	332	114	115	116	117										
DECNUM	C	000010D5	16	408	174	176	183	185	190	192	208	210	217	219	224	226		
E6TADR	A	000004B4	4	335	123													
E6TEST	4	00000000	48	434	132													
E6TESTS	F	00004D0C	4	4457	335													
EDIT	X	000010A9	18	403	175	184	191	209	218	225								
ENDTEST	U	0000037E	1	246	128													
EOJ	I	00000490	4	322	249													
EOJPSW	D	00000480	8	320	322													
FAILCONT	U	0000036E	1	236	199													
FAILED	F	00001000	4	361	238	247												
FAILMSG	U	00000306	1	206	148													
FAILPSW	D	00000498	8	324	326													
FAILTEST	I	000004A8	4	326	250													
I4	U	00000007	1	438	216													
IMAGE	1	00000000	20216	0														
K	U	00000400	1	345	346	347	348											
K64	U	00010000	1	347														
M5	U	00000008	1	439	160	223												
MB	U	00100000	1	348														
MSG	I	000003C8	4	282	265													
MSGCMD	C	00000416	9	312	295	296												
MSGMSG	C	0000041F	95	313	289	310	287											
MSGM/C	I	00000410	6	310	293													
MSGOK	I	000003DE	2	291	288													
MSGRET	I	000003FE	4	306	299	302												
MSGSAVE	F	00000404	4	309	285	306												
NEXTE6	U	0000022A	1	125	151	241												
OPNAME	C	00000020	8	446	179	213												
PAGE	U	00001000	1	346														
PRT3	C	000010BF	18	406	175	176	177	184	185	186	191	192	193	209	210	211	218	
					219	220	225	226	227									
PRTI4	C	00001044	3	375	220													
PRTLNE	C	00001008	16	370	380	230												
PRTLNG	U	0000004C	1	380	229													

SYMBOL	TYPE	VALUE	LENGTH	DEFN	REFERENCES												
PRTM5	C	00001051	2	378	227												
PRTNAME	C	00001033	8	373	213												
PRTNUM	C	00001018	3	371	211												
R0	U	00000000	1	4590	64	114	117	130	134	135	195	229	237	238	264	266	282
					285	287	289	291	306	587	619	651	683	715	747	780	812
					844	878	910	942	978	1010	1042	1074	1106	1138	1170	1203	1235
					1267	1299	1333	1365	1397	1429	1465	1497	1529	1561	1593	1625	1657
					1690	1722	1754	1786	1818	1852	1885	1917	1949	1982	2018	2050	2082
					2114	2146	2178	2210	2243	2275	2307	2339	2371	2403	2437	2469	2501
					2534	2566	2599	2635	2667	2699	2731	2763	2795	2827	2860	2892	2924
					2956	2988	3020	3054	3086	3118	3151	3183	3215	3258	3290	3322	3354
					3386	3418	3450	3483	3516	3548	3580	3612	3647	3681	3714	3748	3782
					3825	3857	3889	3921	3953	3985	4017	4049	4082	4114	4146	4178	4210
					4242	4277	4310	4343	4377	4410	4444						
					141	142	143	146	147	159	160	161	166	167	168	169	196
					230	247	248	296	310								
R1	U	00000001	1	4591	111	112											
R10	U	0000000A	1	4600	138	139	589	621	653	685	717	749	782	814	846	880	912
R11	U	0000000B	1	4601	944	980	1012	1044	1076	1108	1140	1172	1205	1237	1269	1301	1335
					1367	1399	1431	1467	1499	1531	1563	1595	1627	1659	1692	1724	1756
					1788	1820	1854	1887	1919	1951	1984	2020	2052	2084	2116	2148	2180
					2212	2245	2277	2309	2341	2373	2405	2439	2471	2503	2536	2568	2601
					2637	2669	2701	2733	2765	2797	2829	2862	2894	2926	2958	2990	3022
					3056	3088	3120	3153	3185	3217	3260	3292	3324	3356	3388	3420	3452
					3485	3518	3550	3582	3614	3649	3683	3716	3750	3784	3827	3859	3891
					3923	3955	3987	4019	4051	4084	4116	4148	4180	4212	4244	4279	4312
					4345	4379	4412	4446									
R12	U	0000000C	1	4602	123	126	150	240									
R13	U	0000000D	1	4603													
R14	U	0000000E	1	4604													
R15	U	0000000F	1	4605	197	231	259	269	270								
R2	U	00000002	1	4592	173	174	181	182	183	188	189	190	207	208	215	216	217
					222	223	224	264	265	266	283	285	291	292	293	295	301
					306	307	579	580	582	583	587	588	611	612	614	615	619
					620	643	644	646	647	651	652	675	676	678	679	683	684
					707	708	710	711	715	716	739	740	742	743	747	748	772
					773	775	776	780	781	804	805	807	808	812	813	836	837
					839	840	844	845	870	871	873	874	878	879	902	903	905
					906	910	911	934	935	937	938	942	943	970	971	973	974
					978	979	1002	1003	1005	1006	1010	1011	1034	1035	1037	1038	1042
					1043	1066	1067	1069	1070	1074	1075	1098	1099	1101	1102	1106	1107
					1130	1131	1133	1134	1138	1139	1162	1163	1165	1166	1170	1171	1195
					1196	1198	1199	1203	1204	1227	1228	1230	1231	1235	1236	1259	1260
					1262	1263	1267	1268	1291	1292	1294	1295	1299	1300	1325	1326	1328
					1329	1333	1334	1357	1358	1360	1361	1365	1366	1389	1390	1392	1393
					1397	1398	1421	1422	1424	1425	1429	1430	1457	1458	1460	1461	1465
					1466	1489	1490	1492	1493	1497	1498	1521	1522	1524	1525	1529	1530
					1553	1554	1556	1557	1561	1562	1585	1586	1588	1589	1593	1594	1617
					1618	1620	1621	1625	1626	1649	1650	1652	1653	1657	1658	1682	1683
					1685	1686	1690	1691	1714	1715	1717	1718	1722	1723	1746	1747	1749
					1750	1754	1755	1778	1779	1781	1782	1786	1787	1810	1811	1813	1814
					1818	1819	1844	1845	1847	1848	1852	1853	1877	1878	1880	1881	1885
					1886	1909	1910	1912	1913	1917	1918	1941	1942	1944	1945	1949	1950
					1974	1975	1977	1978	1982	1983	2010	2011	2013	2014	2018	2019	2042
					2043	2045	2046	2050	2051	2074	2075	2077	2078	2082	2083	2106	2107
					2109	2110	2114	2115	2138	2139	2141	2142	2146	2147	2170	2171	2173

SYMBOL	TYPE	VALUE	LENGTH	DEFN	REFERENCES
					2174 2178 2179 2202 2203 2205 2206 2210 2211 2235 2236 2238 2239
					2243 2244 2267 2268 2270 2271 2275 2276 2299 2300 2302 2303 2307
					2308 2331 2332 2334 2335 2339 2340 2363 2364 2366 2367 2371 2372
					2395 2396 2398 2399 2403 2404 2429 2430 2432 2433 2437 2438 2461
					2462 2464 2465 2469 2470 2493 2494 2496 2497 2501 2502 2526 2527
					2529 2530 2534 2535 2558 2559 2561 2562 2566 2567 2591 2592 2594
					2595 2599 2600 2627 2628 2630 2631 2635 2636 2659 2660 2662 2663
					2667 2668 2691 2692 2694 2695 2699 2700 2723 2724 2726 2727 2731
					2732 2755 2756 2758 2759 2763 2764 2787 2788 2790 2791 2795 2796
					2819 2820 2822 2823 2827 2828 2852 2853 2855 2856 2860 2861 2884
					2885 2887 2888 2892 2893 2916 2917 2919 2920 2924 2925 2948 2949
					2951 2952 2956 2957 2980 2981 2983 2984 2988 2989 3012 3013 3015
					3016 3020 3021 3046 3047 3049 3050 3054 3055 3078 3079 3081 3082
					3086 3087 3110 3111 3113 3114 3118 3119 3143 3144 3146 3147 3151
					3152 3175 3176 3178 3179 3183 3184 3207 3208 3210 3211 3215 3216
					3250 3251 3253 3254 3258 3259 3282 3283 3285 3286 3290 3291 3314
					3315 3317 3318 3322 3323 3346 3347 3349 3350 3354 3355 3378 3379
					3381 3382 3386 3387 3410 3411 3413 3414 3418 3419 3442 3443 3445
					3446 3450 3451 3475 3476 3478 3479 3483 3484 3508 3509 3511 3512
					3516 3517 3540 3541 3543 3544 3548 3549 3572 3573 3575 3576 3580
					3581 3604 3605 3607 3608 3612 3613 3639 3640 3642 3643 3647 3648
					3673 3674 3676 3677 3681 3682 3706 3707 3709 3710 3714 3715 3740
					3741 3743 3744 3748 3749 3774 3775 3777 3778 3782 3783 3817 3818
					3820 3821 3825 3826 3849 3850 3852 3853 3857 3858 3881 3882 3884
					3885 3889 3890 3913 3914 3916 3917 3921 3922 3945 3946 3948 3949
					3953 3954 3977 3978 3980 3981 3985 3986 4009 4010 4012 4013 4017
					4018 4041 4042 4044 4045 4049 4050 4074 4075 4077 4078 4082 4083
					4106 4107 4109 4110 4114 4115 4138 4139 4141 4142 4146 4147 4170
					4171 4173 4174 4178 4179 4202 4203 4205 4206 4210 4211 4234 4235
					4237 4238 4242 4243 4269 4270 4272 4273 4277 4278 4302 4303 4305
					4306 4310 4311 4335 4336 4338 4339 4343 4344 4369 4370 4372 4373
					4377 4378 4402 4403 4405 4406 4410 4411 4436 4437 4439 4440 4444
					4445
R3	U	00000003	1	4593	
R4	U	00000004	1	4594	
R5	U	00000005	1	4595	126 127 132 260 268 564 591 596 623 628 655 660 687
					692 719 724 751 757 784 789 816 821 848 855 882 887
					914 919 946 955 982 987 1014 1019 1046 1051 1078 1083 1110
					1115 1142 1147 1174 1180 1207 1212 1239 1244 1271 1276 1303 1310
					1337 1342 1369 1374 1401 1406 1433 1442 1469 1474 1501 1506 1533
					1538 1565 1570 1597 1602 1629 1634 1661 1667 1694 1699 1726 1731
					1758 1763 1790 1795 1822 1829 1856 1862 1889 1894 1921 1926 1953
					1959 1986 1995 2022 2027 2054 2059 2086 2091 2118 2123 2150 2155
					2182 2187 2214 2220 2247 2252 2279 2284 2311 2316 2343 2348 2375
					2380 2407 2414 2441 2446 2473 2478 2505 2511 2538 2543 2570 2576
					2603

SYMBOL	TYPE	VALUE	LENGTH	DEFN	REFERENCES				
R8	U	00000008	1	4598	101	104	105	106	108
R9	U	00000009	1	4599	102	108	109	111	
RE1	F	000011F4	4	590	576				
RE10	F	00001674	4	881	867				
RE100	F	00004374	4	3828	3814				
RE101	F	000043F4	4	3860	3846				
RE102	F	00004474	4	3892	3878				
RE103	F	000044F4	4	3924	3910				
RE104	F	00004574	4	3956	3942				
RE105	F	000045F4	4	3988	3974				
RE106	F	00004674	4	4020	4006				
RE107	F	000046F4	4	4052	4038				
RE108	F	00004774	4	4085	4071				
RE109	F	000047F4	4	4117	4103				
RE11	F	000016F4	4	913	899				
RE110	F	00004874	4	4149	4135				
RE111	F	000048F4	4	4181	4167				
RE112	F	00004974	4	4213	4199				
RE113	F	000049F4	4	4245	4231				
RE114	F	00004A74	4	4280	4266				
RE115	F	00004AF4	4	4313	4299				
RE116	F	00004B74	4	4346	4332				
RE117	F	00004BF4	4	4380	4366				
RE118	F	00004C74	4	4413	4399				
RE119	F	00004CF4	4	4447	4433				
RE12	F	00001774	4	945	931				
RE13	F	000017F4	4	981	967				
RE14	F	00001874	4	1013	999				
RE15	F	000018F4	4	1045	1031				
RE16	F	00001974	4	1077	1063				
RE17	F	000019F4	4	1109	1095				
RE18	F	00001A74	4	1141	1127				
RE19	F	00001AF4	4	1173	1159				
RE2	F	00001274	4	622	608				
RE20	F	00001B74	4	1206	1192				
RE21	F	00001BF4	4	1238	1224				
RE22	F	00001C74	4	1270	1256				
RE23	F	00001CF4	4	1302	1288				
RE24	F	00001D74	4	1336	1322				
RE25	F	00001DF4	4	1368	1354				
RE26	F	00001E74	4	1400	1386				
RE27	F	00001EF4	4	1432	1418				
RE28	F	00001F74	4	1468	1454				
RE29	F	00001FF4	4	1500	1486				
RE3	F	000012F4	4	654	640				
RE30	F	00002074	4	1532	1518				
RE31	F	000020F4	4	1564	1550				
RE32	F	00002174	4	1596	1582				
RE33	F	000021F4	4	1628	1614				
RE34	F	00002274	4	1660	1646				
RE35	F	000022F4	4	1693	1679				
RE36	F	00002374	4	1725	1711				
RE37	F	000023F4	4	1757	1743				
RE38	F	00002474	4	1789	1775				
RE39	F	000024F4	4	1821	1807				
RE4	F	00001374	4	686	672				

SYMBOL	TYPE	VALUE	LENGTH	DEFN	REFERENCES
RE40	F	00002574	4	1855	1841
RE41	F	000025F4	4	1888	1874
RE42	F	00002674	4	1920	1906
RE43	F	000026F4	4	1952	1938
RE44	F	00002774	4	1985	1971
RE45	F	000027F4	4	2021	2007
RE46	F	00002874	4	2053	2039
RE47	F	000028F4	4	2085	2071
RE48	F	00002974	4	2117	2103
RE49	F	000029F4	4	2149	2135
RE5	F	000013F4	4	718	704
RE50	F	00002A74	4	2181	2167
RE51	F	00002AF4	4	2213	2199
RE52	F	00002B74	4	2246	2232
RE53	F	00002BF4	4	2278	2264
RE54	F	00002C74	4	2310	2296
RE55	F	00002CF4	4	2342	2328
RE56	F	00002D74	4	2374	2360
RE57	F	00002DF4	4	2406	2392
RE58	F	00002E74	4	2440	2426
RE59	F	00002EF4	4	2472	2458
RE6	F	00001474	4	750	736
RE60	F	00002F74	4	2504	2490
RE61	F	00002FF4	4	2537	2523
RE62	F	00003074	4	2569	2555
RE63	F	000030F4	4	2602	2588
RE64	F	00003174	4	2638	2624
RE65	F	000031F4	4	2670	2656
RE66	F	00003274	4	2702	2688
RE67	F	000032F4	4	2734	2720
RE68	F	00003374	4	2766	2752
RE69	F	000033F4	4	2798	2784
RE7	F	000014F4	4	783	769
RE70	F	00003474	4	2830	2816
RE71	F	000034F4	4	2863	2849
RE72	F	00003574	4	2895	2881
RE73	F	000035F4	4	2927	2913
RE74	F	00003674	4	2959	2945
RE75	F	000036F4	4	2991	2977
RE76	F	00003774	4	3023	3009
RE77	F	000037F4	4	3057	3043
RE78	F	00003874	4	3089	3075
RE79	F	000038F4	4	3121	3107
RE8	F	00001574	4	815	801
RE80	F	00003974	4	3154	3140
RE81	F	000039F4	4	3186	3172
RE82	F	00003A74	4	3218	3204
RE83	F	00003AF4	4	3261	3247
RE84	F	00003B74	4	3293	3279
RE85	F	00003BF4	4	3325	3311
RE86	F	00003C74	4	3357	3343
RE87	F	00003CF4	4	3389	3375
RE88	F	00003D74	4	3421	3407
RE89	F	00003DF4	4	3453	3439
RE9	F	000015F4	4	847	833
RE90	F	00003E74	4	3486	3472

SYMBOL	TYPE	VALUE	LENGTH	DEFN	REFERENCES
RE91	F	00003EF4	4	3519	3505
RE92	F	00003F74	4	3551	3537
RE93	F	00003FF4	4	3583	3569
RE94	F	00004074	4	3615	3601
RE95	F	000040F4	4	3650	3636
RE96	F	00004174	4	3684	3670
RE97	F	000041F4	4	3717	3703
RE98	F	00004274	4	3751	3737
RE99	F	000042F4	4	3785	3771
REA1	A	000011B4	4	576	
REA10	A	00001634	4	867	
REA100	A	00004334	4	3814	
REA101	A	000043B4	4	3846	
REA102	A	00004434	4	3878	
REA103	A	000044B4	4	3910	
REA104	A	00004534	4	3942	
REA105	A	000045B4	4	3974	
REA106	A	00004634	4	4006	
REA107	A	000046B4	4	4038	
REA108	A	00004734	4	4071	
REA109	A	000047B4	4	4103	
REA11	A	000016B4	4	899	
REA110	A	00004834	4	4135	
REA111	A	000048B4	4	4167	
REA112	A	00004934	4	4199	
REA113	A	000049B4	4	4231	
REA114	A	00004A34	4	4266	
REA115	A	00004AB4	4	4299	
REA116	A	00004B34	4	4332	
REA117	A	00004BB4	4	4366	
REA118	A	00004C34	4	4399	
REA119	A	00004CB4	4	4433	
REA12	A	00001734	4	931	
REA13	A	000017B4	4	967	
REA14	A	00001834	4	999	
REA15	A	000018B4	4	1031	
REA16	A	00001934	4	1063	
REA17	A	000019B4	4	1095	
REA18	A	00001A34	4	1127	
REA19	A	00001AB4	4	1159	
REA2	A	00001234	4	608	
REA20	A	00001B34	4	1192	
REA21	A	00001BB4	4	1224	
REA22	A	00001C34	4	1256	
REA23	A	00001CB4	4	1288	
REA24	A	00001D34	4	1322	
REA25	A	00001DB4	4	1354	
REA26	A	00001E34	4	1386	
REA27	A	00001EB4	4	1418	
REA28	A	00001F34	4	1454	
REA29	A	00001FB4	4	1486	
REA3	A	000012B4	4	640	
REA30	A	00002034	4	1518	
REA31	A	000020B4	4	1550	
REA32	A	00002134	4	1582	
REA33	A	000021B4	4	1614	

SYMBOL	TYPE	VALUE	LENGTH	DEFN	REFERENCES
REA34	A	00002234	4	1646	
REA35	A	000022B4	4	1679	
REA36	A	00002334	4	1711	
REA37	A	000023B4	4	1743	
REA38	A	00002434	4	1775	
REA39	A	000024B4	4	1807	
REA4	A	00001334	4	672	
REA40	A	00002534	4	1841	
REA41	A	000025B4	4	1874	
REA42	A	00002634	4	1906	
REA43	A	000026B4	4	1938	
REA44	A	00002734	4	1971	
REA45	A	000027B4	4	2007	
REA46	A	00002834	4	2039	
REA47	A	000028B4	4	2071	
REA48	A	00002934	4	2103	
REA49	A	000029B4	4	2135	
REA5	A	000013B4	4	704	
REA50	A	00002A34	4	2167	
REA51	A	00002AB4	4	2199	
REA52	A	00002B34	4	2232	
REA53	A	00002BB4	4	2264	
REA54	A	00002C34	4	2296	
REA55	A	00002CB4	4	2328	
REA56	A	00002D34	4	2360	
REA57	A	00002DB4	4	2392	
REA58	A	00002E34	4	2426	
REA59	A	00002EB4	4	2458	
REA6	A	00001434	4	736	
REA60	A	00002F34	4	2490	
REA61	A	00002FB4	4	2523	
REA62	A	00003034	4	2555	
REA63	A	000030B4	4	2588	
REA64	A	00003134	4	2624	
REA65	A	000031B4	4	2656	
REA66	A	00003234	4	2688	
REA67	A	000032B4	4	2720	
REA68	A	00003334	4	2752	
REA69	A	000033B4	4	2784	
REA7	A	000014B4	4	769	
REA70	A	00003434	4	2816	
REA71	A	000034B4	4	2849	
REA72	A	00003534	4	2881	
REA73	A	000035B4	4	2913	
REA74	A	00003634	4	2945	
REA75	A	000036B4	4	2977	
REA76	A	00003734	4	3009	
REA77	A	000037B4	4	3043	
REA78	A	00003834	4	3075	
REA79	A	000038B4	4	3107	
REA8	A	00001534	4	801	
REA80	A	00003934	4	3140	
REA81	A	000039B4	4	3172	
REA82	A	00003A34	4	3204	
REA83	A	00003AB4	4	3247	
REA84	A	00003B34	4	3279	

SYMBOL	TYPE	VALUE	LENGTH	DEFN	REFERENCES	
REA85	A	00003BB4	4	3311		
REA86	A	00003C34	4	3343		
REA87	A	00003CB4	4	3375		
REA88	A	00003D34	4	3407		
REA89	A	00003DB4	4	3439		
REA9	A	000015B4	4	833		
REA90	A	00003E34	4	3472		
REA91	A	00003EB4	4	3505		
REA92	A	00003F34	4	3537		
REA93	A	00003FB4	4	3569		
REA94	A	00004034	4	3601		
REA95	A	000040B4	4	3636		
REA96	A	00004134	4	3670		
REA97	A	000041B4	4	3703		
REA98	A	00004234	4	3737		
REA99	A	000042B4	4	3771		
READDR	A	0000002C	4	449	146	
REG2LOW	U	000000DD	1	351		
REG2PATT	U	AABBCCDD	1	350		
RELEN	A	00000028	4	448		
RPTDWSAV	D	000003B8	8	275	264	266
RPTERROR	I	0000038C	4	259	197	231
RPTSAVE	F	000003AC	4	272	259	269
RPTSVR5	F	000003B0	4	273	260	268
SVOLDPSW	U	00000140	0	66		
T1	A	00001188	4	565	4460	
T10	A	00001608	4	856	4469	
T100	A	00004308	4	3803	4559	
T101	A	00004388	4	3835	4560	
T102	A	00004408	4	3867	4561	
T103	A	00004488	4	3899	4562	
T104	A	00004508	4	3931	4563	
T105	A	00004588	4	3963	4564	
T106	A	00004608	4	3995	4565	
T107	A	00004688	4	4027	4566	
T108	A	00004708	4	4060	4567	
T109	A	00004788	4	4092	4568	
T11	A	00001688	4	888	4470	
T110	A	00004808	4	4124	4569	
T111	A	00004888	4	4156	4570	
T112	A	00004908	4	4188	4571	
T113	A	00004988	4	4220	4572	
T114	A	00004A08	4	4255	4573	
T115	A	00004A88	4	4288	4574	
T116	A	00004B08	4	4321	4575	
T117	A	00004B88	4	4355	4576	
T118	A	00004C08	4	4388	4577	
T119	A	00004C88	4	4422	4578	
T12	A	00001708	4	920	4471	
T13	A	00001788	4	956	4472	
T14	A	00001808	4	988	4473	
T15	A	00001888	4	1020	4474	
T16	A	00001908	4	1052	4475	
T17	A	00001988	4	1084	4476	
T18	A	00001A08	4	1116	4477	
T19	A	00001A88	4	1148	4478	

SYMBOL	TYPE	VALUE	LENGTH	DEFN	REFERENCES
T2	A	00001208	4	597	4461
T20	A	00001B08	4	1181	4479
T21	A	00001B88	4	1213	4480
T22	A	00001C08	4	1245	4481
T23	A	00001C88	4	1277	4482
T24	A	00001D08	4	1311	4483
T25	A	00001D88	4	1343	4484
T26	A	00001E08	4	1375	4485
T27	A	00001E88	4	1407	4486
T28	A	00001F08	4	1443	4487
T29	A	00001F88	4	1475	4488
T3	A	00001288	4	629	4462
T30	A	00002008	4	1507	4489
T31	A	00002088	4	1539	4490
T32	A	00002108	4	1571	4491
T33	A	00002188	4	1603	4492
T34	A	00002208	4	1635	4493
T35	A	00002288	4	1668	4494
T36	A	00002308	4	1700	4495
T37	A	00002388	4	1732	4496
T38	A	00002408	4	1764	4497
T39	A	00002488	4	1796	4498
T4	A	00001308	4	661	4463
T40	A	00002508	4	1830	4499
T41	A	00002588	4	1863	4500
T42	A	00002608	4	1895	4501
T43	A	00002688	4	1927	4502
T44	A	00002708	4	1960	4503
T45	A	00002788	4	1996	4504
T46	A	00002808	4	2028	4505
T47	A	00002888	4	2060	4506
T48	A	00002908	4	2092	4507
T49	A	00002988	4	2124	4508
T5	A	00001388	4	693	4464
T50	A	00002A08	4	2156	4509
T51	A	00002A88	4	2188	4510
T52	A	00002B08	4	2221	4511
T53	A	00002B88	4	2253	4512
T54	A	00002C08	4	2285	4513
T55	A	00002C88	4	2317	4514
T56	A	00002D08	4	2349	4515
T57	A	00002D88	4	2381	4516
T58	A	00002E08	4	2415	4517
T59	A	00002E88	4	2447	4518
T6	A	00001408	4	725	4465
T60	A	00002F08	4	2479	4519
T61	A	00002F88	4	2512	4520
T62	A	00003008	4	2544	4521
T63	A	00003088	4	2577	4522
T64	A	00003108	4	2613	4523
T65	A	00003188	4	2645	4524
T66	A	00003208	4	2677	4525
T67	A	00003288	4	2709	4526
T68	A	00003308	4	2741	4527
T69	A	00003388	4	2773	4528
T7	A	00001488	4	758	4466

SYMBOL	TYPE	VALUE	LENGTH	DEFN	REFERENCES													
T70	A	00003408	4	2805	4529													
T71	A	00003488	4	2838	4530													
T72	A	00003508	4	2870	4531													
T73	A	00003588	4	2902	4532													
T74	A	00003608	4	2934	4533													
T75	A	00003688	4	2966	4534													
T76	A	00003708	4	2998	4535													
T77	A	00003788	4	3032	4536													
T78	A	00003808	4	3064	4537													
T79	A	00003888	4	3096	4538													
T8	A	00001508	4	790	4467													
T80	A	00003908	4	3129	4539													
T81	A	00003988	4	3161	4540													
T82	A	00003A08	4	3193	4541													
T83	A	00003A88	4	3236	4542													
T84	A	00003B08	4	3268	4543													
T85	A	00003B88	4	3300	4544													
T86	A	00003C08	4	3332	4545													
T87	A	00003C88	4	3364	4546													
T88	A	00003D08	4	3396	4547													
T89	A	00003D88	4	3428	4548													
T9	A	00001588	4	822	4468													
T90	A	00003E08	4	3461	4549													
T91	A	00003E88	4	3494	4550													
T92	A	00003F08	4	3526	4551													
T93	A	00003F88	4	3558	4552													
T94	A	00004008	4	3590	4553													
T95	A	00004088	4	3625	4554													
T96	A	00004108	4	3659	4555													
T97	A	00004188	4	3692	4556													
T98	A	00004208	4	3726	4557													
T99	A	00004288	4	3760	4558													
TESTCC	I	00000272	4	153	143													
TESTING	F	00001004	4	362	135													
TESTREST	U	0000025A	1	145	162													
TNUM	H	00000004	2	436	134	173	207											
TSUB	A	00000000	4	435	138													
TTABLE	F	00004D0C	4	4459														
V0	U	00000000	1	4611														
V1	U	00000001	1	4612	137	585	586	617	618	649	650	681	682	713	714	745	746	
					778	779	810	811	842	843	876	877	908	909	940	941	976	
					977	1008	1009	1040	1041	1072	1073	1104	1105	1136	1137	1168	1169	
					1201	1202	1233	1234	1265	1266	1297	1298	1331	1332	1363	1364	1395	
					1396	1427	1428	1463	1464	1495	1496	1527	1528	1559	1560	1591	1592	
					1623	1624	1655	1656	1688	1689	1720	1721	1752	1753	1784	1785	1816	
					1817	1850	1851	1883	1884	1915	1916	1947	1948	1980	1981	2016	2017	
					2048	2049	2080	2081	2112	2113	2144	2145	2176	2177	2208	2209	2241	
					2242	2273	2274	2305	2306	2337	2338	2369	2370	2401	2402	2435	2436	
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					2666	2697	2698	2729	2730	2761	2762	2793	2794	2825	2826	2858	2859	
					2890	2891	2922	2923	2954	2955	2986	2987	3018	3019	3052	3053	3084	
					3085	3116	3117	3149	3150	3181	3182	3213	3214	3256	3257	3288	3289	
					3320	3321	3352	3353	3384	3385	3416	3417	3448	3449	3481	3482	3514	
					3515	3546	3547	3578	3579	3610	3611	3645	3646	3679	3680	3712	3713	
					3746	3747	3780	3781	3823	3824	3855	3856	3887	3888	3919	3920	3951	
					3952	3983	3984	4015	4016	4047	4048	4080	4081	4112	4113	4144	4145	

SYMBOL	TYPE	VALUE	LENGTH	DEFN	REFERENCES												
					4176 4376	4177 4408	4208 4409	4209 4442	4240 4443	4241	4275	4276	4308	4309	4341	4342	4375
V10	U	0000000A	1	4621													
V11	U	0000000B	1	4622													
V12	U	0000000C	1	4623													
V13	U	0000000D	1	4624													
V14	U	0000000E	1	4625													
V15	U	0000000F	1	4626													
V16	U	00000010	1	4627													
V17	U	00000011	1	4628													
V18	U	00000012	1	4629													
V19	U	00000013	1	4630													
V1FUDGE	X	00001128	16	422	137												
V1INPUT	C	00001138	16	423													
V10OUTPUT	X	00001108	16	420	147	586	618	650	682	714	746	779	811	843	877	909	941
					977	1009	1041	1073	1105	1137	1169	1202	1234	1266	1298	1332	1364
					1396	1428	1464	1496	1528	1560	1592	1624	1656	1689	1721	1753	1785
					1817	1851	1884	1916	1948	1981	2017	2049	2081	2113	2145	2177	2209
					2242	2274	2306	2338	2370	2402	2436	2468	2500	2533	2565	2598	2634
					2666	2698	2730	2762	2794	2826	2859	2891	2923	2955	2987	3019	3053
					3085	3117	3150	3182	3214	3257	3289	3321	3353	3385	3417	3449	3482
					3515	3547	3579	3611	3646	3680	3713	3747	3781	3824	3856	3888	3920
					3952	3984	4016	4048	4081	4113	4145	4177	4209	4241	4276	4309	4342
					4376	4409	4443										
V2	U	00000002	1	4613	581	585	613	617	645	649	677	681	709	713	741	745	774
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					1004	1008	1036	1040	1068	1072	1100	1104	1132	1136	1164	1168	1197
					1201	1229	1233	1261	1265	1293	1297	1327	1331	1359	1363	1391	1395
					1423	1427	1459	1463	1491	1495	1523	1527	1555	1559	1587	1591	1619
					1623	1651	1655	1684	1688	1716	1720	1748	1752	1780	1784	1812	1816
					1846	1850	1879	1883	1911	1915	1943	1947	1976	1980	2012	2016	2044
					2048	2076	2080	2108	2112	2140	2144	2172	2176	2204	2208	2237	2241
					2269	2273	2301	2305	2333	2337	2365	2369	2397	2401	2431	2435	2463
					2467	2495	2499	2528	2532	2560	2564	2593	2597	2629	2633	2661	2665
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					3542	3546	3574	3578	3606	3610	3641	3645	3675	3679	3708	3712	3742
					3746	3776	3780	3819	3823	3851	3855	3883	3887	3915	3919	3947	3951
					3979	3983	4011	4015	4043	4047	4076	4080	4108	4112	4140	4144	4172
					4176	4204	4208	4236	4240	4271	4275	4304	4308	4337	4341	4371	4375
					4404	4408	4438	4442									
V20	U	00000014	1	4631													
V21	U	00000015	1	4632													
V22	U	00000016	1	4633													
V23	U	00000017	1	4634													
V24	U	00000018	1	4635													
V25	U	00000019	1	4636													
V26	U	0000001A	1	4637													
V27	U	0000001B	1	4638													
V28	U	0000001C	1	4639													
V29	U	0000001D	1	4640													
V2PACKED	X	00001157	16	426	580	581	612	613	644	645	676	677	708	709	740	741	773
					774	805	806	837	838	871	872	903	904	935	936	971	972
					1003	1004	1035	1036	1067	1068	1099	1100	1131	1132	1163	1164	1196

SYMBOL	TYPE	VALUE	LENGTH	DEFN	REFERENCES
					1197 1228 1229 1260 1261 1292 1293 1326 1327 1358 1359 1390 1391
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					1845 1846 1878 1879 1910 1911 1942 1943 1975 1976 2011 2012 2043
					2044 2075 2076 2107 2108 2139 2140 2171 2172 2203 2204 2236 2237
					2268 2269 2300 2301 2332 2333 2364 2365 2396 2397 2430 2431 2462
					2463 2494 2495 2527 2528 2559 2560 2592 2593 2628 2629 2660 2661
					2692 2693 2724 2725 2756 2757 2788 2789 2820 2821 2853 2854 2885
					2886 2917 2918 2949 2950 2981 2982 3013 3014 3047 3048 3079 3080
					3111 3112 3144 3145 3176 3177 3208 3209 3251 3252 3283 3284 3315
					3316 3347 3348 3379 3380 3411 3412 3443 3444 3476 3477 3509 3510
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					3978 3979 4010 4011 4042 4043 4075 4076 4107 4108 4139 4140 4171
					4172 4203 4204 4235 4236 4270 4271 4303 4304 4336 4337 4370 4371
					4403 4404 4437 4438
V2VALUE	F	00000010	8	443	
V2_1	F	00001198	8	572	579
V2_10	F	00001618	8	863	870
V2_100	F	00004318	8	3810	3817
V2_101	F	00004398	8	3842	3849
V2_102	F	00004418	8	3874	3881
V2_103	F	00004498	8	3906	3913
V2_104	F	00004518	8	3938	3945
V2_105	F	00004598	8	3970	3977
V2_106	F	00004618	8	4002	4009
V2_107	F	00004698	8	4034	4041
V2_108	F	00004718	8	4067	4074
V2_109	F	00004798	8	4099	4106
V2_11	F	00001698	8	895	902
V2_110	F	00004818	8	4131	4138
V2_111	F	00004898	8	4163	4170
V2_112	F	00004918	8	4195	4202
V2_113	F	00004998	8	4227	4234
V2_114	F	00004A18	8	4262	4269
V2_115	F	00004A98	8	4295	4302
V2_116	F	00004B18	8	4328	4335
V2_117	F	00004B98	8	4362	4369
V2_118	F	00004C18	8	4395	4402
V2_119	F	00004C98	8	4429	4436
V2_12	F	00001718	8	927	934
V2_13	F	00001798	8	963	970
V2_14	F	00001818	8	995	1002
V2_15	F	00001898	8	1027	1034
V2_16	F	00001918	8	1059	1066
V2_17	F	00001998	8	1091	1098
V2_18	F	00001A18	8	1123	1130
V2_19	F	00001A98	8	1155	1162
V2_2	F	00001218	8	604	611
V2_20	F	00001B18	8	1188	1195
V2_21	F	00001B98	8	1220	1227
V2_22	F	00001C18	8	1252	1259
V2_23	F	00001C98	8	1284	1291
V2_24	F	00001D18	8	1318	1325
V2_25	F	00001D98	8	1350	1357
V2_26	F	00001E18	8	1382	1389

SYMBOL	TYPE	VALUE	LENGTH	DEFN	REFERENCES
V2_27	F	00001E98	8	1414	1421
V2_28	F	00001F18	8	1450	1457
V2_29	F	00001F98	8	1482	1489
V2_3	F	00001298	8	636	643
V2_30	F	00002018	8	1514	1521
V2_31	F	00002098	8	1546	1553
V2_32	F	00002118	8	1578	1585
V2_33	F	00002198	8	1610	1617
V2_34	F	00002218	8	1642	1649
V2_35	F	00002298	8	1675	1682
V2_36	F	00002318	8	1707	1714
V2_37	F	00002398	8	1739	1746
V2_38	F	00002418	8	1771	1778
V2_39	F	00002498	8	1803	1810
V2_4	F	00001318	8	668	675
V2_40	F	00002518	8	1837	1844
V2_41	F	00002598	8	1870	1877
V2_42	F	00002618	8	1902	1909
V2_43	F	00002698	8	1934	1941
V2_44	F	00002718	8	1967	1974
V2_45	F	00002798	8	2003	2010
V2_46	F	00002818	8	2035	2042
V2_47	F	00002898	8	2067	2074
V2_48	F	00002918	8	2099	2106
V2_49	F	00002998	8	2131	2138
V2_5	F	00001398	8	700	707
V2_50	F	00002A18	8	2163	2170
V2_51	F	00002A98	8	2195	2202
V2_52	F	00002B18	8	2228	2235
V2_53	F	00002B98	8	2260	2267
V2_54	F	00002C18	8	2292	2299
V2_55	F	00002C98	8	2324	2331
V2_56	F	00002D18	8	2356	2363
V2_57	F	00002D98	8	2388	2395
V2_58	F	00002E18	8	2422	2429
V2_59	F	00002E98	8	2454	2461
V2_6	F	00001418	8	732	739
V2_60	F	00002F18	8	2486	2493
V2_61	F	00002F98	8	2519	2526
V2_62	F	00003018	8	2551	2558
V2_63	F	00003098	8	2584	2591
V2_64	F	00003118	8	2620	2627
V2_65	F	00003198	8	2652	2659
V2_66	F	00003218	8	2684	2691
V2_67	F	00003298	8	2716	2723
V2_68	F	00003318	8	2748	2755
V2_69	F	00003398	8	2780	2787
V2_7	F	00001498	8	765	772
V2_70	F	00003418	8	2812	2819
V2_71	F	00003498	8	2845	2852
V2_72	F	00003518	8	2877	2884
V2_73	F	00003598	8	2909	2916
V2_74	F	00003618	8	2941	2948
V2_75	F	00003698	8	2973	2980
V2_76	F	00003718	8	3005	3012
V2_77	F	00003798	8	3039	3046

SYMBOL	TYPE	VALUE	LENGTH	DEFN	REFERENCES												
V2_78	F	00003818	8	3071	3078												
V2_79	F	00003898	8	3103	3110												
V2_8	F	00001518	8	797	804												
V2_80	F	00003918	8	3136	3143												
V2_81	F	00003998	8	3168	3175												
V2_82	F	00003A18	8	3200	3207												
V2_83	F	00003A98	8	3243	3250												
V2_84	F	00003B18	8	3275	3282												
V2_85	F	00003B98	8	3307	3314												
V2_86	F	00003C18	8	3339	3346												
V2_87	F	00003C98	8	3371	3378												
V2_88	F	00003D18	8	3403	3410												
V2_89	F	00003D98	8	3435	3442												
V2_9	F	00001598	8	829	836												
V2_90	F	00003E18	8	3468	3475												
V2_91	F	00003E98	8	3501	3508												
V2_92	F	00003F18	8	3533	3540												
V2_93	F	00003F98	8	3565	3572												
V2_94	F	00004018	8	3597	3604												
V2_95	F	00004098	8	3632	3639												
V2_96	F	00004118	8	3666	3673												
V2_97	F	00004198	8	3699	3706												
V2_98	F	00004218	8	3733	3740												
V2_99	F	00004298	8	3767	3774												
V3	U	00000003	1	4614	584	585	616	617	648	649	680	681	712	713	744	745	777
					778	809	810	841	842	875	876	907	908	939	940	975	976
					1007	1008	1039	1040	1071	1072	1103	1104	1135	1136	1167	1168	1200
					1201	1232	1233	1264	1265	1296	1297	1330	1331	1362	1363	1394	1395
					1426	1427	1462	1463	1494	1495	1526	1527	1558	1559	1590	1591	1622
					1623	1654	1655	1687	1688	1719	1720	1751	1752	1783	1784	1815	1816
					1849	1850	1882	1883	1914	1915	1946	1947	1979	1980	2015	2016	2047
					2048	2079	2080	2111	2112	2143	2144	2175	2176	2207	2208	2240	2241
					2272	2273	2304	2305	2336	2337	2368	2369	2400	2401	2434	2435	2466
					2467	2498	2499	2531	2532	2563	2564	2596	2597	2632	2633	2664	2665
					2696	2697	2728	2729	2760	2761	2792	2793	2824	2825	2857	2858	2889
					2890	2921	2922	2953	2954	2985	2986	3017	3018	3051	3052	3083	3084
					3115	3116	3148	3149	3180	3181	3212	3213	3255	3256	3287	3288	3319
					3320	3351	3352	3383	3384	3415	3416	3447	3448	3480	3481	3513	3514
					3545	3546	3577	3578	3609	3610	3644	3645	3678	3679	3711	3712	3745
					3746	3779	3780	3822	3823	3854	3855	3886	3887	3918	3919	3950	3951
					3982	3983	4014	4015	4046	4047	4079	4080	4111	4112	4143	4144	4175
					4176	4207	4208	4239	4240	4274	4275	4307	4308	4340	4341	4374	4375
					4407	4408	4441	4442									
V30	U	0000001E	1	4641													
V31	U	0000001F	1	4642													
V3PACKED	X	00001167	16	427	583	584	615	616	647	648	679	680	711	712	743	744	776
					777	808	809	840	841	874	875	906	907	938	939	974	975
					1006	1007	1038	1039	1070	1071	1102	1103	1134	1135	1166	1167	1199
					1200	1231	1232	1263	1264	1295	1296	1329	1330	1361	1362	1393	1394
					1425	1426	1461	1462	1493	1494	1525	1526	1557	1558	1589	1590	1621
					1622	1653	1654	1686	1687	1718	1719	1750	1751	1782	1783	1814	1815
					1848	1849	1881	1882	1913	1914	1945	1946	1978	1979	2014	2015	2046
					2047	2078	2079	2110	2111	2142	2143	2174	2175	2206	2207	2239	2240
					2271	2272	2303	2304	2335	2336	2367	2368	2399	2400	2433	2434	2465
					2466	2497	2498	2530	2531	2562	2563	2595	2596	2631	2632	2663	2664
					2695	2696	2727	2728	2759	2760	2791	2792	2823	2824	2856	2857	2888

SYMBOL	TYPE	VALUE	LENGTH	DEFN	REFERENCES
					2889 2920 2921 2952 2953 2984 2985 3016 3017 3050 3051 3082 3083
					3114 3115 3147 3148 3179 3180 3211 3212 3254 3255 3286 3287 3318
					3319 3350 3351 3382 3383 3414 3415 3446 3447 3479 3480 3512 3513
					3544 3545 3576 3577 3608 3609 3643 3644 3677 3678 3710 3711 3744
					3745 3778 3779 3821 3822 3853 3854 3885 3886 3917 3918 3949 3950
					3981 3982 4013 4014 4045 4046 4078 4079 4110 4111 4142 4143 4174
					4175 4206 4207 4238 4239 4273 4274 4306 4307 4339 4340 4373 4374
					4406 4407 4440 4441
V3VALUE	F	00000018	8	444	
V3_1	F	000011A0	8	573	582
V3_10	F	00001620	8	864	873
V3_100	F	00004320	8	3811	3820
V3_101	F	000043A0	8	3843	3852
V3_102	F	00004420	8	3875	3884
V3_103	F	000044A0	8	3907	3916
V3_104	F	00004520	8	3939	3948
V3_105	F	000045A0	8	3971	3980
V3_106	F	00004620	8	4003	4012
V3_107	F	000046A0	8	4035	4044
V3_108	F	00004720	8	4068	4077
V3_109	F	000047A0	8	4100	4109
V3_11	F	000016A0	8	896	905
V3_110	F	00004820	8	4132	4141
V3_111	F	000048A0	8	4164	4173
V3_112	F	00004920	8	4196	4205
V3_113	F	000049A0	8	4228	4237
V3_114	F	00004A20	8	4263	4272
V3_115	F	00004AA0	8	4296	4305
V3_116	F	00004B20	8	4329	4338
V3_117	F	00004BA0	8	4363	4372
V3_118	F	00004C20	8	4396	4405
V3_119	F	00004CA0	8	4430	4439
V3_12	F	00001720	8	928	937
V3_13	F	000017A0	8	964	973
V3_14	F	00001820	8	996	1005
V3_15	F	000018A0	8	1028	1037
V3_16	F	00001920	8	1060	1069
V3_17	F	000019A0	8	1092	1101
V3_18	F	00001A20	8	1124	1133
V3_19	F	00001AA0	8	1156	1165
V3_2	F	00001220	8	605	614
V3_20	F	00001B20	8	1189	1198
V3_21	F	00001BA0	8	1221	1230
V3_22	F	00001C20	8	1253	1262
V3_23	F	00001CA0	8	1285	1294
V3_24	F	00001D20	8	1319	1328
V3_25	F	00001DA0	8	1351	1360
V3_26	F	00001E20	8	1383	1392
V3_27	F	00001EA0	8	1415	1424
V3_28	F	00001F20	8	1451	1460
V3_29	F	00001FA0	8	1483	1492
V3_3	F	000012A0	8	637	646
V3_30	F	00002020	8	1515	1524
V3_31	F	000020A0	8	1547	1556
V3_32	F	00002120	8	1579	1588
V3_33	F	000021A0	8	1611	1620

SYMBOL	TYPE	VALUE	LENGTH	DEFN	REFERENCES
V3_34	F	00002220	8	1643	1652
V3_35	F	000022A0	8	1676	1685
V3_36	F	00002320	8	1708	1717
V3_37	F	000023A0	8	1740	1749
V3_38	F	00002420	8	1772	1781
V3_39	F	000024A0	8	1804	1813
V3_4	F	00001320	8	669	678
V3_40	F	00002520	8	1838	1847
V3_41	F	000025A0	8	1871	1880
V3_42	F	00002620	8	1903	1912
V3_43	F	000026A0	8	1935	1944
V3_44	F	00002720	8	1968	1977
V3_45	F	000027A0	8	2004	2013
V3_46	F	00002820	8	2036	2045
V3_47	F	000028A0	8	2068	2077
V3_48	F	00002920	8	2100	2109
V3_49	F	000029A0	8	2132	2141
V3_5	F	000013A0	8	701	710
V3_50	F	00002A20	8	2164	2173
V3_51	F	00002AA0	8	2196	2205
V3_52	F	00002B20	8	2229	2238
V3_53	F	00002BA0	8	2261	2270
V3_54	F	00002C20	8	2293	2302
V3_55	F	00002CA0	8	2325	2334
V3_56	F	00002D20	8	2357	2366
V3_57	F	00002DA0	8	2389	2398
V3_58	F	00002E20	8	2423	2432
V3_59	F	00002EA0	8	2455	2464
V3_6	F	00001420	8	733	742
V3_60	F	00002F20	8	2487	2496
V3_61	F	00002FA0	8	2520	2529
V3_62	F	00003020	8	2552	2561
V3_63	F	000030A0	8	2585	2594
V3_64	F	00003120	8	2621	2630
V3_65	F	000031A0	8	2653	2662
V3_66	F	00003220	8	2685	2694
V3_67	F	000032A0	8	2717	2726
V3_68	F	00003320	8	2749	2758
V3_69	F	000033A0	8	2781	2790
V3_7	F	000014A0	8	766	775
V3_70	F	00003420	8	2813	2822
V3_71	F	000034A0	8	2846	2855
V3_72	F	00003520	8	2878	2887
V3_73	F	000035A0	8	2910	2919
V3_74	F	00003620	8	2942	2951
V3_75	F	000036A0	8	2974	2983
V3_76	F	00003720	8	3006	3015
V3_77	F	000037A0	8	3040	3049
V3_78	F	00003820	8	3072	3081
V3_79	F	000038A0	8	3104	3113
V3_8	F	00001520	8	798	807
V3_80	F	00003920	8	3137	3146
V3_81	F	000039A0	8	3169	3178
V3_82	F	00003A20	8	3201	3210
V3_83	F	00003AA0	8	3244	3253
V3_84	F	00003B20	8	3276	3285

SYMBOL	TYPE	VALUE	LENGTH	DEFN	REFERENCES
V3_85	F	00003BA0	8	3308	3317
V3_86	F	00003C20	8	3340	3349
V3_87	F	00003CA0	8	3372	3381
V3_88	F	00003D20	8	3404	3413
V3_89	F	00003DA0	8	3436	3445
V3_9	F	000015A0	8	830	839
V3_90	F	00003E20	8	3469	3478
V3_91	F	00003EA0	8	3502	3511
V3_92	F	00003F20	8	3534	3543
V3_93	F	00003FA0	8	3566	3575
V3_94	F	00004020	8	3598	3607
V3_95	F	000040A0	8	3633	3642
V3_96	F	00004120	8	3667	3676
V3_97	F	000041A0	8	3700	3709
V3_98	F	00004220	8	3734	3743
V3_99	F	000042A0	8	3768	3777
V4	U	00000004	1	4615	
V5	U	00000005	1	4616	
V6	U	00000006	1	4617	
V7	U	00000007	1	4618	
V8	U	00000008	1	4619	
V9	U	00000009	1	4620	
X1	F	000011B8	4	578	565
X10	F	00001638	4	869	856
X100	F	00004338	4	3816	3803
X101	F	000043B8	4	3848	3835
X102	F	00004438	4	3880	3867
X103	F	000044B8	4	3912	3899
X104	F	00004538	4	3944	3931
X105	F	000045B8	4	3976	3963
X106	F	00004638	4	4008	3995
X107	F	000046B8	4	4040	4027
X108	F	00004738	4	4073	4060
X109	F	000047B8	4	4105	4092
X11	F	000016B8	4	901	888
X110	F	00004838	4	4137	4124
X111	F	000048B8	4	4169	4156
X112	F	00004938	4	4201	4188
X113	F	000049B8	4	4233	4220
X114	F	00004A38	4	4268	4255
X115	F	00004AB8	4	4301	4288
X116	F	00004B38	4	4334	4321
X117	F	00004BB8	4	4368	4355
X118	F	00004C38	4	4401	4388
X119	F	00004CB8	4	4435	4422
X12	F	00001738	4	933	920
X13	F	000017B8	4	969	956
X14	F	00001838	4	1001	988
X15	F	000018B8	4	1033	1020
X16	F	00001938	4	1065	1052
X17	F	000019B8	4	1097	1084
X18	F	00001A38	4	1129	1116
X19	F	00001AB8	4	1161	1148
X2	F	00001238	4	610	597
X20	F	00001B38	4	1194	1181
X21	F	00001BB8	4	1226	1213

SYMBOL	TYPE	VALUE	LENGTH	DEFN	REFERENCES
X22	F	00001C38	4	1258	1245
X23	F	00001CB8	4	1290	1277
X24	F	00001D38	4	1324	1311
X25	F	00001DB8	4	1356	1343
X26	F	00001E38	4	1388	1375
X27	F	00001EB8	4	1420	1407
X28	F	00001F38	4	1456	1443
X29	F	00001FB8	4	1488	1475
X3	F	000012B8	4	642	629
X30	F	00002038	4	1520	1507
X31	F	000020B8	4	1552	1539
X32	F	00002138	4	1584	1571
X33	F	000021B8	4	1616	1603
X34	F	00002238	4	1648	1635
X35	F	000022B8	4	1681	1668
X36	F	00002338	4	1713	1700
X37	F	000023B8	4	1745	1732
X38	F	00002438	4	1777	1764
X39	F	000024B8	4	1809	1796
X4	F	00001338	4	674	661
X40	F	00002538	4	1843	1830
X41	F	000025B8	4	1876	1863
X42	F	00002638	4	1908	1895
X43	F	000026B8	4	1940	1927
X44	F	00002738	4	1973	1960
X45	F	000027B8	4	2009	1996
X46	F	00002838	4	2041	2028
X47	F	000028B8	4	2073	2060
X48	F	00002938	4	2105	2092
X49	F	000029B8	4	2137	2124
X5	F	000013B8	4	706	693
X50	F	00002A38	4	2169	2156
X51	F	00002AB8	4	2201	2188
X52	F	00002B38	4	2234	2221
X53	F	00002BB8	4	2266	2253
X54	F	00002C38	4	2298	2285
X55	F	00002CB8	4	2330	2317
X56	F	00002D38	4	2362	2349
X57	F	00002DB8	4	2394	2381
X58	F	00002E38	4	2428	2415
X59	F	00002EB8	4	2460	2447
X6	F	00001438	4	738	725
X60	F	00002F38	4	2492	2479
X61	F	00002FB8	4	2525	2512
X62	F	00003038	4	2557	2544
X63	F	000030B8	4	2590	2577
X64	F	00003138	4	2626	2613
X65	F	000031B8	4	2658	2645
X66	F	00003238	4	2690	2677
X67	F	000032B8	4	2722	2709
X68	F	00003338	4	2754	2741
X69	F	000033B8	4	2786	2773
X7	F	000014B8	4	771	758
X70	F	00003438	4	2818	2805
X71	F	000034B8	4	2851	2838
X72	F	00003538	4	2883	2870

SYMBOL	TYPE	VALUE	LENGTH	DEFN	REFERENCES						
X73	F	000035B8	4	2915	2902						
X74	F	00003638	4	2947	2934						
X75	F	000036B8	4	2979	2966						
X76	F	00003738	4	3011	2998						
X77	F	000037B8	4	3045	3032						
X78	F	00003838	4	3077	3064						
X79	F	000038B8	4	3109	3096						
X8	F	00001538	4	803	790						
X80	F	00003938	4	3142	3129						
X81	F	000039B8	4	3174	3161						
X82	F	00003A38	4	3206	3193						
X83	F	00003AB8	4	3249	3236						
X84	F	00003B38	4	3281	3268						
X85	F	00003BB8	4	3313	3300						
X86	F	00003C38	4	3345	3332						
X87	F	00003CB8	4	3377	3364						
X88	F	00003D38	4	3409	3396						
X89	F	00003DB8	4	3441	3428						
X9	F	000015B8	4	835	822						
X90	F	00003E38	4	3474	3461						
X91	F	00003EB8	4	3507	3494						
X92	F	00003F38	4	3539	3526						
X93	F	00003FB8	4	3571	3558						
X94	F	00004038	4	3603	3590						
X95	F	000040B8	4	3638	3625						
X96	F	00004138	4	3672	3659						
X97	F	000041B8	4	3705	3692						
X98	F	00004238	4	3739	3726						
X99	F	000042B8	4	3773	3760						
ZVE6TST	J	00000000	20216	63	66	68	72	76	360	64	
=AL2 (L' MSGMSG)	R	000004C2	2	341	287						
=F' 1'	F	000004B8	4	338	161	237					
=H' 0'	H	000004C0	2	340	282						
=XL4' 3'	X	000004BC	4	339	168						

DESC	SYMBOL	SIZE	POS	ADDR
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Entry: 0

Image	IMAGE	20216	0000-4EF7	0000-4EF7
Regi on		20216	0000-4EF7	0000-4EF7
CSECT	ZVE6TST	20216	0000-4EF7	0000-4EF7

STMT	FILE NAME
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99	99
100	100

```
1 /home/tn529/sharedvfp/tests/zvector-e6-05-packarith.asm
```

**** NO ERRORS FOUND ****